R&S®ZNA
VECTOR NETWORK ANALYZER

Master the most challenging measurement tasks

Product Brochure
Version 06.00

ROHDE&SCHWARZ
Make ideas real

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AT A GLANCE

Offeringoutstandingrfcharacteristics,auniqueandcomprehensive hardware architecture and a DUToriented operationconcept,theR&S®ZNAhigh-endvector network analyzer makes demanding measurements easier than ever before.

The R&S®ZNA features exceptional stability, low trace noise and excellent raw data, making it a perfect choice for development and production applications that require high accuracy, e.g. for developing and producing components and modules for A&D and satellite applications.

The R&S®ZNA offers four internal, phase coherent sources, allowing independent control of the signal's frequency at each port as well as phase measurements on mixers. It provides two internal local oscillator (LO) sources, a true multichannel receiver architecture, pulse generators and modulators, an internal combiner, selectable reference signal access points, preamplifiers and comprehensive trigger and synchronization capabilities. These hardware features make the R&S®ZNA a universal, compact test system for active and passive device characterization. Even intermodulation measurements on mixers and receivers can be performed without external signal sources, minimizing test time and simplifying test configuration. Thanks to the phase coherent digital sources and receivers, no reference mixers are needed for mixer phase measurements, and test setups are configured just as easily as for non-frequency-converting S-parameter measurements.

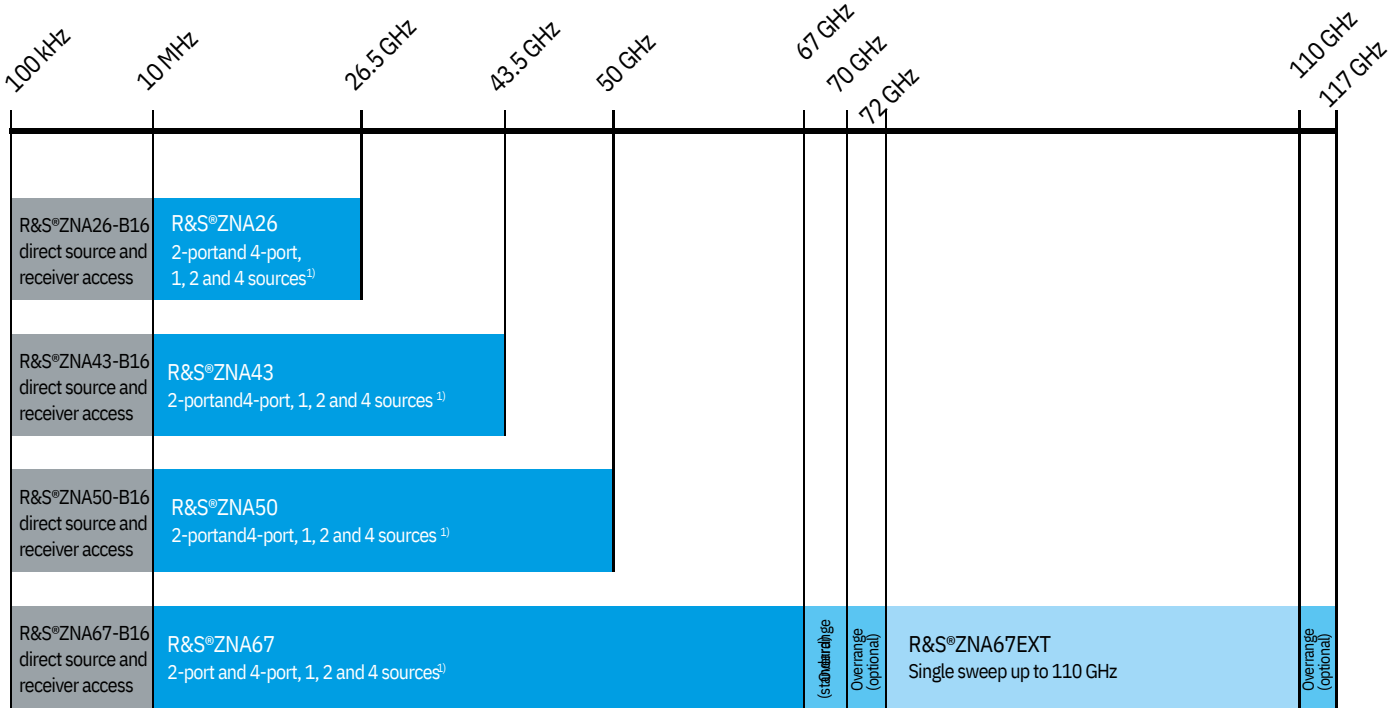
Users can operate the R&S®ZNA via two independent touchscreens

The analyzer's DUT-centric operating concept makes it possible to achieve the desired setup at an unrivaled speed. Users can control sophisticated measurements at a glance with dedicated dialogs that show the setup schematics and all of the essential test parameters.

The R&S®ZNA characterizes low-noise amplifiers (LNA), receivers, frequency-converting DUTs and transmit/receive (T/R) modules precisely and efficiently; the DUT needs to be connected only once. The instrument provides numer- ous software applications, e.g. for intuitive configuration of group delay and spectrum measurements.

Various menu-based calibration procedures are available to help users calibrate even complicated setups efficiently and reliably. All the calibration methods supported by the R&S®ZNA can be expanded using a special calibration technique referred to as R&S®SMARTerCal. This technique combines system error correction with absolute power level correction, minimizing the number of calibration steps even with active DUTs, which involve considerable measurement effort.

R&S®ZNA models



1) With all models, the internal (second) LO generator is optionally available at the rear panel as third or fifth source respectively (up to 26.5 GHz).

KEY FACTS AND BENEFITS

Fourinternalphasecoherentsources
- Compact multiple source setups
- Convenient phase measurements on mixers
- Phase coherent DUT stimulation and true differential measurements

Two internal LOs
- Excellent trace noise as low as 0.005 dB (spec.) and 0.002 dB (typ.) at 100 kHz IF bandwidth (IFBW)
- Fast mixer measurements
- More accurate phase results due to parallel signal sampling
- Rear panel LO output for mmWave systems and general purpose applications

Eight truly parallel measurement receivers
- Measurements onmultipath DUTsand antenna arrays, use of analyzer as a powerful core in antenna test systems

Flexiblesignalroutingandpathaccess
- Internalcombiner for intermodulation and embedded LO converter group delay measurements
- Reference signal access before or after source step attenuator for low trace noise even with very low stimulus signals (e.g. for high gain DUTs)
- Direct IF access for antenna test systems with external up/down conversion
- Rear panel LO output and direct IF input for compact mmWave test setups: 2/4-port mmWave converter setups with 2/4-port R&S®ZNA, without additional external source

Four internal pulse modulators
- Two-toneandbidirectionalpulsed signal measurements

Phasemeasurementsonmixerswithoutreference mixers
- Simple mixer tests in a compact setup

Noisefiguremeasurementsonamplifiersandmixers
- Internal preamplifier (R&S®ZNAxx-B302/-B312) for low-noise DUTs
- Quickset configuration dialog for fast and optimized amplifier noise figure measurements

Spectrum analysis option
- DUT characterization and spurious search without reconnecting the DUT to a spectrum analyzer

Group delay measurements on frequency converters with embeddedLOs
- Reliable, straightforward satellite receiver measurements

High dynamic range
- Dynamic range of 147 dB (typ.) and up to 170 dB (typ., with options)
- Characterization of high-rejection filters
- Short test times and low trace noise

Outstanding receiver sensitivity
- Noise floor < –120 dBm (spec.) [1)]
- Noise level down to –157 dBm (typ., with options) [2)]

Exceptionalsourceandreceiverlinearity
- 0.03 dB receiver linearity in the range from –50 dBm to 0 dBm
- Accurate amplifier testing even at very high and low power levels

Wide power sweep range
- Power sweep range of 100 dB (typ.)
- Versatile compression measurements

Low trace noise
- Trace noise of < 0.001 dB (at 1 kHz IF bandwidth)
- Accurate, highly reproducible measurements

DUT-centric operating concept
- Easy startup, short configuration times

Compact instrument, quiet operation
- Acoustic noise as low as 42 dB(A)
- Small footprint, low noise pollution

SCPI recorder
- Simpifies automated complex measurement setups
- Standard feature

[1)] Specification, without options, at 1 Hz IF bandwidth.
[2)] Applies for port 2, at 1 Hz IF bandwidth, with R&S®ZNAxx-B16 reversed coupler operation and R&S®ZNAxx-B302 preamplifier options. (xx designates the R&S®ZNA model: R&S®ZNA26, R&S®ZNA43, R&S®ZNA50 and R&S®ZNA67.)


ROHDE&SCHWARZ
Port 3

STATE-OF-THE-ART USER INTERFACE

Context-sensitivehelp

Menu bar
Foroperation with a mouse or finger

Undo/Redo
Cancelsorrestores the last operations

Toolbar
Frequently used functions such as zoom, new trace, new marker, print

More than 100 channels and traces
- ▶ Straightforward displayof complex measurements
- ▶Simultaneous, independent display of multiple test setups; display of large number of traces; arrangement of traces, channels and diagrams in any desired combination

Three front panel USB ports for connecting
- ▶Storage media
- ▶Keyboard and mouse
- ▶Calibration units
- ▶Power sensors

Direct source monitor access (option)
- ▶ Directreference signal access before or after internal mechanical source step attenuator
- ▶Low trace noise even with very small output power levels

12.1" touchscreen with state-of-the-art graphical user interface (GUI)

Softkeys and soft panel

- Logicallystructured menus: everything in view without scroll bar
- All parameters for a test setup presented in straightforward GUI dialogs
- Measured traces can be dragged and dropped

Touch panel

Instrumentcontrol and display of macros

Soft roll key with locking function

Status LEDs

Calibrationstatus, remote operation, etc.

Direct source and receiver access (option)

Status LEDs for each port indicating

- TX/RX operation
- Input active

REAR PANEL CONNECTIONS

LAN port

SSD (removable)

Display ports
- DisplayPort
- DVI-D

Internal LO signal output (option)
- LOsource for mmWave converter setups (standard internal LO or optional 2nd internal LO)
- General-purpose, configurable RF source up to 26.5 GHz (optional 2nd internal LO)
- Up to +25 dBm output power

Trigger board (option)
- Three additional trigger inputs
- Four trigger outputs
- Four connectors for pulse modulator control
- Ready for trigger (output)
- Busy (output)
- RF interlock control (input)

GPIB port

Standard control and sync connectors
- Reference frequency output: 10 MHz,100 MHz
- Reference frequency input: 1 MHz to 50 MHz, 100 MHz, 1 GHz
- Trigger input

Four USB ports

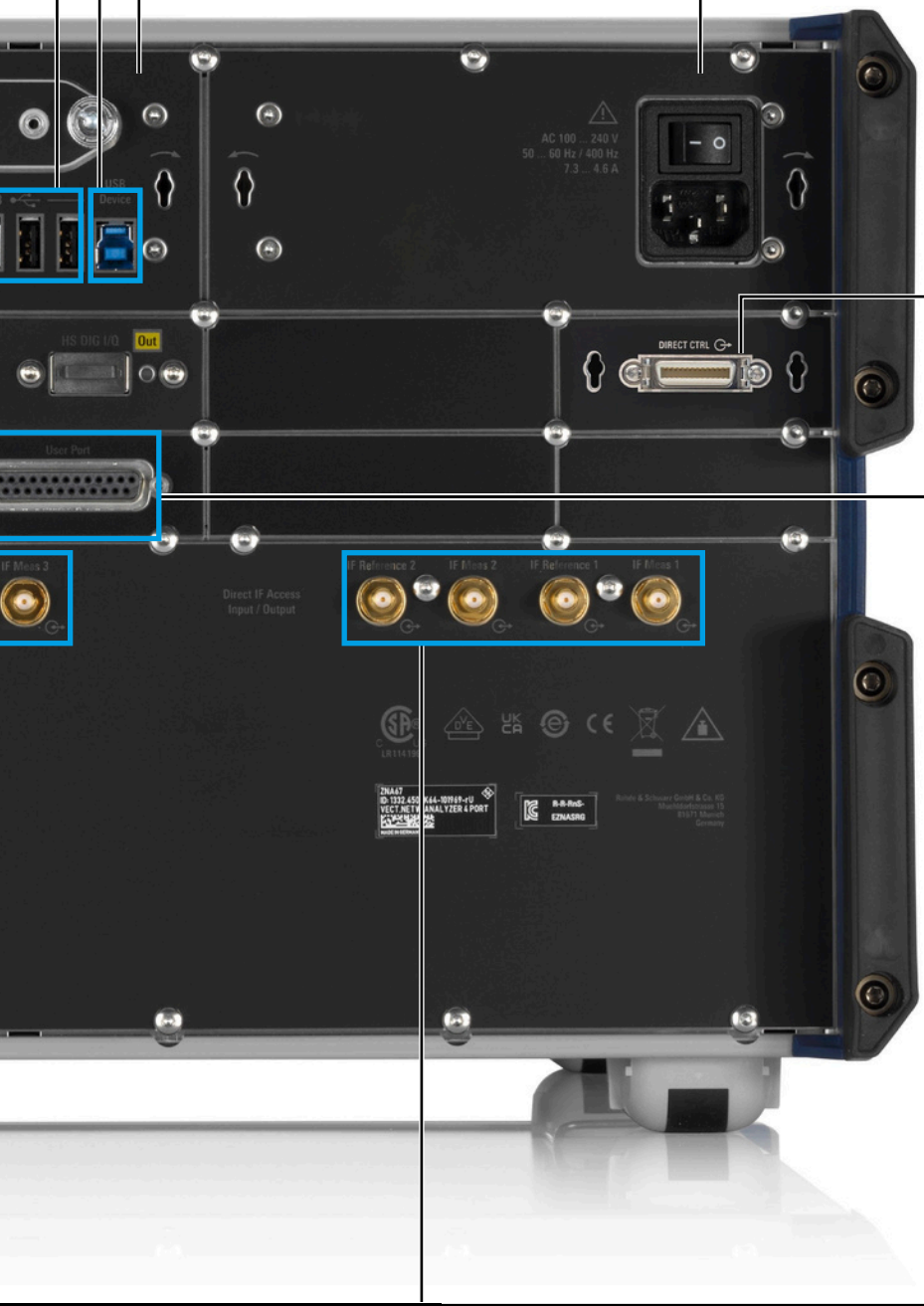
- Storage media
- Keyboard and mouse
- Calibration units
- Power sensors

USB control

Forremotedevice control via USB

Modular design for easy maintenance

ControlPCandpowersupply



Direct control interface (option)

Quickcommunicationwithexternal devices, e.g. control of R&S®ZN-ZCG

User port

- Digital I/Os
- Power supply

Direct IF access (option)

- I/Os(input/outputswitchable; IF bandwidth, output: 2 GHz IF bandwidth, input: 1 GHz)
- Access to measurement and reference receiver IF of each port

UNIQUE OPERATING CONCEPT WITH TWO TOUCHSCREENS

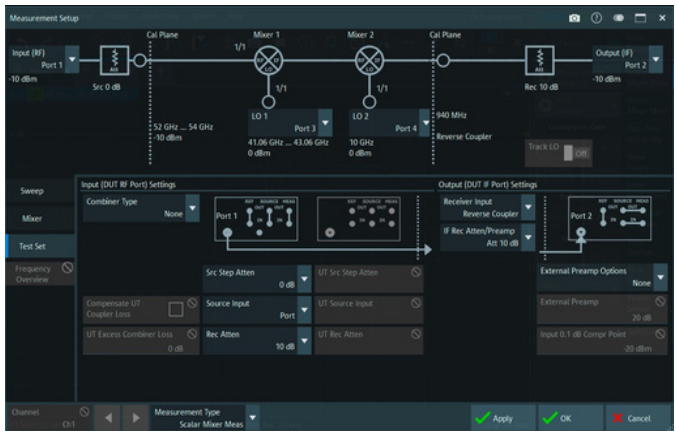
Keepthingsinperspectivewithall-in-oneGUIsandoptimizeyoursetupswithsingleparameter adjustment.

Operation using touch gestures

Users can operate the R&S®ZNA via two independent touchscreens:

- ▶ Innovative control panel on the right instead of mechanical keys which can wear out over time
- ▶ 12.1" touch display on the left for configuring and displaying measurements

The dual-screen operating concept offers utmost flexibility in configuring measurements. Touch gestures are used to zoom, move traces and add markers. Traces, channels and diagrams can be dragged and dropped to arrange them in any desired combination. The control panel on the right can, among other things, be used to display macros, remote control commands and auxiliary tools.



All-in-one dialog for intermodulation measurement on a double converting receiver

Threealternativestoarrive at the desired setup

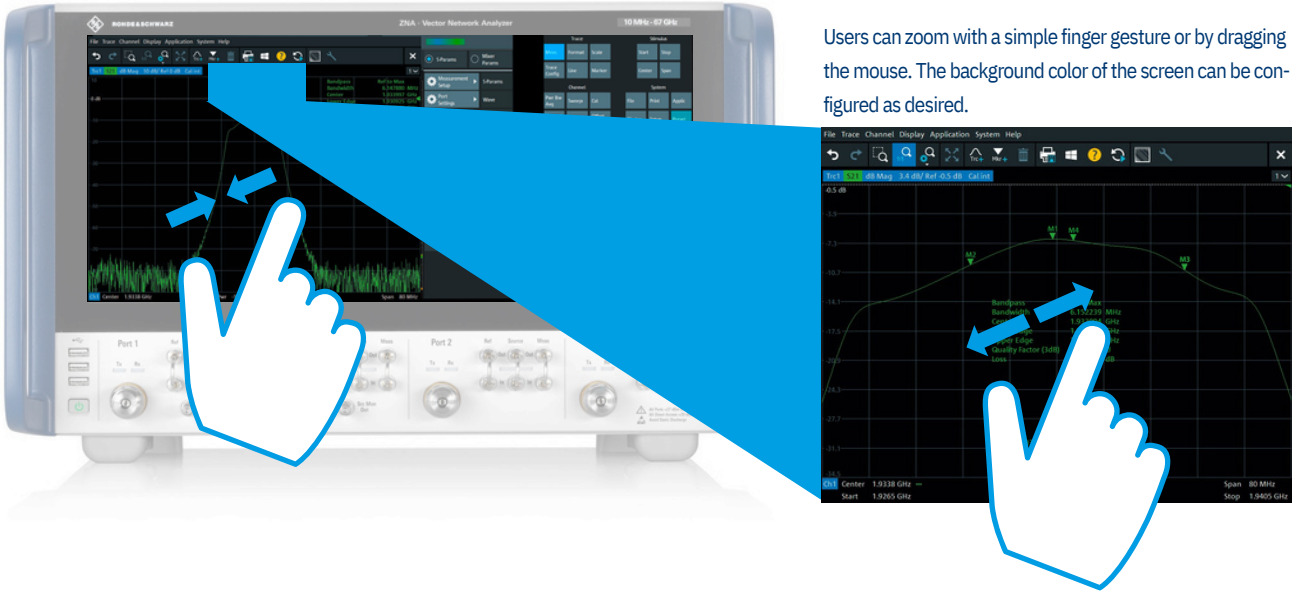
1. Conventional approach

For general configuration and for basic measurement quantities, such as S-parameters, power and ratios, users can take the conventional approach to configure measurements on the R&S®ZNA. They can select the parameters for a desired setup, e.g. power parameters, the number of points, and the measurement type and measurement quantity.

2. All-in-onedialogs–keepingtrackevenofsophisticatedsetups

For complex setups, such as intermodulation on mixers and noise figure tests, all-in-one dialogs show all of the key parameters otherwise distributed among several menus on a single display. The hardware is configured interactively using graphic elements. Test parameters such as frequencies, power levels and bandwidths are set via pull-down menus and input fields. Users see all relevant information at a glance, not missing a single parameter. Measurement traces for any desired measurement quantities can then be dragged and dropped to any desired position.

Zoom function



Users can zoom with a simple finger gesture or by dragging the mouse. The background color of the screen can be configured as desired.

Control of the R&S®ZNA via touch panel. Users benefit from all-in-one dialogs, which provide a clear overview of all key parameters and help to keep track of the overall measurement configuration.

Trace analysis functions

A wide variety of trace analysis functions provide a clear o verview of key parameters:

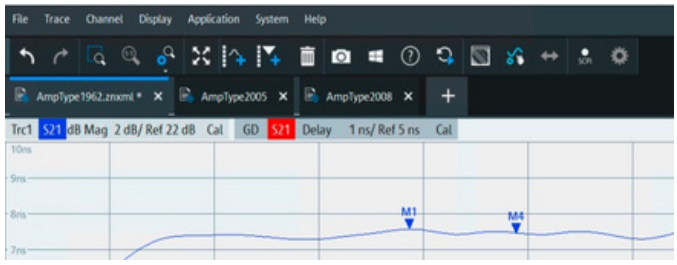
- ▶ Ten markers per trace, including analysis functions and conversion to desired unit
- ▶ Automatic bandwidth measurement on filters
- ▶ Limit and ripple check with configurable pass/fail indication
- ▶ Statistical trace analysis including maximum, minimum, RMS, peak-to-peak and compression point
- ▶ Equation editor for complex trace mathematics

Fast switching between instrument setups

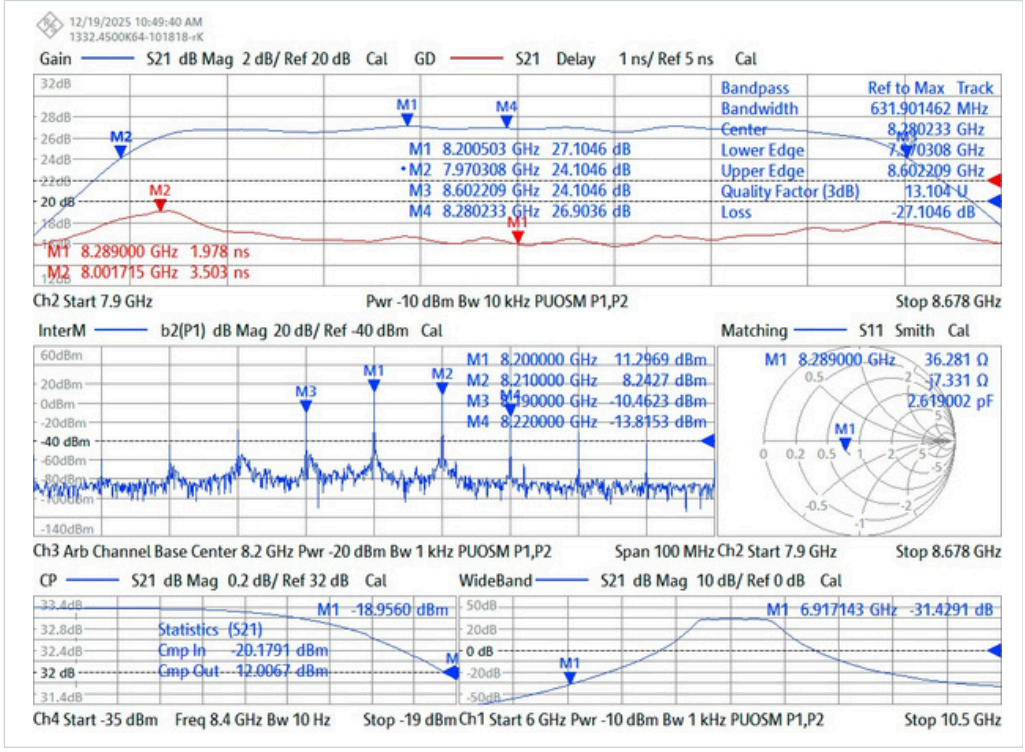
With the R&S®ZNA, multiple setups can be kept in memory simultaneously, allowing users to switch quickly between measurement tasks. This feature is especially advantageous with DUTs that deliver a variety of com- plex results, as it provides a quick overview and simplifies operation.

3. Step by step to the desired setup: the DUT-centric wizard

Another alternative is a step-by-step, DUT-centric approach. In a first step, the user defines the type of DUT (e.g. mixer) and its key data (e.g. maximum/mini- mum input power level and frequency ranges). The wiz- ard then prompts the user, in easy-to-follow steps, to define the required settings and measurement parameters, using DUT-specific terms (“Conversion Gain RF to IF” or “Feedthrough LO to IF”). Properly sizing and positioning the display ensures a clear overview, even when there are many result traces. The analyzer automatically creates and displays the associated channels and traces.



Setups in the tabs can be switched on with a mouse click.



Properly sizing and positioning the dis- play areas ensures a clear overview even when there are many result traces.

The R&S®ZNA comes with an extensive range of hardware options

TOP-CLASS HARDWARE COMPONENTS

The R&S®ZNA comes with an extensive range of hardware options, allowing customized configuration for the intended use.

4-port model with four internal sources

The R&S®ZNA is available with up to four internal sources (R&S®ZNAxx-B3 [1]) option, 3rd and 4th internal source for 4-port models). The user b enefits from a powerful, compact system that can even perform intermodulation measurements on mixers and receivers with two converter stages. The digitally controlled, phase coherent and phase repeatable sources allow phase measurements on mixers and converters without external reference mixers.

2-port models with two internal sources

Options for second internal RF/LO sources (R&S®ZNAxx-B52), an integrated combiner (R&S®ZNAxx-B212), the rear panel LO output connector (26.5 GHz) and preamplifiers (R&S®ZNAxx-B302/-B312/-B501/-B511) make the R&S®ZNA an extremely compact and effective tool for comprehensive characterization of DUTs with two test ports. Especially the following measurements are supported:

- Intermodulation on amplifiers
- Noise figure test
- Group delay test on (high-gain) embedded LO converters for satellite applications or T/R modules (using R&S®ZNA-K9 two-tone technique)
- Mixer test (with LO up to 26.5 GHz, rear panel LO out connector)

[1] xx designates the R&S®ZNA model (R&S®ZNA26, R&S®ZNA43, R&S®ZNA50 and R&S®ZNA67).

Direct IF access

When used as inputs, the R&S®ZNA-B26 direct IF access ports provide direct access to the internal IF signal paths. The IF frequency is selectable with 1 GHz bandwidth, which provides a high degree of freedom for system integration, especially when integrating the analyzer into antenna test systems with external mixers. When used as outputs, the R&S®ZNA-B26 ports make it possible to record and analyze data using external equipment.

Synchronization and trigger capabilities

The R&S®ZNA offers a comprehensiverange of synchronization and trigger features such as diverse trigger inputs and outputs, e.g. for test status indication, definition of criteria for logical decision-making, RF power shutdown, flexible test sequence control in pulsed measurements, synchronization of external devices, and for timing control during test sequences in production. The R&S®ZNA-B91 option (trigger and control I/O board) acts as an interface for the input and output of signals.

SecondinternalLOsourceand mmWaveconverterLOoutput

The second i nternal LO source (R&S®ZNA-B5 option for 4-port models, R&S®ZNAxx-B52 second source and second LO option for 2-port models) allows two ports to receive signals at different frequencies. This means that two frequencies can be measured simultaneously, e.g. the RF and the IF signal of a mixer, making the measurement twice as fast and reducing trace noise.

The optional R&S®ZNA-B8 mmWave converter LO output makes the analyzer's internal LO available on the rear panel, e.g. for feeding mmWave converters connected to the R&S®ZNA [2)]. Alternatively, the second LO can be used as a general- purpose RF source, e.g. for external mixers.

(The R&S®ZNA-B8 rear panel LO output is limited to the frequency range from 10 MHz to 26.5 GHz independent from using the standard or optional second internal LO.)

Eight internal pulse generators and four internal pulse modulators

Eight pulse generators and fourmodulators make it possible to generate pulsed two-tone signals and bidirectional pulsed signals, e.g. for intermodulation measurements on T/R modules. The pulse generators are enabled with any of the following options: R&S®ZNAxx-B4n (internal pulse modulator for port n) and R&S®ZNA-B91 (trigger and control I/O board). The trigger and control I/O board alone enables use of the internal pulse generators to control internal or external pulse modulators (e.g. to generate pulses with a duration of < 40 ns). Point-in- pulse measurements are delivered by the base unit; pulse profile measurements are added with the R&S®ZNA-K7 option.

[2)] Configuration of the R&S®ZNA-B8 output for use with mmWave converters r equires the R&S®ZNA-K8 option (mmWave converter support).

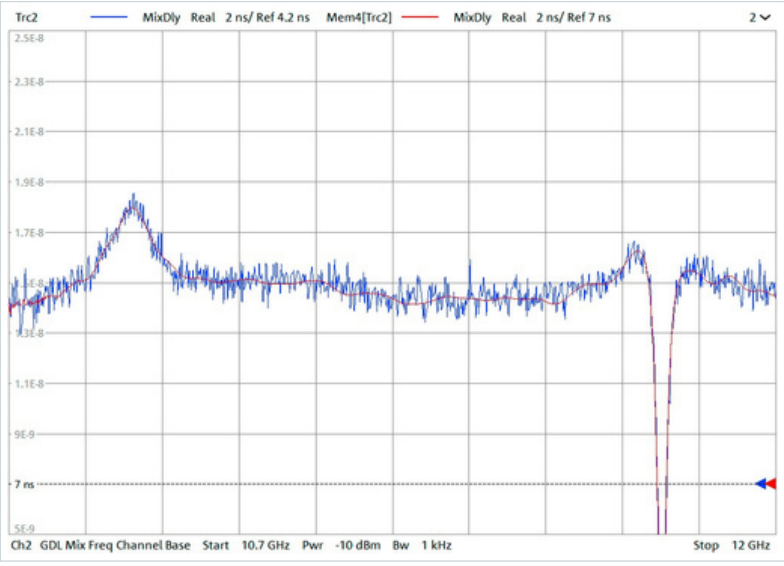
Internal combiner

A switchable internal combiner (R&S®ZNAxx-B213 for 4-port models, R&S®ZNAxx-B212 for 2-port models) c ombines the signals from source 1 and 3 (or a second internal source for 2-port models) to provide a two-tone signal at port 1. This enables intermodulation measurements and embedded LO group delay measurements (with R&S®ZNA-K9 option) to be carried out without additional e xternal equipment.

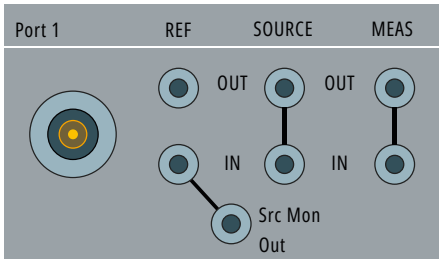
Direct source and receiver access, source monitor (reference signal) access before or after source step attenuator

The R&S®ZNAxx-B16 direct source and receiver access option provides direct access to the source and receiver paths. On the one hand, this yields highest sensitivity as the internal coupler can be bypassed, thus avoiding the coupler attenuation, on the other hand, it supports e.g. external high-power test setups. Testing at low stimulus levels is further improved with the R&S®ZNAxx-B501/-B511 low-power spurious reduction option. An isolation amplifier provides optimized spurious reduction, delivering excellent signal purity for power levels down to –110 dBm and below.

The R&S®ZNAxx-B161 and R&S®ZNAxx-B163 direct source monitor access options make the R&S®ZNA even more versatile. They provide direct access to the reference signal, i.e. they allow the reference signal to be picked up before the internal source step attenuator. With the step attenuator set to high attenuation for very small output power levels, picking up the reference signal before the source step attenuator will provide a reference signal strong enough to deliver low-noise traces, thus providing high accuracy even with high gain DUTs such as satellite and radar modules.



Group delay measurement on a 60 dB gain embedded LO converter (IFBW = 10 kHz for both measurements, shown as blue and red traces). Blue trace: poor trace noise with the low-level reference signal picked up after the source step attenuator. Red trace: minimized trace noise with the reference signal picked up before the source step attenuator, yielding a high signal-to-noise ratio (SNR) at the reference receiver.



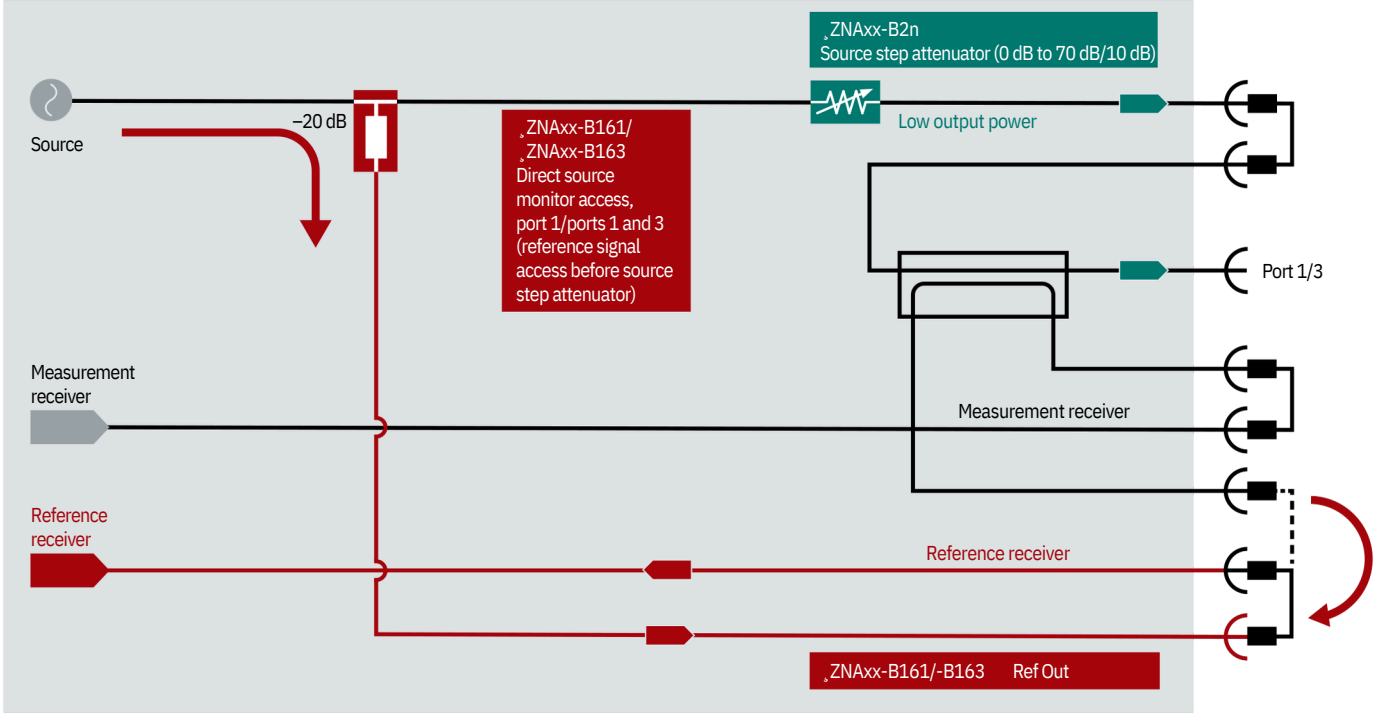
R&S®ZNAxx-B16 front panel jumper position required for direct source monitor access (R&S®ZNAxx-B161/-B163)

Internal preamplifier supports noise figure measurements

The R&S®ZNAxx-B302/-B312 option is a switchable low-noise amplifier (LNA) with filtering inserted upstream of the port 2 measurement receiver. With selectable gain up to 30 dB, even low gain/low noise figure DUTs can be accurately characterized.

R&S®ZNAxx-B161andR&S®ZNAxx-B163options

When theR&S®ZNAxx-B16 referencesignalfrontpaneljumper(ports 1 and 3) is reconnected from the standard position (Ref Out) to the direct source monitor output (R&S®ZNAxx-B161/R&S®ZNAxx-B163), the reference signal will be picked up before the source step attenuator.



UNPRECEDENTEDRF QUALITY

Wide signal-to noise ratio and exceptional stability for accurate results

Wide dynamic and power sweep range

Thevery high dynamicrangeof theR&S®ZNA allows the characterization of high-rejection filters. With high output powers and a wide power sweep range, the instrument can analyze the large- and small-signal behavior of amplifiers in a single sweep:

- ▶ Dynamic range: 147 dB (typ.) [1], > 129 dB (specified, without options)
- ▶ Maximum attainable dynamic range: 170 dB (typ.) [2]
- ▶ Electronically controlled power sweep range up to 100 dB (typ.), interruption-free up to 40 dB (typ.)

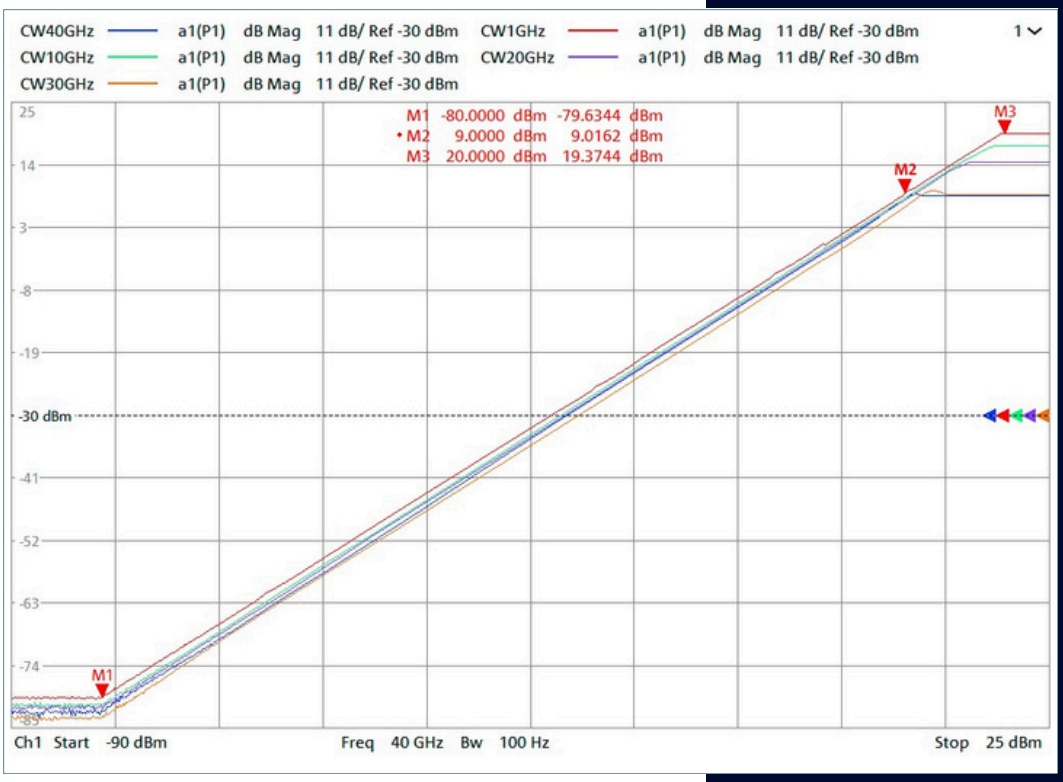
[1] With R&S®ZNAxx-B3n option.

[2] Requires: maximum output power, R&S®ZNAxx-B16 option, R&S®ZNAxx-B3n option, reversed coupler configuration at receive port, and 1 Hz IF bandwidth.

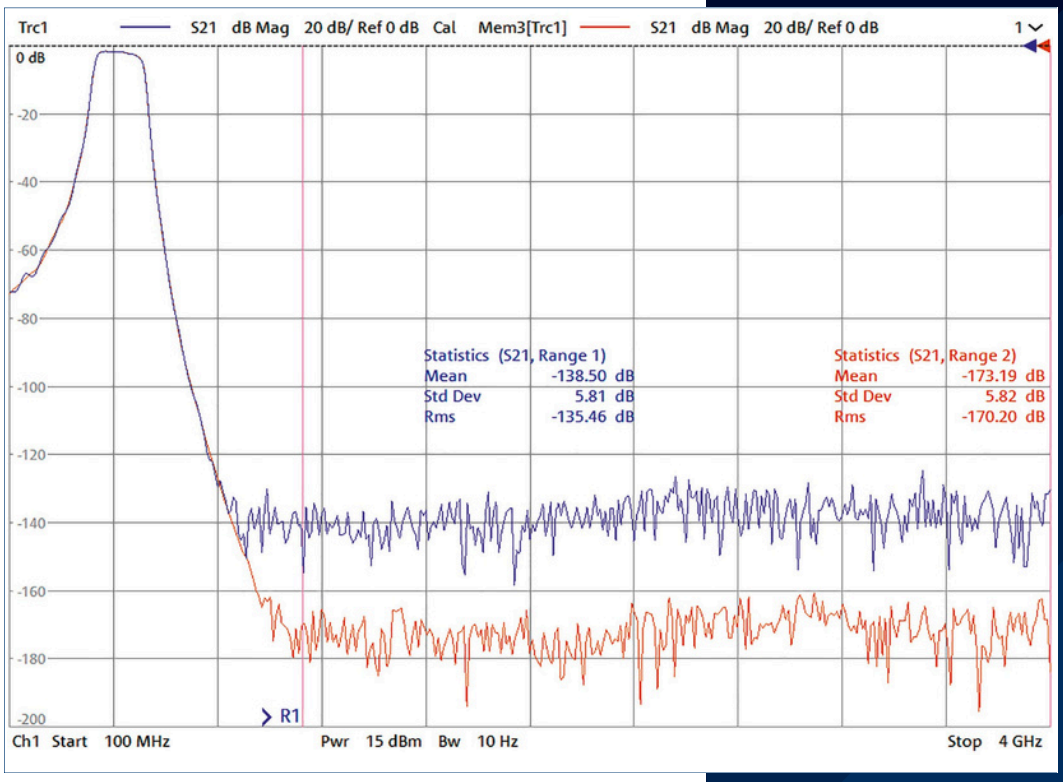
High stability for reliable results

TheR&S®ZNA testset andreceivers feature excellent temperature and long-term performance stability. Combined with other decisive RF features, this offers outstanding reliability and accuracy.

- ▶ Trace noise of 0.001 dB (RMS, at 1 kHz IF bandwidth)
- ▶ Temperature stability of 0.01 dB/K and 0.1°/K
- ▶ Reliable measurement of high power levels thanks to 0.1 dB (typ.) receiver compression for 10 dBm power level at test port
- ▶ High dynamic range of sources due to source step attenuators up to 70 dB and electronic power sweep range up to 100 dB
- ▶ Excellent receiver linearity of < 0.03 dB (typ.) across an extremely wide range of –50 dBm to 0 dBm



Maximum power sweep range of up to 100 dB



Dynamic range: at maximum specified output power,
without options (blue trace: at 10 Hz IF bandwidth);
at maximum specified output power, in reversed coupler mode,
with receiver step attenuator set to 0 dB (red trace: at 1 Hz IF bandwidth)

HARDWARE OPTIONS

Description	Applications and benefits	Hardware option [1]
Direct source and receiver access ▶ With start frequency down to 100 kHz [2] ▶ Supports reversed coupler configuration	▶ Facilitates external test setups for high-power measurements across a wide frequency range ▶ Reversed coupler configuration increases dynamic range and reduces system noise figure	R&S®ZNAxx-B16
R&S®ZNA 4-port model with up to four internal sources	▶ No external sources means flexible configuration and short measurement times ▶ Flexible-to-configure, compact test setups, e.g. for DUTs with two converter stages	R&S®ZNAxx-B3 [3]
2nd internal LO source for 4-port R&S®ZNA model ▶ For simultaneous measurement of two different f requencies (e.g. RF and IF signal of mixers) ▶ Additional RF source (in combination with R&S®ZNA-B8 mmWave converter LO output)	▶Fast mixer and converter measurements ▶Very low trace noise with frequency-converting measurements ▶ General-purpose RF source up to 26.5 GHz (e.g. to provide LO signal for external mixers)	R&S®ZNA-B5
2nd internal RF source and 2nd internal LO source for 2-port R&S®ZNA model	R&S®ZNA with 2 test ports supports: ▶ Intermodulation measurements ▶ Group delay on embedded LO (satellite) conver ters (LNB), T/R modules ▶ Mixer tests (with R&S®ZNA-B8 for LO)	R&S®ZNA-B52 [3]
Four/eight true receivers (no multiplexing)	▶ Reliable multichannel phase and antenna measurements	Provided as standard in base unit (direct receiver access requires R&S®ZNAxx-B16)
Direct IF access, I/O ports switchable as inputs or o utputs, with 2 GHz analog IF bandwidth (output) and 1 GHz analog IF bandwidth (input)	Enhanced flexibility and sensitivity, e.g. when used in antenna test systems ▶ Provides direct access to up to eight phase coherent receivers ▶ Supports compact mmWave converter setups	R&S®ZNA-B26
Eight internal pulse generators and four internal pulse modulators	▶ For measurements on pulsed signals and for flexible system integration ▶ R&S®ZNA-B7 increases the number of wave quantities that can be captured in parallel with R&S®ZNA-K7	R&S®ZNA-K7, R&S®ZNAxx-B4n [4], R&S®ZNA-B7
Enhanced trigger and control functions (three additional trigger inputs, four trigger outputs, four pulse control I/O ports, ready for trigger, busy, RF interlock control) [5]	▶ Universal system adaptation and easy system integration ▶ High reference frequency for low phase noise	R&S®ZNA-B91
Metrology configuration for R&S®ZNA	▶Enhanced long-term stability ▶Support of 2/4-port R&S®ZNA	R&S®ZNAxx-B10
Source step attenuators, 0 dB to 70 dB in 10 dB steps	▶Generation of low-power stimulus signals down to –110 dBm	R&S®ZNAxx-B2n[4]

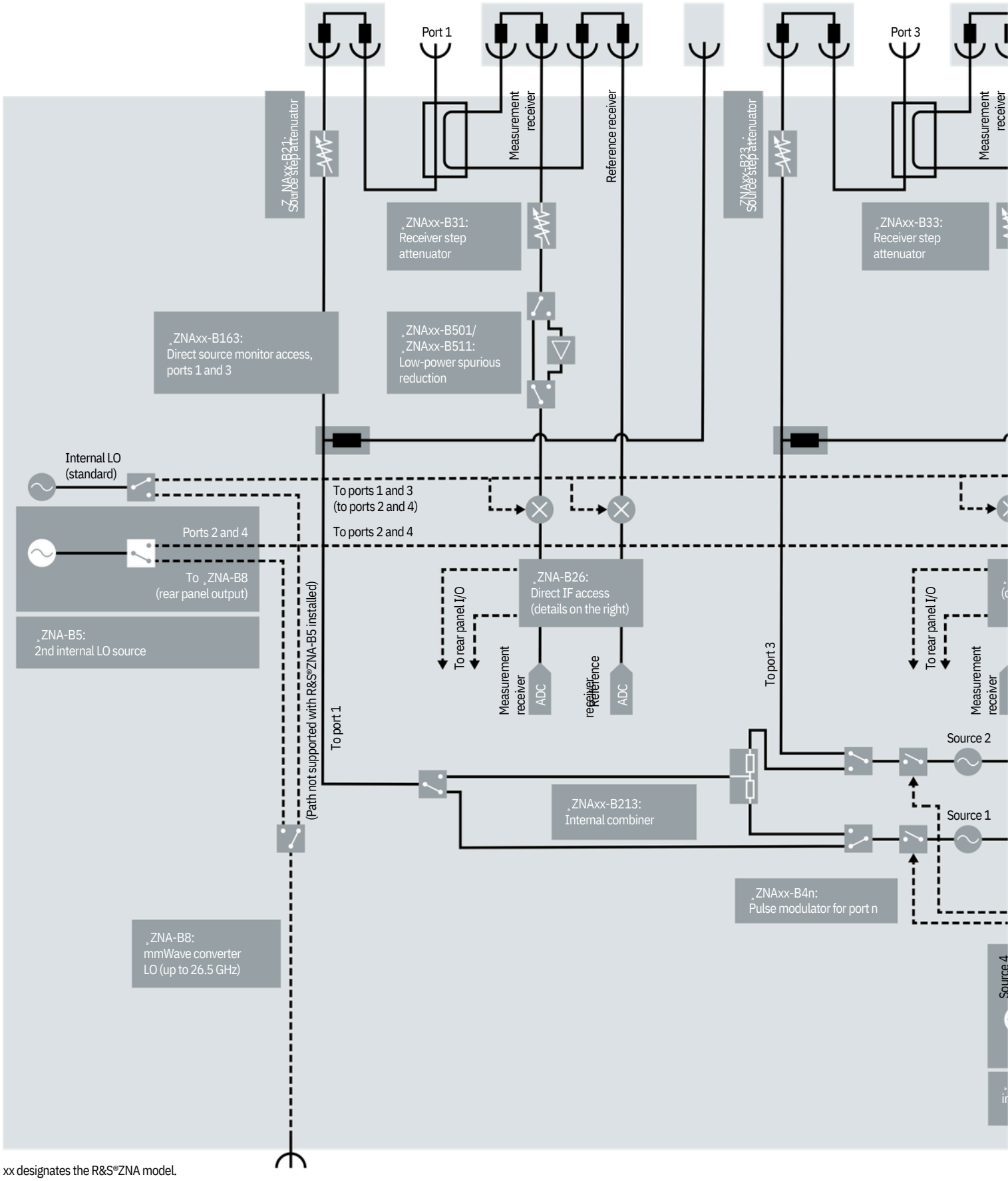
[1] xx designates the R&S®ZNA model (R&S®ZNA26, R&S®ZNA43, R&S®ZNA50 and R&S®ZNA67).
[2] Between 100 kHz and 10 MHz, the internal coupler can only be used to a limited extent. Here, external directional components and recalibration are required.
[3] The 2-port R&S®ZNA models come with one RF source as standard, the 4-port R&S®ZNA models with two RF sources.
[4] n designates the port number (1/2/3/4).
[5] 1 GHz reference frequency input provided as standard.

Description	Applications and benefits	Hardware option [1]
Receiver step attenuators, 0 dB to 35 dB in 5 dB steps	▶ Compression-free measurements with input power up to destruction limit of +27 dBm	R&S®ZNAxx-B3n [4]
Rear panel output for internal LO signal (when the 2nd internal LO source (R&S®ZNA-B5) is installed, it is available at the output); provides up to +25 dBm output power	▶ Support of compact mmWave converter setups (2 /4 - p or t mmWave c onver ter setups with 2 /4 - p or t R&S®ZNA) without additional external source ▶ General-purpose RF source up to 26.5 GHz ▶ High source power not affected by hardware options installed in the R&S®ZNA frontend	R&S®ZNA-B8
mmwWave extender with LO output for R&S®ZNA67EXT [6]	▶ Enables frequency overrange above 110 GHz	R&S®ZNA-B80
Frequency extension for R&S®ZNA67	▶Frequency range extended up to 72 GHz ▶Support of 2/4-port R&S®ZNA67	R&S®ZNA67-B72
Switchable internal combiner, provides a two-tone signal at port 1	▶Intermodulation measurements ▶Embedded LO converter group delay measurements (R&S®ZNA-K9 option) ▶ Mixer measurements with 2-port R&S®ZNA models (R& S ® Z N A - B 8 a s 26 . 5 GHz LO s o u r c e)	R&S®ZNAxx-B213 for 4-port models, R&S®ZNAxx-B212 for 2-port models
Direct source monitor (reference signal) access; when reconnecting the R&S®ZNAxx-B16 reference signal front panel jumper to the direct source monitor output (R&S®ZNAxx-B161/-B163), the signal to the reference receiver can be picked up before the source step attenuator	▶ Low trace noise even with low output power levels as typically encountered with high gain DUTs ▶ Monitoring of source output power simultaneously at source monitor output and test port	R&S®ZNAxx-B161, R&S®ZNAxx-B163
Low-noise preamplifier at port 2 measurement receiver, switchable low-noise amplifier (LNA) with selectable gain and integrated filter	▶ Noise figure measurements on amplifiers and converters ▶ Up to 30 dB gain for low gain / low noise figure DUTs	R&S®ZNAxx-B302 [7], R&S®ZNAxx-B312
Low-power spurious reduction, isolation amplifier at port 1 measurement receiver; low-power spurious level is reduced down to –110 dBm	▶Optimized spurious suppression ▶Signal purity with very low stimulus levels ▶Reliable high gain amplifier/converter testing	R&S®ZNAxx-B501 [6], R&S®ZNAxx-B511
Direct control interface, a proprietary interface for Rohde & Schwarz extensions	▶ Control of R&S®ZN-ZCG comb generator as phase reference ▶Control of the external RFFE GPIO interface ▶Control of switch matrices such as R&S®ZN-Z8x	R&S®ZNA-B12
MIPI RF frontend (RFFE) and general-purpose input/output (GPIO) interface, including voltage and current measurements	▶Integrated, configurable control of mobile phone frontend chipsets ▶ Additional digital and analog I/O	R&S®ZNA-B15

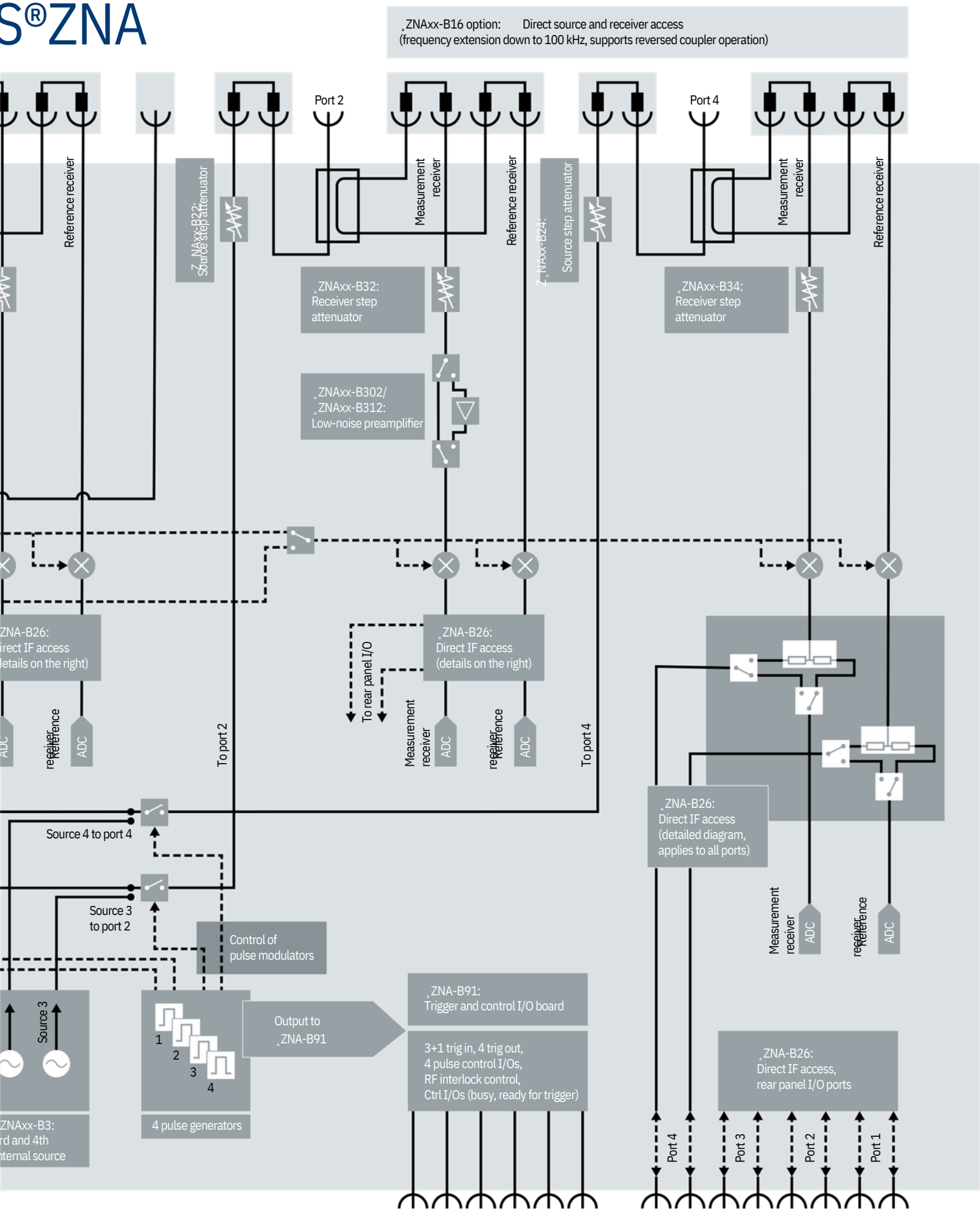
[6] Export restricted.

[7] R&S®ZNAxx-B302 and R&S®ZNAxx-B501 options provoke increased receiver sensitivity for other option(s). If the enhanced sensitivity conflicts with country-specific ex p or t re gul ations, R&S ®ZN A x x- B 312 and R&S ®ZN A x x- B511 options c an b e ordere d ins te ad.

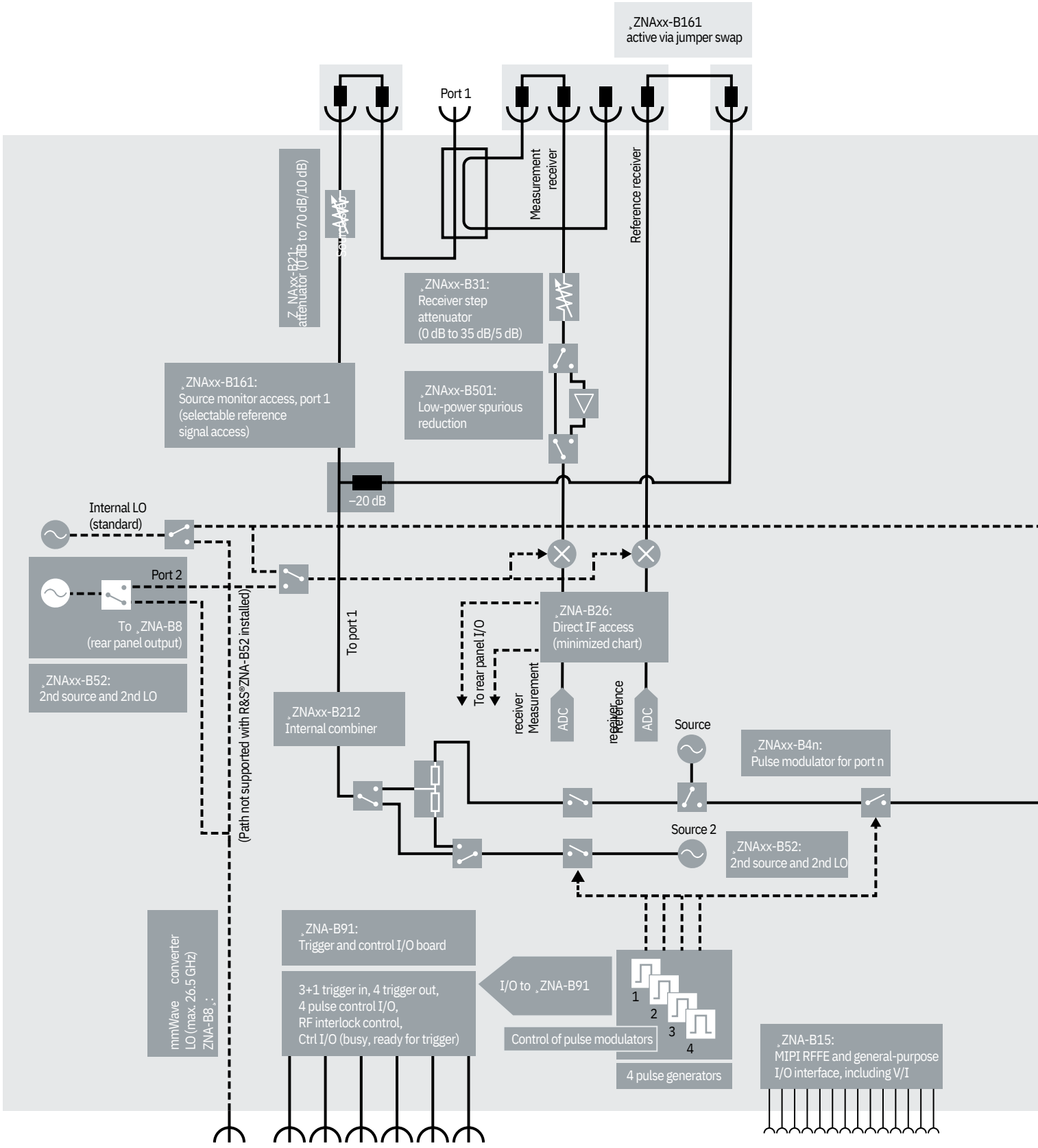
PRINCIPLE OF OPERATION OF 4-PORT R&



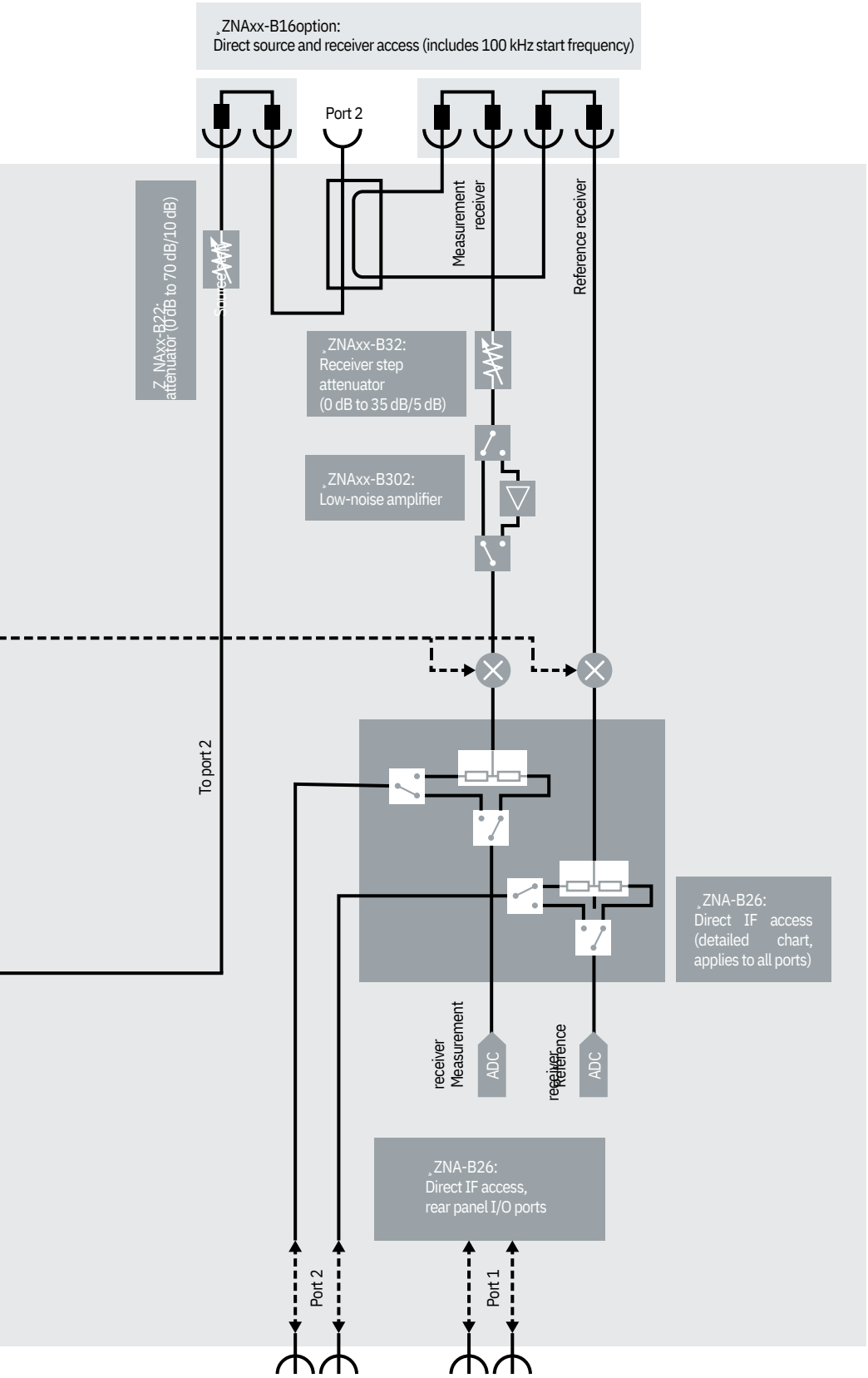
xx designates the R&S®ZNA model.
n designates the port number (1/2/3/4).


„ZNAxx-B16 option: Direct source and receiver access
(frequency extension down to 100 kHz, supports reversed coupler operation)
Port 2
Port 4
Reference receiver
Measurement receiver
„ZNAxx-B22: Source step attenuator
„ZNAxx-B24: Source step attenuator
„ZNAxx-B32: Receiver step attenuator
„ZNAxx-B34: Receiver step attenuator
„ZNAxx-B302/ „ZNAxx-B312: Low-noise preamplifier
„ZNA-B26: Direct IF access (details on the right)
To rear panel I/O
To port 2
To port 4
ADC
Source 4 to port 4
Source 3 to port 2
Control of pulse modulators
Source 3
1
2
3
4
Output to „ZNA-B91
„ZNA-B91: Trigger and control I/O board
3+1 trig in, 4 trig out, 4 pulse control I/Os, RF interlock control, Ctrl I/Os (busy, ready for trigger)
4 pulse generators
„ZNAxx-B3: rd and 4th nternal source
„ZNA-B26: Direct IF access (detailed diagram, applies to all ports)
„ZNA-B26: Direct IF access, rear panel I/O ports
Port 1
Port 3

PRINCIPLE OF OPERATION OF 2-PORT R&



xx designates the R&S®ZNA model.
n designates the port number (1/2).


„ZNAxx-B16option:
Direct source and receiver access (includes 100 kHz start frequency)
Port 2
Measurement receiver
Reference receiver
„ZNAxx-B22:
attenuator (0 dB to 70 dB/10 dB)
„ZNAxx-B32:
Receiver step attenuator
(0 dB to 35 dB/5 dB)
„ZNAxx-B302:
Low-noise amplifier
To port 2
„ZNA-B26:
Direct IF access (detailed chart, applies to all ports)
receiver Measurement
ADC
receiver Reference
ADC
„ZNA-B26:
Direct IF access,
rear panel I/O ports
Port 2
Port 1

THE RIGHT CALIBRATION FOR EVERY TEST SCENARIO

The R&S®ZNA offersawiderangeofcalibration techniquesforcoaxialand non-coaxialsystems, such as wave guides andprinted circuit boards(PCB). Variousdeembedding techniques offersolutions for in-fixture and on-wafer calibration. The R&S®SMARTerCal concept combines system error correction with receiver and flatness calibration, guiding the operator efficiently to the optimal result.

Fullcalibrationwithonlythreestandards–faster,simpler, more precise

- ▶Through, reflect, line/line, reflect, line (TRL/LRL) for on-wafer applications, waveguides and coaxial DUTs
- ▶Through, reflect, match (TRM) for applications in test fixtures and on wafers
- ▶Through, short, match (TSM) and through, open, match (TOM) as alternatives to TOSM, for reduced calibration effort

CalibrationforDUTsusingamixofconnectors

The classic TOSM method does notprovide direct calibration of test setups for DUTs equipped with different types of connectors at the input and output. The R&S®ZNA offers two alternatives to provide this type of calibration.

UOSM calibration

Unknown through, open, short, match (UOSM) calibration is the smartest way to overcome the above problem. It involves about the same effort as TOSM calibration. A through connection with unknown parameters is required, i.e. a reciprocal (but otherwise more or less arbitrary) two-port, e.g. a simple and cost-effective adapter.

Adapter removal method

The R&S®ZNA also provides classic adapter removal calibration. This method is very robust, but requires many more calibration steps.

R&S®SMARTerCal–getreadyforactivedevicetesting

Calibrating theabsolute power levels of the sources and receivers is indispensable in order to reliably test amplifiers, mixers and T/R modules. However, this process is time-consuming. The R&S®ZNA uses a special calibration technique referred to as R&S®SMARTerCal, which radically simplifies calibration. R&S®SMARTerCal combines the information gained from system error correction (e.g. TOSM, UOSM) with the information obtained through absolute power level calibration (wave quantities in terms of amplitude and phase). This means that the absolute power levels of the sources and receivers are calibrated already during system error correction, taking into account port mismatch. For absolute output power level calibration, the power sensor needs to be connected to a test port only once. The calibration values for all other sources and receivers are derived from the calibration values for that specific test port. This significantly reduces calibration time and effort.

Multiline TRL calibration in line with National Institute of Standards and Technology (NIST)

Even though standard TRL calibration is preferablefor on-wafer calibration or planar line systems, NIST multiline TRL calibration has valuable features that improve accuracy and reliability. The calibration is in line with NIST recommendations and can overcome standard TRL frequency band limitations while avoiding the potential discontinuities in the transition frequencies when several TRL bands are concatenated. Taking line attenuation into account further increases accuracy. The use of multiple lines also creates optimized calibration over a wide frequency range.

The R&S®SMARTerCal merges system error correction, receiver power calibration and absolute source level calibration.

Digital automatic level control (ALC)

The configurable digital ALC sets the source power precisely to the target value, using a reference signal that can be derived from any point in the test setup. This means that the source power is adjusted, in a minimum of time, to the output power of a preamplifier in the test setup or to the output power of the DUT. Power fluctuations, e.g. due to drift effects, are eliminated. This provides stable, reproducible power conditions over long test cycles.

Unlike wideband diode detectors, the ALC uses the digitally filtered results delivered by the reference receivers. As a result, the source power is adjusted to the power of the wanted signal (fundamental) without any distortion otherwise introduced by harmonics, for example. Users can configure the ALC parameters, such as the ALC IF bandwidth, to achieve the optimum balance of accuracy and control time.

ALC controlled high-power setups

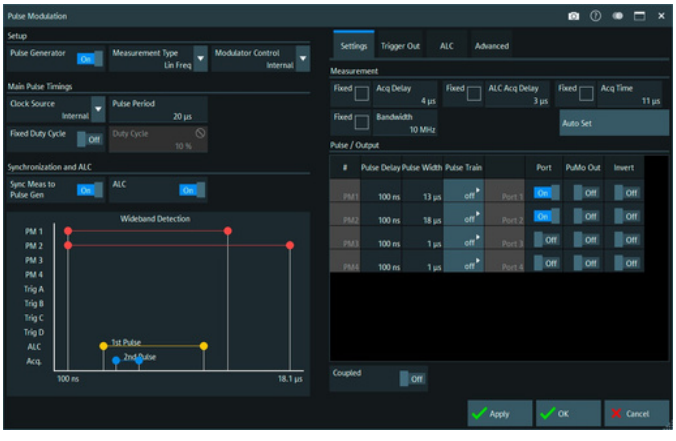
With the reference signal picked up at any point in the test setup, the R&S®ZNA controls the source to keep output power from booster amplifiers stable with high precision. Settling effects are equalized in milliseconds and measurements can be triggered immediately after power changes.

ALC ensures accuracy at very low levels

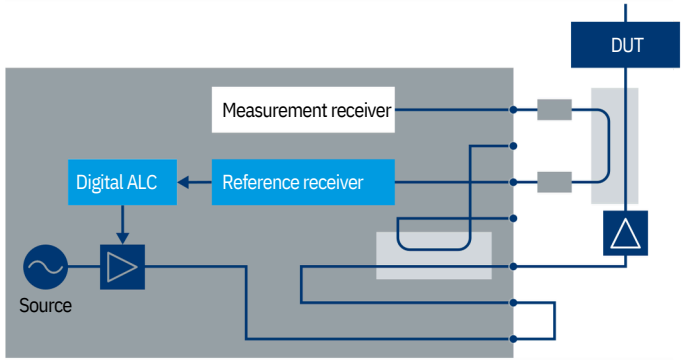
The analyzer's excellent receiver linearity of < 0.05 dB across a wide range from –50 dBm to 0 dBm results in high level accuracy even when measuring very low power levels. The receivers are calibrated at a higher power level that is optimal for the power sensor. The power level is then reduced, while power accuracy is maintained thanks to the reference receivers' high linearity and ALC control.

Amplifier IM and converter test

For measurements requiring two or more signals, (intermodulation test, R&S®ZNA-K9 converter group delay test) all sources involved are controlled for reliable active device characterization.



Digital automatic level control (ALC)



ALC operation: in a high-power setup with an external preamplifier and a directional coupler, the source power is controlled to match the preamplifier output power. This compensates for drift effects, making the output power very precise and stable.

ALCdeembeddingforin-fixtureandon-wafernoisefiguretests

The ALC accounts for deembedded virtual networks, inserted or removed after power calibration. This way, the reference plane for the power control is shifted at the end of probes for the on-wafer test or into test fixtures. The latter is particularly useful for noise figure measurement for in-fixture/on-wafer chip tests.

ALC with pulsed signals

The finite measurement and control time of the ALC is typically longer than the short pulse duration time. To find the optimal setting, the ALC and pulse parameters can be matched, and users can select whether to carry out ALC control and measurement on the same or on successive pulses.

Power offset correction for short pulses

The point-wise ALC cycle may result in a total control and measurement time per point that exceeds the duration of the short pulses. As an alternative, R&S®ZNA offers a sweep-wise power offset correction, where the power is corrected after the completion of each sweep. Thus, the measurement IFBW is decisive for the time per point, without time offset.

The configuration of ALC supported measurements under pulsed condition allows detailed settings to match ALC and pulse parameters. For instance, to allow short pulses, ALC control and measurement can be set to successive pulses.

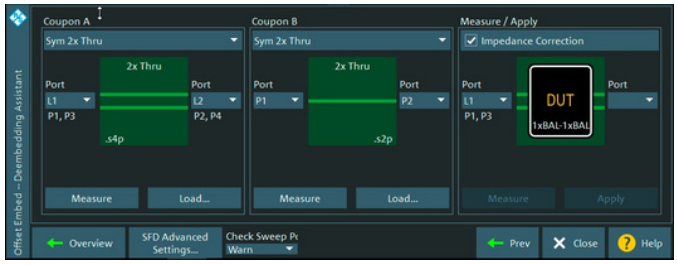
Fast deembedding for impedance matching using virtual networks

Coaxial andbalanced components,such as surface acoustic wave (SAW) filters used in mobile phone frontends, are specified together with the networks that match them to the impedance of the surrounding circuit. The R&S®ZNA can embed the DUT into virtual matching networks to provide realistic conditions by simulating the DUT installed in its operational environment. The R&S®ZNA offers a choice of predefined matching network topologies. If values of individual network elements are edited, the R&S®ZNA immediately recalculates the network and embeds the DUT in the new network in real time. In addition to predefined topologies, .s2p, .s4p, .s6p and .s8p files can be read into the R&S®ZNA and used for embedding/ deembedding.

EnhancedsolutionsforIn-fixtureandPCBtesting

IfDUTs do nothave coaxial connectors,vector network analyzer calibration often cannot be made directly in the reference planes. This is the case for in-fixture and on-wafer chip tests, measurements of PCB structures, non-coaxial connectors or cables and all non-connectorized components. In these cases, test fixtures, probes or other structures are used to adapt from the coaxial interface at the calibration plane to the device under test. The corresponding lead-ins and lead-outs need to be modelled and characterized via their S-parameters, so that they can be deembedded from the measurement results.

For such tasks, the R&S®ZNA is prepared by seamless integration of third-party tools made available as the R&S®ZNA-K210, R&S®ZNA-K220, R&S®ZNA-K230 and R&S®ZNA-K231 options. All procedures are coupon based, and differ by the type and number of applied test coupons, the incorporation of PCB impedance effects, and calculation speed. A user-friendly wizard with agraphical interface andparameterentries specific to eachdeem bedding tool, guide the operator through the entire calibration and deembedding procedure.



For in-fixture and PCB tests Rohde & Schwarz offers advanced coupon based deembedding options, supported by a smart configuration wizard.

Calibration equipment

TheR&S®ZN-Z1xx economy calibration kits provide robust operation up to 43.5 GHz. The R&S®ZN-Z2xx high-end calibration kits are available for more sophisticated requirements, offering calibration standards from type N through 1.0 mm (110 GHz connectors). These kits achieve very high calibration accuracy thanks to precision manufacturing combined with S-parameter based characterization of the individual calibration standards.

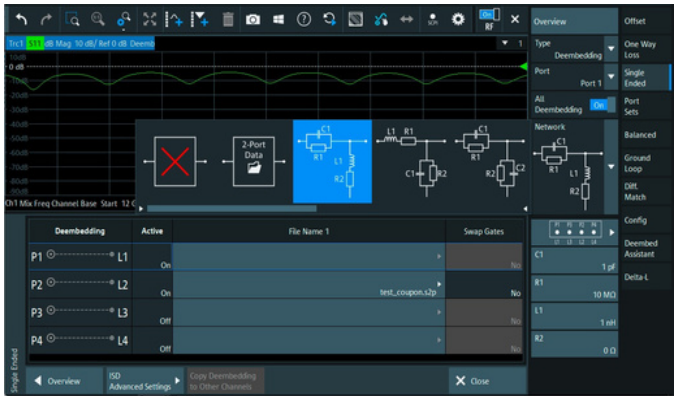
Automatic calibration units

Automatic calibration units up to 67 GHz with two or four ports greatly simplify calibration, while reducing operator errors and improving calibration repeatability.

Calibrationofmixerandconvertersetups

With the R&S®ZNA-K4, R&S®ZNA-K5 and R&S®ZNA-K9 options, the R&S®ZNA supports comprehensive characterization of frequency translating devices, such as mixers, T/R modules, and (embedded LO) satellite receivers (LNB). For the R&S®ZNA to measure group delay and, for instance, transmission phase, the mixer used for calibration should be reciprocal in corresponding limits. Users can extend their manual kit or calibration unit with calibration mixers that meet this requirement. The R&S®ZN-ZM292 is reciprocal [1] within tight limits and covers common conversion schematics up to 40 GHz.

[1] Ideal reciprocity and thus the absolute phase accuracy is degraded by $S21/S_{12}$ uncertainty, and LO contributions.



The R&S®ZNA comes with a choice of predefined matching networks whose values can be edited. If values are changed, the R&S®ZNA will immediately recalculate the network and embed the DUT in the new network in real time.

R&S®ZN-ZCG44/67 comb generator, for calibration of phase reference

R&S®ZN-Z1xx economy calibration kit

R&S®ZN-Z2xx high-end calibration kits

R&S®ZN-Z156 calibration unit

R&S®ZN-ZCG comb generator

The R&S®ZN-ZCG comb generator has a traceable wideband phase reference for calibrating R&S®ZNA receivers that enables phase-accurate harmonic and sideband measurements of power amplifiers and frequency- converting DUTs such as mixers and converters. The R&S®ZN-ZCG generates a pulse train with a dense set of equally spaced comb lines in its spectrum. The magnitude and phase of each line are characterized in the factory. R&S®ZNA receiver channels for a test-port group can be prepared for wideband phase testing.

The R&S®ZNA-B12 device control interface handles synchronization and control by using a 2 GHz clock from a R&S®ZNA test port during calibration.

Tone spacing can be selected in the kHz range up to 100 MHz with additional user-defined spacing available up to 2 GHz to closely match the measurement frequency grid and maximize the signal-to-noise ratio (SNR) for comb lines. The R&S®ZN-ZCG44 and R&S®ZN-ZCG67 cover frequencies up to 44 GHz respectively 67 GHz and NIST traceability ensure reliability.

The comb generator is supported by R&S®SMARTerCal and can be used as a calibration unit. The comb generator can also be disconnected after error correction, leaving all test ports available for measurements. The generator can also be monitored when operating or used as a standalone unit in nonlinear, large-signal setups.

Real-time measurement uncertainty and verification

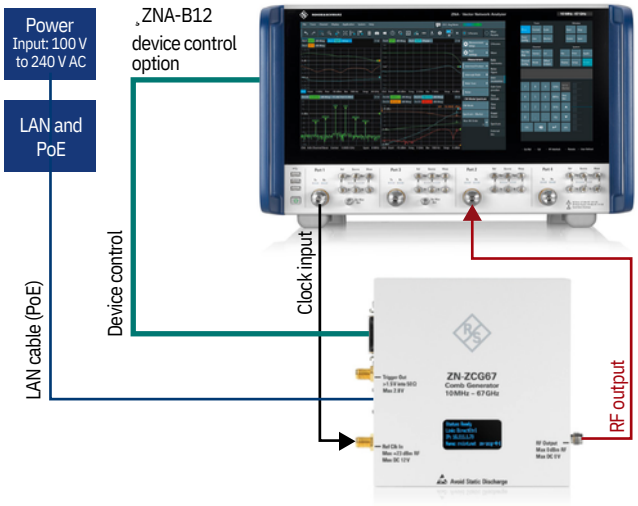
Uncertainty data listed on data sheets is inevitably provided for only a limited set of test parameters. With the two functionalities offered by the R&S®ZNA-K50(P) option, operators can check uncertainty under the given test conditions and verify actual RF performance:

- S-parameter traces can be displayed with error bars, calculated in real time depending on the current settings
- Verification measurements are performed to ensure that verification standards match their characterization values. Utilizing R&S®ZV-Z4xx verification kits ensures traceability of measurement results to the Swiss metrology authority METAS.

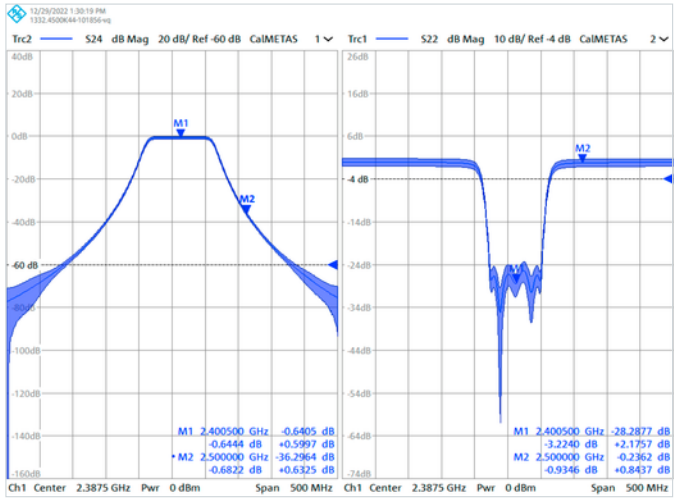
The R&S®ZNA-K50(P) option requires installation of the VNA tool from the Swiss metrology authority METAS. This option enables operators to use the VNA tool as an additional means of individual uncertainty evaluation.

R&S®ZN-ZCGconnectionexampleforR&S®ZNAcalibration

The R&S®ZN-ZCG44/67 calibration setup has one RF port feeding the 2 GHz clock signal. When combined with the R&S®SMARTerCal, all receivers are phase-calibrated. The R&S®ZN-ZCG can be disconnected after calibration, as with a calibration unit.



R&S®ZNA-K50(P) option adds error bars to S-parameter traces in real time, to calculate the uncertainty in real time for every sweep.



HIGH-END, APPLICATION-TAILORED PERFORMANCE

Along with basic RF performance, smart features optimize test setups and test execution.

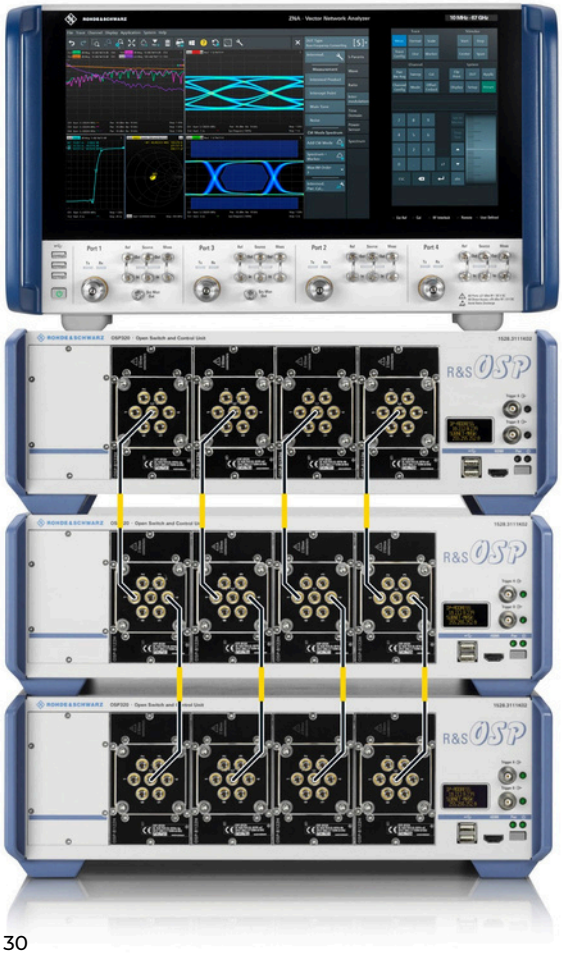
Features for quick results

Besides very short measurement times, the R&S®ZNA has other features to speed up data acquisition. The specified high dynamic range of > 129 dB generates a high SNR for accurate measurements, even with large IF bandwidths and it only needs short amount of time for measurements. RF and IF signals can be recorded simultaneously with the second internal LO source when measuring mixers. Measurement speeds are fast enough to measure non-frequency-converting S-parameters. The R&S®ZNA can pick up measurement data on all of its ports simultaneously for parallel testing of two 2-port DUTs, doubling throughput.

Flexiblemultiportsystemswithspeedenhancement

Besides active device characterization, passive device and digital design testing (DDT) is challenging for multi-band and multiport testing due to high port numbers and sweeps with large point counts. The R&S®ZNA-K66 option for a 4-port R&S®ZNA significantly improves speed while letting users reduce sweep time and maintain measurement quality.

Combining the R&S®ZNA with one or more configurable R&S®OSP open switch and control unit supports multiport measurements. The R&S®ZNRun vector network analyzer test automation suite is a powerful software tool that makes defining a test configuration easy. The software suite was designed for optimization and acknowledges that workflows need to be expedited as much as possible.



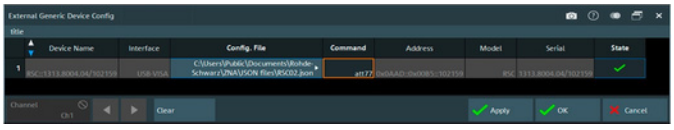
R&S®ZNA based multiport solution for fully automated multiport testing; highest flexibility is provided by integrating the configurable R&S®OSP320 open switch and control units.

SYSTEM INTEGRATION AND CONNECTIVITY

Flexibletest systemcompletionwithuserinstrumentation,extendeddynamiclinklibrary (DLL) and remote instrument monitoring.

Generic device system integration

The R&S®ZNA supports a wide range of auxiliary instruments by default, such as Rohde & Schwarz signal generators and power test heads. If the test system needs to be extended with further instrumentation, the R&S®ZNA firmware provides the operator a powerful and flexible tool by means of external generic device configuration. With command files in JavaScript Object Notation (JSON, *.json) format, users can set up communications to an external VISA capable device. ASCII notation can be used to define sequences of commands, and command files for different instruments can be loaded.



A JSON command list file is defined in the "External Generic Device Config" menu. A command or command sequence from the file can be selected for each channel.

Dynamic link library integration

Anevenmorepowerfulandversatile tool is the integration of user-provided DLL. Besides the control of external devices, (firmware compatible) GUI windows can be created, and individual data processing and analysis can be added. A basic example is the control of an external power meter or source monitor unit for an amplifier power added efficiency measurement (PAE). For some Rohde & Schwarz power meters, plug & play DLLs are available, and the open DLL architecture supports operators who want to integrate custom code.

Health and utilization monitoring service (HUMS)

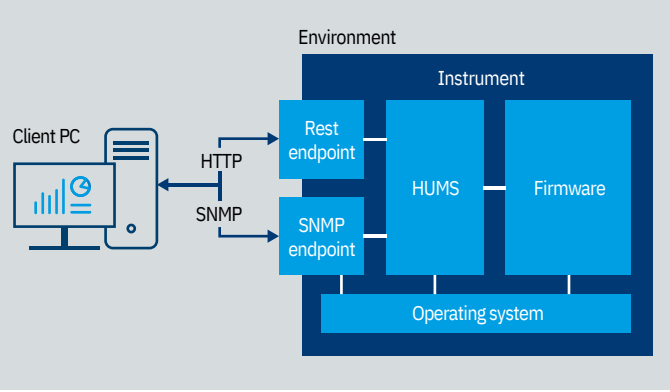
For companies with a large installed instrument base and extended networks, a clear overview of the entire network and central management is crucial for ensuring effective and reliable operations across the network. The software for all of the modules needs to be kept up to date, costs and efficiency need to be optimized using statistical data, operations need to be monitored and failures recognized as soon as possible. HUMS is a service that runs locally on each instrument, collecting and storing data on that instrument. Data can be retrieved by standard plug & play browser based communications, and with application specific programming.

HUMS is available on the R&S®ZNA with the R&S®ZNA-K980 software option. HUMS opens the SNMP agent and a REST service with HTTP endpoints, which allows the HUMS data to be retrieved.

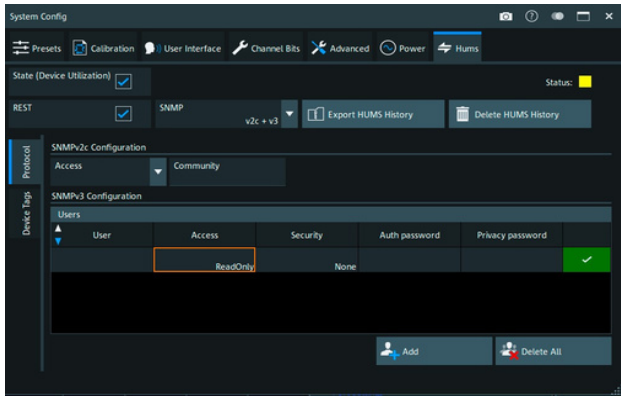
Some examples of parameters obtainable from a VNA:

- Hardware and software options
- Detailed info on hardware components (e.g. sync, HDD)
- Status (self-test, system messages, service)
- Malware status
- Storage capacity
- Utilization (e.g. activity of hardware and software options, count number of switching cycles)

Functional schematic of HUMS



R&S®ZNA HUMS activation and configuration GUI



MEASUREMENT MODES

COMPRESSION POINT MEASUREMENTS

Determining thecompressionpoint is essentialwhencharacterizingactive components. With the R&S®ZNA, compression pointmeasurements can beflexiblycombinedwithS-parameter measurements.

Highly accurate results

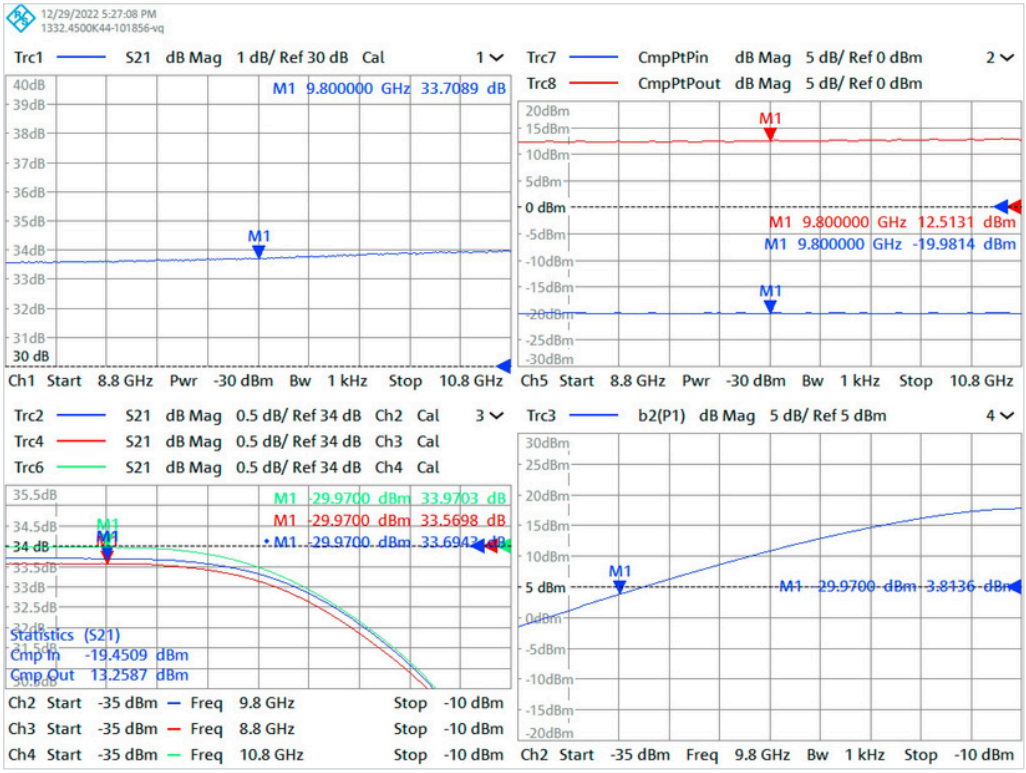
Compression measurements in particular require accurate power levels for stimulation and measurement as well as port match correction. The R&S®SMARTerCal procedure combines receiver power calibration, source flatness calibration and system error correction, thus compensating for the test set response and system error. Outstanding high receiver linearity makes it possible to reduce power calibration to a single point of the power sweep, which drastically reduces calibration time.

Power and phase sweeps for detailed insight

Tofind theoptimum set ofpower sweepparameters, single power sweeps at dedicated frequencies can be combined in one display. For single power sweeps, the x dB (where x dB is typically assumed as 1 dB or 0.1 dB) compression can be flexibly referenced to single values or power ranges, thus minimizing noise effects in the small signal range. Compression power and S-parameters are shown in real time. The reverse power sweep reveals hysteresis effects of the DUT and the test time can be reduced by the swept mode.

Compression versus frequency

Automatic compression measurement performs power sweeps in the background at each data point and directly shows the CP(f) in terms of the input/output power or as an S-parameter. To minimize measurement time, the linear range can be skipped by defining a back-off value to set a reference different from the power sweep start value.



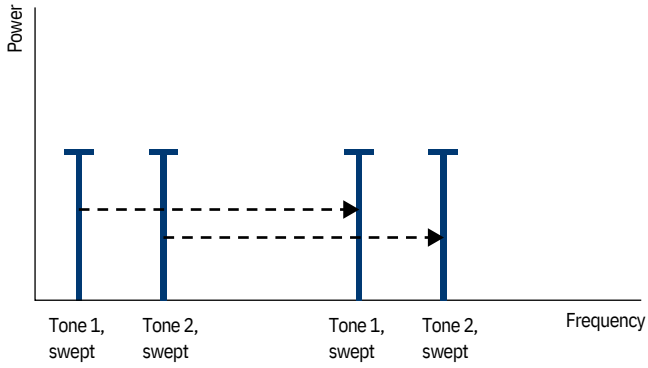
Amplifier compression measurements:

- Gain
- Compression point by measurement of power sweeps at dedicated frequencies
- Input and output power compression point versus frequency
- Absolute power

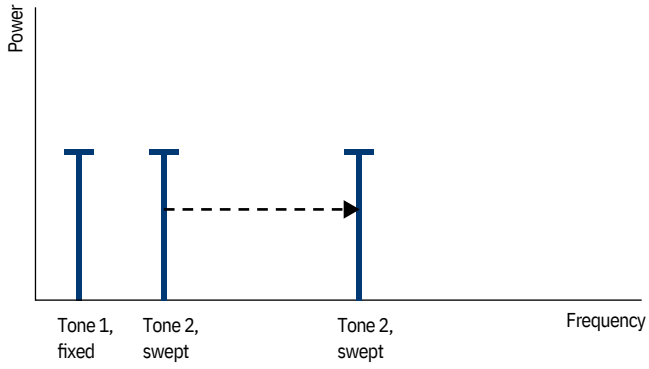
INTERMODULATION MEASURE MENTS ONAMPLIFIERS AND MIXERS

The R&S®ZNA makesitpossibletodeterminetheintermodulationcharacteristicsofamplifiersandmixers fast andwith highaccuracy.

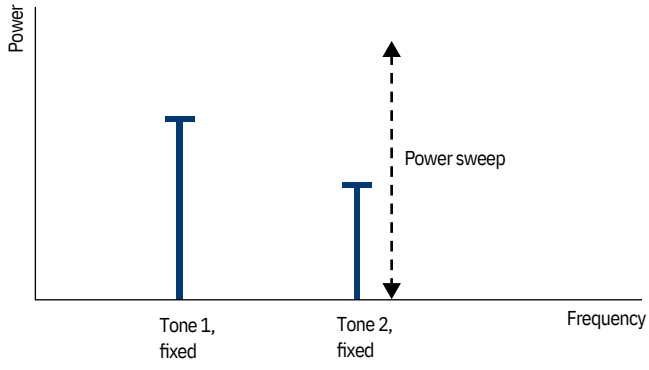
Frequencysweepwithfixedcarrierspacing



Frequency sweep with variable carrier spacing



Powersweepwithfixedcarrierspacing



The R&S®ZNA provides the following three types of intermodulation m easurements:

- ▶ Frequency sweep with fixed carrier spacing
- ▶ Frequency sweep with variable carrier spacing
- ▶ Power sweep with fixed carrier spacing

Wide dynamic range and digital ALC for challenging intermodulation measurements

The R&S®ZNA offers major benefits especially when measuring amplifiers with very small intermodulation products. Its wide dynamic range and the excellent power handling capacity of its receivers make it possible to measure low intermodulation distortion within seconds instead of minutes.

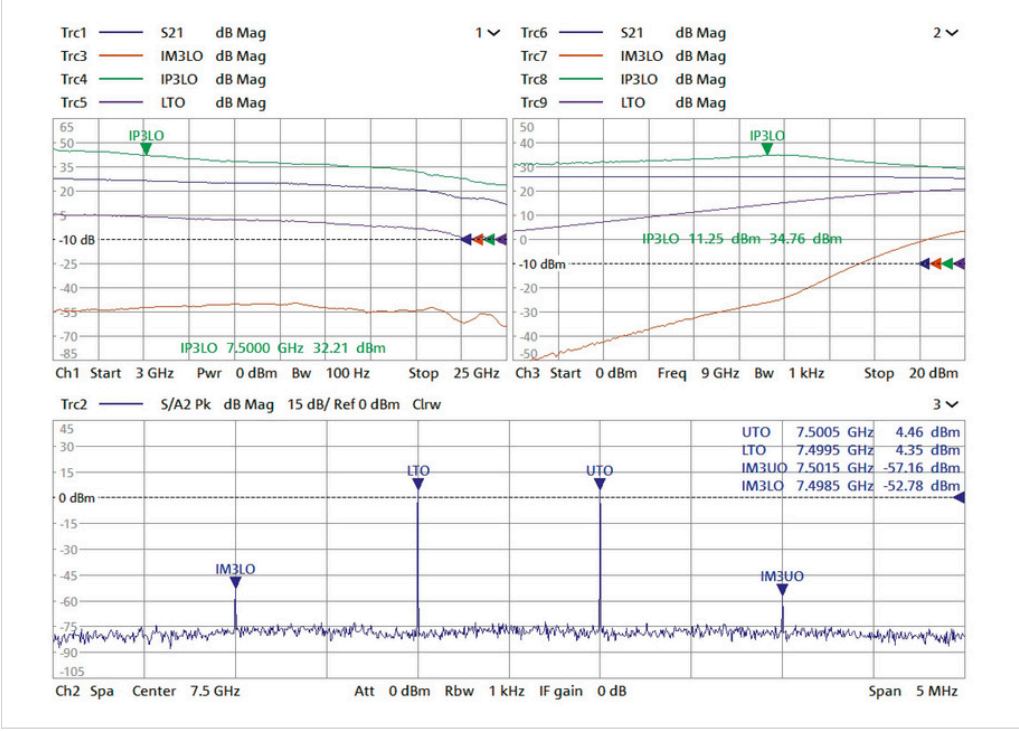
When measuring intermodulation, precise control of the powers applied to the DUT inputs is vital. Here, the R&S®ZNA makes no compromises. Automatic level control (ALC) combined with system error correction ensures a precise amplitude for the individual carriers over the entire frequency range, regardless of the DUT's input reflection coefficient.

Highoutputpowerandflexibility

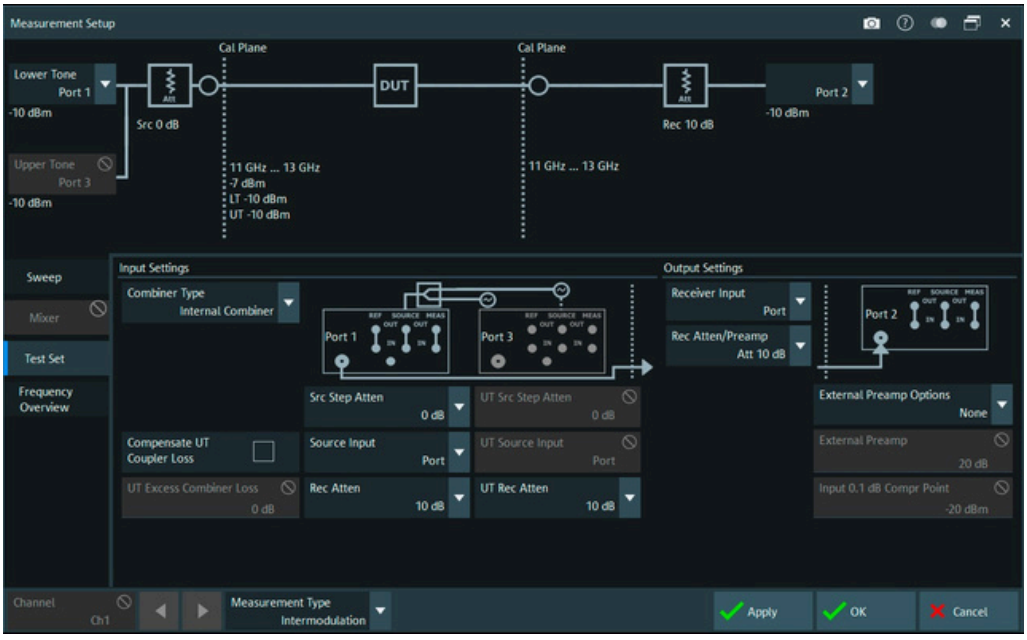
Featuring four independent sources, the R&S®ZNA can even perform intermodulation measurements on mixers without requiring an external source. The analyzer delivers high output p owers of up to +20 dBm per test port. If this is not sufficient, the R&S®ZNA can flexibly loop external amplifiers into the signal path and precisely control them via ALC.

Simplified configuration with graphical user interfaces

Dedicatedmixer andintermodulationtestscan be configured with tailored GUIs. The test parameters are displayed at corresponding positions in a test set diagram. The actual hardware settings for attenuators and (direct) channel access ports are dynamically displayed above the diagrams, so that operators can keep track and be confident about the setup and test results.



Comprehensive amplifier characterization, including intermodulation products (IP), IP versus frequency, spectral measurements and other quantities



Configuration GUI for an amplifier intermodulation test

NOISE FIGURE MEASUREMENTS ON AMPLIFIERS AND MIXERS

The R&S®ZNA-K30 noise figure measurementsoptionfurther enhancestheR&S®ZNAtoprovideapowerful and versatiletest system forfull characterizationofamplifiers andconverters.

Noisefiguremeasurementsonamplifiersandmixers

The R&S®ZNA-K30 noise figure measurements option expands the R&S®ZNA to include noise figure analysis for amplifiers, converters and T/R modules. Hardware options can be added to further optimize this functionality, e.g. to stimulate high gain amplifiers with very low levels or to measure low gain/low noise figure LNAs with high accuracy.

Single connection device characterization

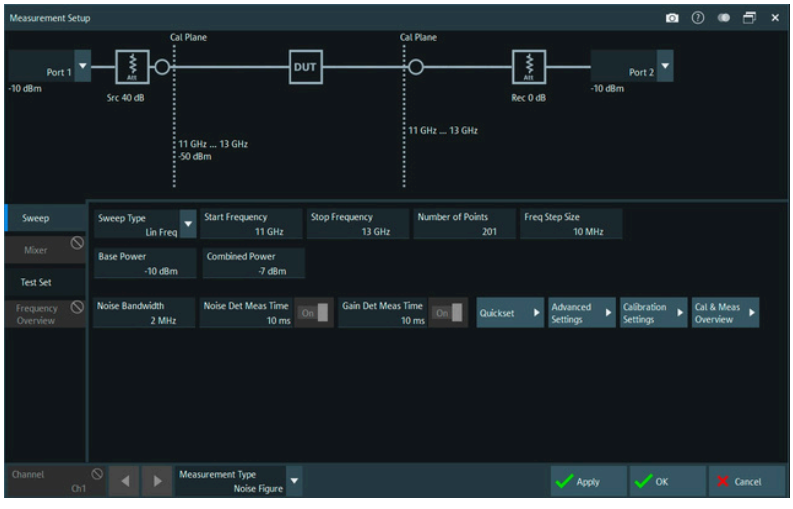
Instead of using a noisesource to determine the noise figure, the R&S®ZNA directly measures absolute noise power, based on absolute power level calibration and system error correction. Likewise, instrument calibration with a manual calibration standard, a calibration unit and a power sensor requires no extra equipment; an external noise source is not necessary. The calibration process is included in the convenient calibrate all function for the entire setup. The DUT (amplifier, converter, T/R module) needs to be connected only once to provide full device characterization, including quantities such as conversion gain/loss, intermodulation distortion, compression and group delay.

StraightforwardmainGUIforamplifierandmixertestsetups

The GUI shows the hardware components in the measurement path as graphic elements und helps users optimally configure all the details. Users can see all relevant settings at a glance, including source power, step attenuators, the resul ting power level at the reference plane, the internal/external preamplifier gain on the receiver side, and the test parameters. The GUI also provides elements for configuring frequency-converting measurements on mixers and converters; even measurements on high gain receivers with embedded LO can be easily configured and deliver reliable results.

Calibration features and settings

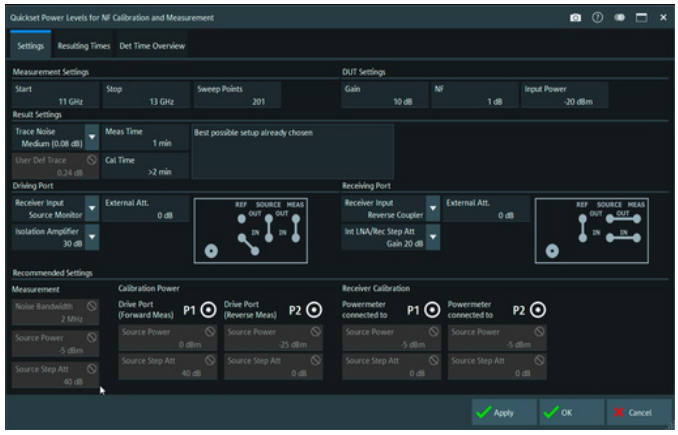
The challenge many instruments and devices are facing with this type of measurement is to handle very low stimulus powers and high measured power levels that may even differ for calibration and measurement and in the forward and reverse direction. The main GUI includes essential parameters to help users easily find the desired settings with manual configuration. Correction algorithms such as used in system error correction provide accurate and reliable results.



GUI for configuring noise figure measurements on amplifiers, mixers, converters and T/R modules

Quickset–thefastandintuitivewaytooptimalsettings

Asanalternativetodirect manual configurationof measurement and calibration parameters and the R&S®ZNA hardware, the extremely powerful Quickset dialog guides users interactively to the optimal setup. Based on estimated DUT characteristics such as the approximate noise figure (NF) and gain and the desired noise figure accuracy, the R&S®ZNA calculates parameters such as the measurement time and source power and displays the recommended optimal hardware configuration (e.g. use of direct source monitor access, low-noise preamplifier at receiver port 2 or reverse coupler operation). Interactive graphic elements help the user modify settings. The effects of modifications are calculated and displayed instantaneously and can be assessed by the user. This is a quick way to configure reliable noise figure measurements on amplifiers.



Quickset dialog for interactive and semi-automatic configuration of optimal test parameters and R&S®ZNA hardware

Options supporting noise figure measurements

Designation	Type	Required/recommended	Comment
Noise figure measurements	R&S®ZNA-K30	required	with R&S®ZNA-K4: support of frequency-converting measurements
Options for source port 1 (port 3) configuration			
Direct source monitor access, port 1/port 1 and port 3	R&S®ZNAxx-B161/ R&S®ZNAxx-B163 [1]	required	provides a relatively strong reference signal with very low stimulus powers, for low trace noise (requires R&S®ZNAxx-B16/-B21/-B23)
Source step attenuator, port 1/port 3	R&S®ZNAxx-B21/ R&S®ZNAxx-B23	required with R&S®ZNAxx-B161/-B163, step attenuator for port 1 required	variation of source power, for two-tone signals, attenuators at both source ports P1 and P3 are recommended
Receiver step attenuator, port 1	R&S®ZNAxx-B31		power level optimization at measurement receiver
Low-power spurious reduction, port 1	R&S®ZNAxx-B501/ R&S®ZNAxx-B511	recommended recommended	recommended with high gain DUTs (requires R&S®ZNAxx-B31; recommended: R&S®ZNAxx-B21/-B23, R&S®ZNAxx-B16, R&S®ZNAxx-B161/-163)
Options for receiver port 2 configuration			
Low-noise preamplifier, port 2	R&S®ZNAxx-B302/ R&S®ZNAxx-B312	strongly recommended	switchable internal preamplifier, selectable gain steps (requires R&S®ZNAxx-B16, R&S®ZNAxx-B32)
Receiver step attenuator, port 2	R&S®ZNAxx-B32	strongly recommended, required with R&S®ZNAxx-B302/-B312	power level optimization at measurement receiver
Direct source and receiver access	R&S®ZNAxx-B16	recommended, required with R&S®ZNAxx-B302/-B312	supports reversed coupler operation for increased receiver sensitivity

[1] xx designates the R&S®ZNA model.

PULSED MEASUREMENTS – FAST AND SIMPLE

TheR&S®ZNAoffers pulse modulators, pulse generatorsand synchronization I/Osfor analyzing active components under pulsed conditions. Typical DUTs include components and complete T/R modules for radar applications. S-parameters, input and output powers and intermodulation products can be measured without any external components to generate RF pulses and synchronize test sequences.

Internal pulse modulators and pulse generators

TheR&S®ZNA can be equippedwith one pulse modulator (R&S®ZNAxx-B4n) per port. The pulse m odulators can be controlled via external pulse sources or via the four internal pulse generators. The internal pulse generators can also be used to control external pulse modulators via the trigger board outputs. This allows special modulators for very short pulses to be integrated, for example.

Thanks to the test set architecture, once system error calibration has been performed, it remains valid for all types of pulsed measurements – versus frequency, power and time – even if the pulse duty cycle is changed. The R&S®ZNA digital section is designed so that users can configure the pulse parameters individually for each port, supported by a convenient GUI. In addition to double pulses, users can configure arbitrary pulse sequences (i.e. with arbitrary start and stop times for all pulses) in a clearly laid out table.

Measurementsversusfrequencyand power

TheR&S®ZNAsupportsthecommon measurement techniques for pulsed applications such as point-in-pulse and pulse profile m easurements. For average pulse measurements, which rely on narrow IF bandwidths, the R&S®ZNA offers highly selective IF d igital filters for the carrier signal.

Point-in-pulse measurements

Short sampling times of 32 ns are achieved for point-in-pulse measurements with IF bandwidths ranging up to 30 MHz. In addition to S-parameters, the a bsolute peak power can be determined in amplitude and intermodulation measurements. Flexible trigger functions support complex pulsed measurement scenarios and facilitate synchronization of measurements.

Pulseprofileanalysisversustimewith8 ns resolution

Equipped with the R&S®ZNA-K7 option (measurements on pulsed signals), the R&S®ZNA supports pulse profile measurements with a time resolution of 8 ns. This technique is suitable for periodic, non-periodic and one-shot pulse scenarios.

The analyzer provides simultaneous measurement of a signal on multiple receivers and for multiple wave quantities. The maximum number of wave quantities depends on the IF bandwidth and can vary e.g. between two (at 30 MHz IF bandwidth) and eight (at 1 MHz IF bandwidth). The number of wave quantities can be doubled using the R&S®ZNA-B7 data streaming memory option.

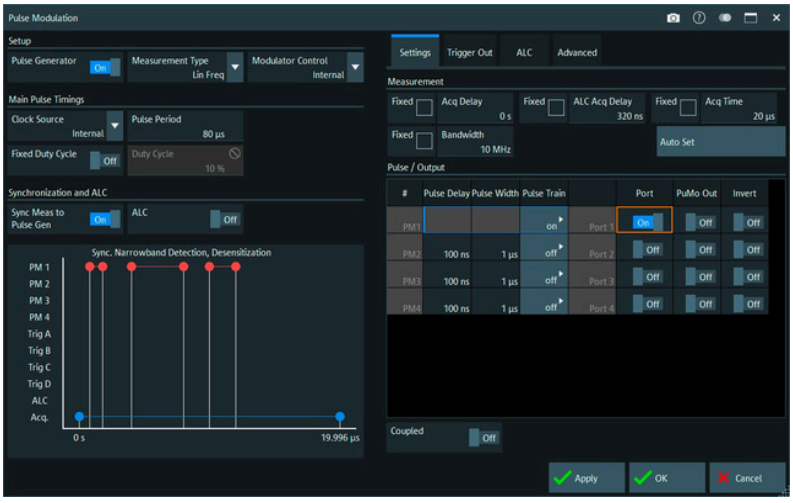
Pulsed measurements

	Functions	Options
Hardware	▶ Four internal pulse generators with 4 ns time resolution and 8 ns minimum pulse width ▶ One pulse modulator per port with 4 0 ns minimum pulse width ▶ Four trigger inputs ▶ Four trigger outputs	The internal pulse generators are enabled with one of the following options: R&S®ZNA-B91 (trigger and control I/O board) or R&S®ZNAxx-B4n (internal pulse modulator, port n). The R&S®ZNA-B7 (data streaming memory) increases the number of wave quantities that can be measured in parallel with the R&S®ZNA-K7 (measurements on pulsed signals).
Pulse profile measurements	▶ Up to 30 MHz IF bandwidth ▶ 8 ns time resolution ▶ 40 ns minimum pulse width	R&S®ZNA-K7 (measurements on pulsed signals)
Point-in-pulse measurements	40 ns minimum pulse width (30 MHz IF bandwidth)	R&S®ZNA-K17 (increased IF bandwidth 30 MHz)

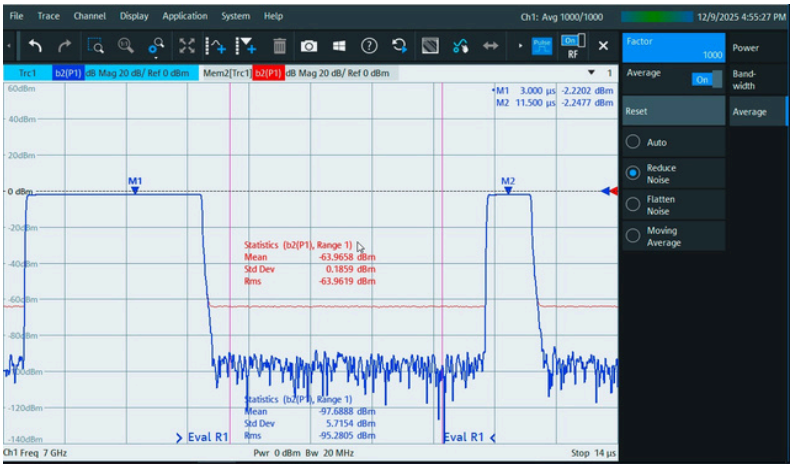
Wideband pulsed measurements with high dynamic range

With up to 30 MHz IF bandwidth, the R&S®ZNA provides point-in-pulse and pulse profile measurements on very short pulses. At the same time, the analyzer offers techniques to deliver extremely low-noise traces or achieve a very high dynamic range despite the wide measurement bandwidth.

Unique in the R&S®ZNA is a method for averaging complex values, which allows sensitivity in the order of –90 dBm to be achieved at an IF bandwidth of 10 MHz, for example.



Configuration of parameters for pulsed signal measurements



Pulse profile measurement: the wideband measurement mode enables single-shot pulse sweeps without averaging. Averaging (AVG) modes are also available to achieve either a very low trace noise or a very high dynamic range (i.e. a high pulse on/off ratio) based on vector averaging. Red trace: AVG mode "flatten noise". Blue trace: AVG mode "reduce noise".

Pulse profile measurement with arbitrary pulse sequences. Pulse sequences can be measured on multiple receivers simultaneously. Since the receivers are phase coherent, they not only measure the amplitude of a pulse but also its phase with high stability. This allows the phase deviation of a DUT to be determined very simply and reliably.

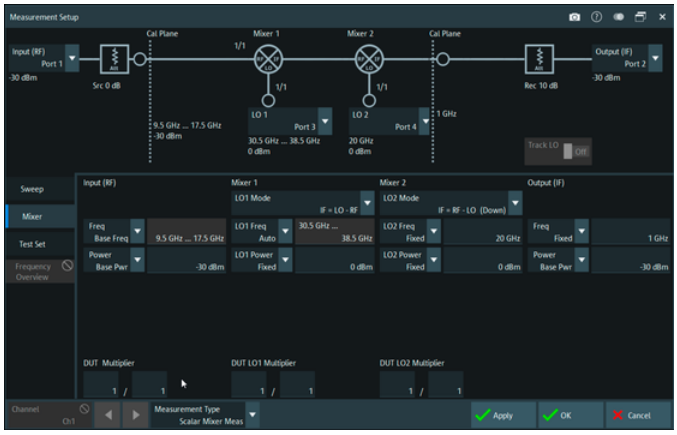
MIXER MEASUREMENTS EASIER THAN EVER

System errorcorrectedmixer phaseandgroupdelaytestswithuptofoursourcesforIMonmixersand double convertingreceivers

Fast setup and short measurement times with four internal sources and two internal LOs

The R&S®ZNA 4-port model comes with up to four internal sources. Swept LO measurements and intermodulation measurements versus frequency on mixers are performed up to ten times faster compared to setups that use external sources. With separate sources independently configurable by port, even double-converting receivers can be characterized with the R&S®ZNA single box solution with unrestricted configuration flexibility and optimum accuracy. In addition, the rear panel local oscillator (LO) output is available as a scalar LO source up to 26.5 GHz. [1] With two independent LOs for the internal receivers, the R&S®ZNA can perform s imultaneous RF/IF measurements on mixers at twice the speed of a single LO while reducing trace noise during conversion loss and group delay measurements.

DUT-centric configuration of mixer measurements

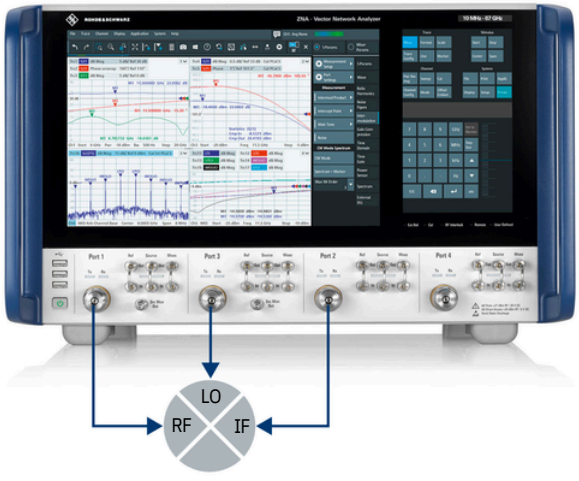


High accuracy and easy configuration thanks to R&S®SMARTerCal

The R&S®ZNA determines the return loss and conversion loss of mixers and converters with high precision using R&S®SMARTerCal, a special calibration technique that combines system error correction with absolute power level calibration. It corrects mismatch of the test ports and

[1] Requires R&S®ZNA-B8 and ZNAxx-B5 options.

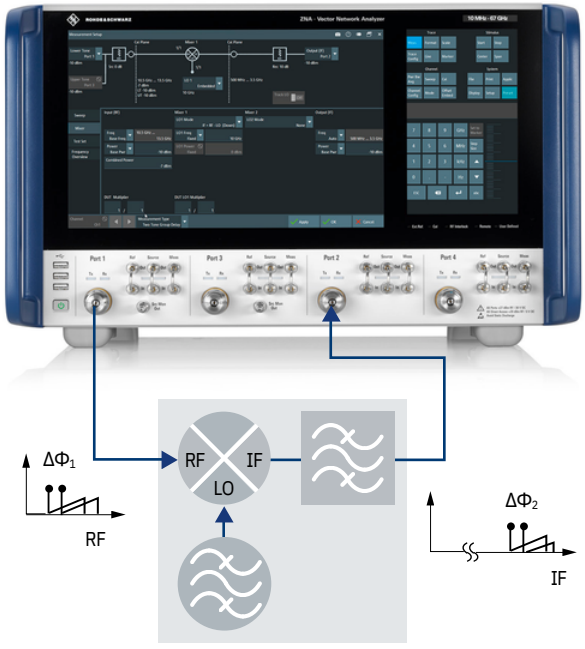
Phasemeasurementonamixer



R&S®ZN-ZCG as phase reference

R&S®ZN-ZM292 calibration mixer

Group delay measurement on a converter with two-tonesignalappliedtothemixer

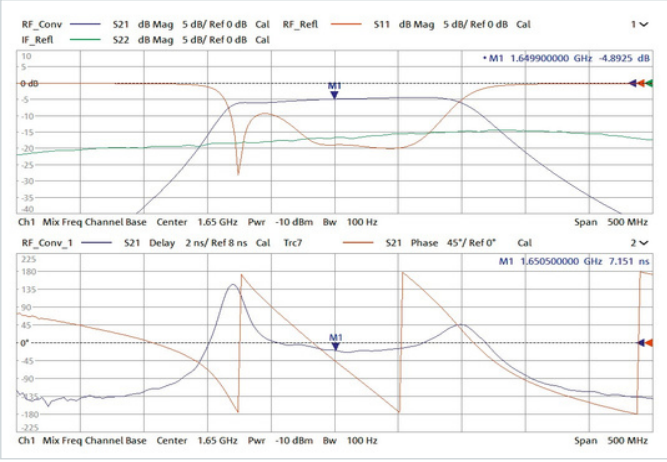


Two-tone signal obtained with R&S®ZNAxx-B213 internal combiner or an external combiner

mixer; no attenuators are needed to improve port matching. Port match correction also ensures accurate results when using the R&S®ZNA-K9 option (group delay measurements on frequency converters without LO access).

Unique approach for phase and group delay measurements on converterswithoutLOaccess

The R&S®ZNA offers a special technique for measuring group delay and relative phase on frequency converters in cases where there is no access to the internal LO or the reference frequency. The analyzer uses a two-tone signal to stimulate the DUT. From the phase difference between the carriers at the input and output, the instrument calculates the group delay and the relative phase. The f requency drift and frequency modulation of the DUT's internal LO do not affect the measurement accuracy as long as the frequency deviation lies within the analyzer's IF bandwidth used for the measurement.



Results of a converter measurement including return loss, conversion loss, phase and group delay

Phase measurements on frequency converters using vector error correction

Any receiving system requires a flat amplitude and phase response in order to transmit information smoothly and without disruptions. With the R&S®ZNA-K5 option (vector corrected converter measurements), the R&S®ZNA determines the magnitude and phase for the trans mission parameters of mixers and converters with LO access. This measurement uses the phase coherent, phase repeatable synthesizers in the R&S®ZNA in combination with a 2-port power UOSM (PUOSM) calibration. The measurement itself does not require a reference mixer for f requency back-conversion. However, using a mixer for calibration can potentially compromise the accuracy because of nonreciprocity and the band-limited usable frequency range. Using the R&S®ZN-ZCG comb generator as a phase reference is a more versatile and unambiguous solution. The measurement is quick and easy to configure. It delivers the magnitude and phase for all four system error corrected S-parameters of a frequency converter, as well as its phase and group delay and AM/AM and AM/PM conversion.

Frequency-converting measurements

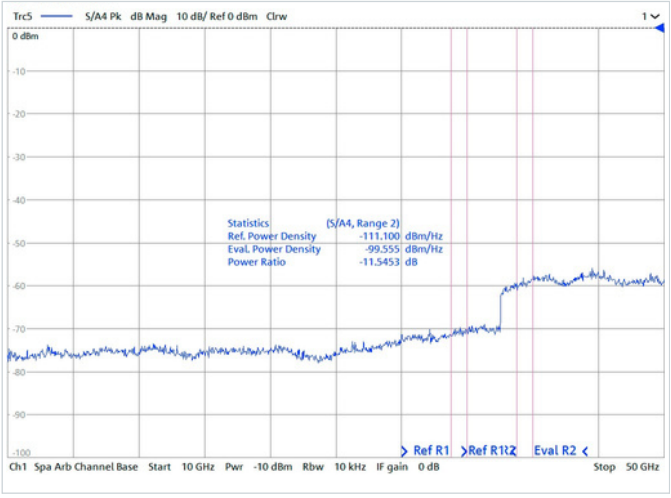
Type of measurement	Functions	Options
Scalarmixerandarbitrary frequency-converting measurements	▶Conversion loss of mixers ▶2nd source for swept LO measurements ▶3rd and 4th internal source for intermodulation measurements on mixers and receivers with two converter stages ▶ R&S®SMARTerCal for vector error corrected scalar frequency-converting measurements ▶Correction of mismatch on test ports ▶Scalar conversion loss and return loss ▶Isolation measurement: LO → RF and LO → IF ▶Intermodulation products and nth-order intercept point ▶AM/AM conversion	R&S®ZNA-K4, R&S®ZNAxx-B3n
	▶2nd internal LO source for twice the measurement speed ▶Rear panel output for internal LO signal as the 5th source (when 2nd internal LO source (R&S®ZNA-B5, up to 26.5 GHz) is installed, the 2nd LO source is made available at the output)	R&S®ZNA-B5, R&S®ZNA-B8
Vector error corrected converter measurements	▶ 2-port power UOSM (PUOSM) calibration for vector error corrected conversion loss measurements ▶Forward and reverse conversion loss (magnitude and phase) ▶Absolute/relative group delay ▶AM/AM and AM/PM conversion	R&S®ZNA-K5
	▶Calibration mixer	R&S®ZN-ZM292
Measurements on frequency converters without LO access	▶Group delay and relative phase ▶2nd internal LO for twice the measurement speed and for low trace noise	R&S®ZNA-K9, R&S®ZNA-B5

SPECTRUM ANALYSIS WITH MULTI CHANNEL VIEW

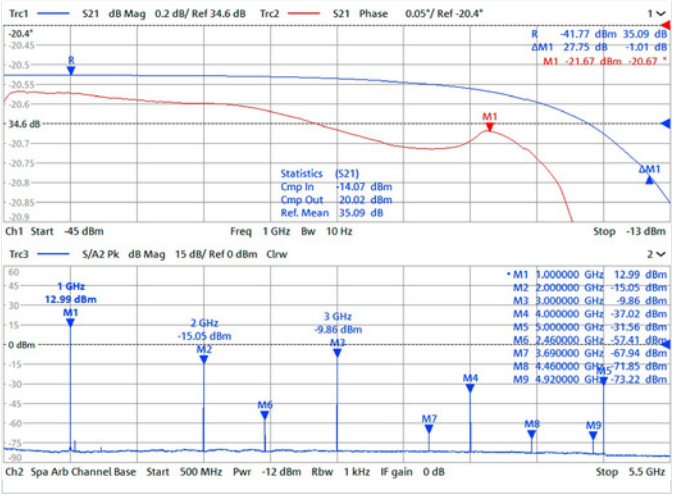
TheR&S®ZNA-K1spectrum analysis function providesa deeper insightinto aDUT'sbehavior where S-parametermeasurements versus frequency andpower arenot sufficient.

The FFT-based spectrum analysis function can be used to measure a DUT's spurious and harmonics, providing short sweep times along with high dynamic range and fine frequency resolution. It quickly detects undesired signal components (spurious) in converters and T/R modules. The marker-to-spectrum function directly gets to the root of problems in the event of unexpected S-parameter results, thus providing fast and extremely useful integrated diagnostics.

R&S®ZNA-K1 analysis functions: display of the ratio of power densities from different segments and the noise power marker function



R&S®ZNA-K1 spectrum analyzer option: amplifier magnitude and phase compression measurement (at 1 GHz, top) and corresponding harmonic and spurious spectrum



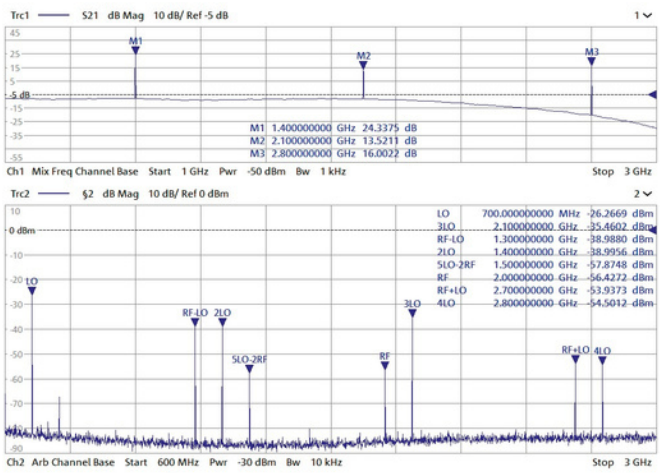
Multichannelviewofmixermeasurementswith harmonic and spurioussearch

The spectrumanalysisfunctionisavailable onall ports of the R&S®ZNA. It relies on system error correction (OSM port match correction), boosting accuracy and eliminating the influences of the test setup. In multichannel view, multiple results are displayed simultaneously. For example, an S-parameter measurement can be displayed along with the harmonics spectrum, or the conversion loss along with the spurious signals for a mixer. The R&S®ZNA-K1 spectrum analysis results can be dis- played from all measurement and reference receivers in one setup. True parallel detection and display of the results from up to four receivers significantly reduces test time.

Combined S-parameter and spectrum analysis with marker function

Whenundesired effects are detected duringS-parameter measurements, the root cause of the problem can be identified with a subsequent spectrum analysis, which is performed at the press of a button. A marker is placed on the desired frequency, and spectrum analysis around this frequency will deliver conclusive information about unwanted effects. In addition, a noise marker can be used to display the n ormalized noise power in dBm (1 Hz).

R&S®ZNA-K1 spectrum analyzer option: output spectrum of a mixer



TIME DOMAIN ANALYSIS AND SIGNAL INTEGRITY MEASUREMENTS

TheR&S®ZNA-K2 andR&S®ZNA-K20optionsprovidea wide rangeoffeaturesforin-depthinvestigationof transmissionline structures,signaltransmissionquality and in-fixture/PCBtesting.

Efficient time domain analysis with enhanced resolution

TheR&S®ZNA offers powerful time domain analysis to measure components such as test fixtures, cables and connectors in the frequency and time domain. With up to 100 000 points per trace, the R&S®ZNA can easily measure even electrically long DUTs such as cables. Using the gating function, the analyzer can locate discontinuities and analyze them in detail.

A 4-port R&S®ZNA can be used to determine the b alanced S-parameters and other quantities such as near-end and far-end crosstalk (NEXT, FEXT) on two-wire lines and differential structures. Using the Rohde & Schwarz VNA unique resolution enhancement function, the frequency range of the R&S®ZNA can be virtually extended. This yields temporal and spatial resolution substantially higher than would be expected from the DUT's and/or analyzer's frequency range.

Distance-to-fault measurements

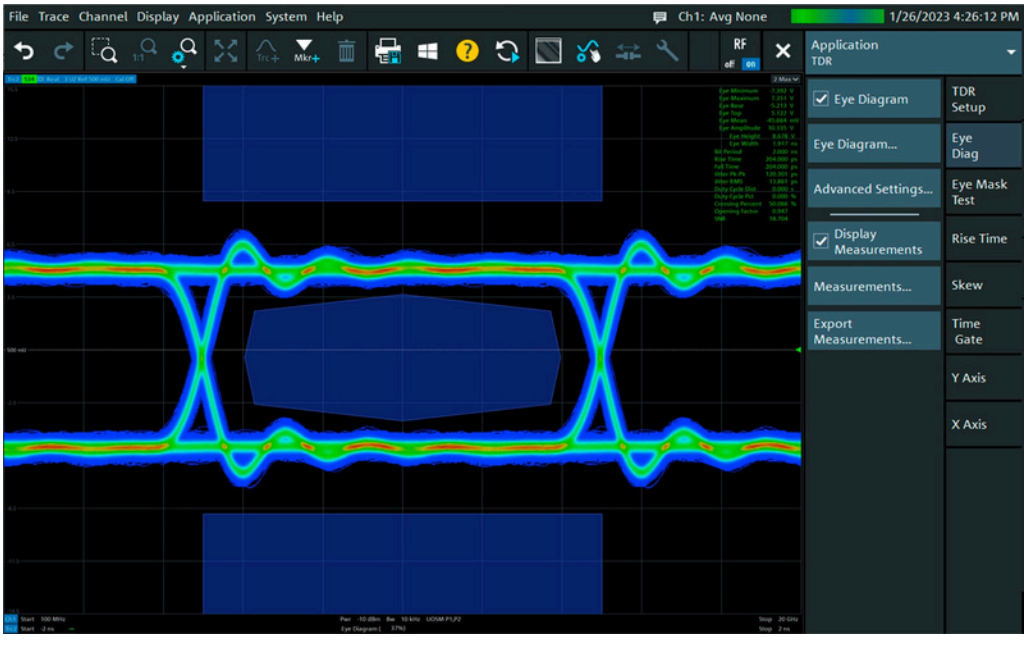
TheR&S®ZNA-K2 timedomainanalysis option has a special menu for the straightforward configuration of distance-to-fault (DTF) measurements. Discontinuities in transmission lines are directly measured and displayed versus distance using S-parameter reflection measurements.

Signal integrity at a glance with eye diagrams

Verifying the quality of a transmissionpath usually requires testing all of its components. The R&S®ZNA provides comprehensive analysis of cables and connectors in the time and frequency domain. The R&S®ZNA-K20 extended time domain analysis option makes it possible to compute, based on the S-parameters, the rise time, skew and eye diagrams for different bit patterns. The R&S®ZNA-K2 time domain analysis and R&S®ZNA-K20 extended time domain analysis options are integrated into the analyzer firmware. Eye diagrams and S-parameters versus frequency and time can be analyzed and displayed simultaneously, revealing the transmission quality at a glance.

Analysis of disturbance effects and signal quality optimization

The R&S®ZNA-K20 extended time domain analysisoption makes it possible to simulate the effects of disturbances such as jitter and noise on the eye diagram. The analyzer can also simulate the impact of correction algorithms, e.g. for predistortion at the transmitter end and for equalization at the receiver end. Plus, the R&S®ZNA-K20 option can be used to configure user-defined mask tests. These tests make it possible to verify compliance of the DUT's b ehavior with relevant standards such as USB, HDMI™ and DVI.



The R&S®ZNA-K20 option offers versatile signal integrity measurements, e.g. eye diagrams with a mask to verify compliance with relevant requirements. It can also be used to determine the trans mission characteristics of signals with jitter or noise.

PHASE-CONTROLLED SOURCE MEASUREMENTS

Phasecontrolofup to eightdigitalRF sourcesenablesmulti-pathpropagationevaluation, phased antenna array/TRMtesting, I/Q measurements, andfullyautomatedtruedifferentialmodetesting.

Innovative digital LO and RF synthesizers

Thanks to R&S®ZNA digital(DAC based) synthesizers, sources can be set to dedicated phase values. This concept is the basis for well defined stimulus phase conditions in the reference planes, and unambiguous synchronous phase measurements even with the receivers at different frequencies.

A variety of advanced measurements is supported:

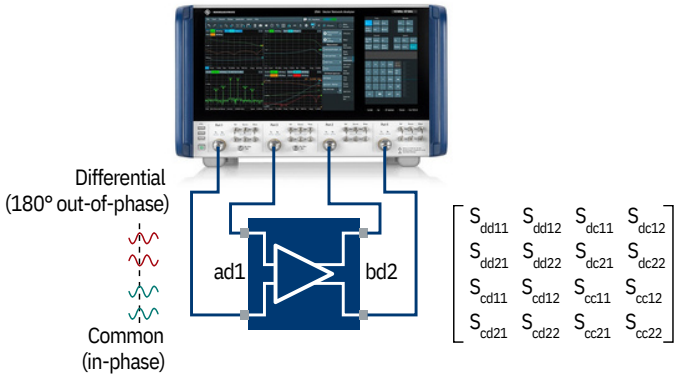
- ▶ Arbitrary phase source setting for I/Q applications
- ▶ Testing differential amplifiers under real operating conditions
- ▶ Evaluation of the phase and magnitude imbalance of balanced and multipath systems
- ▶ Tuning the radiation pattern of antenna arrays and subarrays (AESA)
- ▶ Phase tuning of all RF sources allows amplifier active load pull tests
- ▶ Getting differential or mixed-mode S-parameters of differential structures with true-mode stimulation

R&S®ZNA-K6 source-coherent mode

The R&S®ZNA-K6optionenables the phase-coherent operation of the R&S®ZNA sources. Depending on the operation mode, arbitrary phase state values can be entered for each source as required. Full n-port and level calibration ensure high-phase and level accuracy in the reference plane and minimum phase uncertainty by port match correction.

True differential test mode

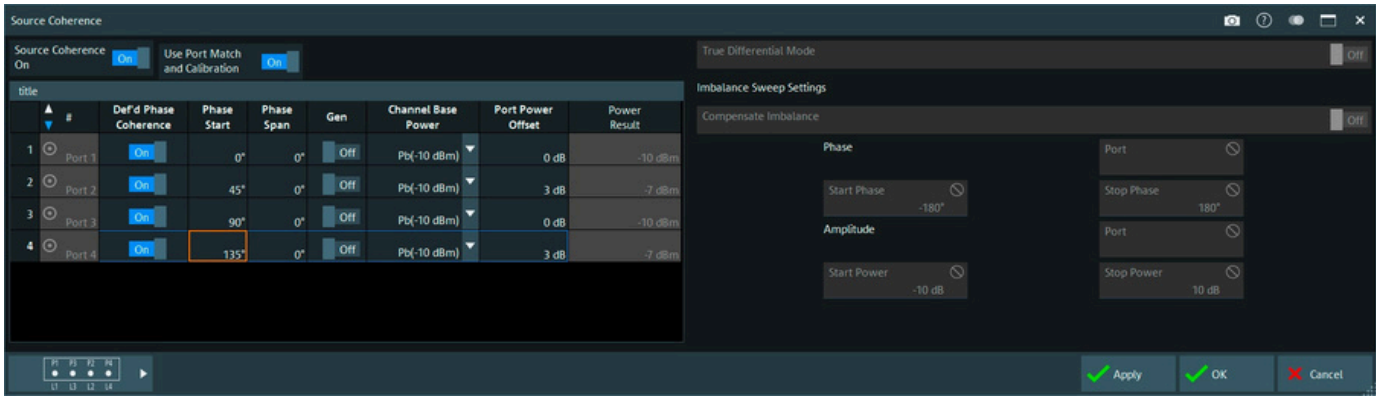
The true differential test mode benefits from the source-coherence capability of the RF sources. Alternating stimulus with two 0° in-phase and 180° out-of phase signals provides all elements of the complete mixed mode S-parameter matrix.



R&S®ZNA-K61 true differential mode testing

Differential amplifiers may respond differently depending on whether they are tested with sequential single-ended or true differential mode stimulation. The use of baluns involves severe limitations: no common mode or mode conversion evaluation, band limitation, limited phase symmetry. R&S®ZNA-K61 overcomes this issue, with true-mode stimulation, and fully automated test execution, applying true common and differential signals, measuring the DUT response. As a result, all elements of the mixed-mode S-parameter matrix are available. In addition, imbalance sweeps for the phase (phase sweep at fixed frequency and power) or magnitude (magnitude sweep at fixed frequency and phase) are supported.

GUI for entering dedicated port specific values for phase and power. In automatic true differential measurement mode, users can enter parameters for phase and magnitude imbalance sweeps.



Balanced structures as well as used and unused ports are defined at a keystroke. Predefined topologies are completed with a tab offering free user configurations.

Definition of differential structures at a keystroke

Todefinethebalanced structure andbalanced/single-ended ports of the DUT, a clear GUI allows to select the desired topology from predefined settings at a keystroke. Additional configurations are done in just a few mouse clicks.

Application: active load pull

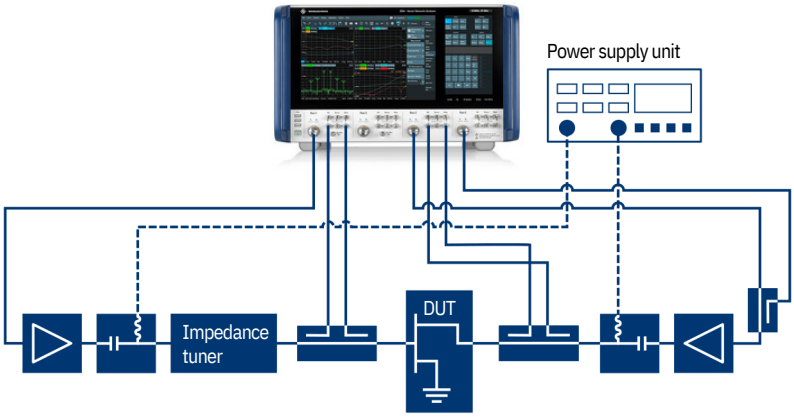
Tuning the magnitudeandphase of all sources makes it possible to electronically tune the source at the amplifier output in parallel to the RF stimulation. This enables electronic output impedance tuning (reflection coefficient at the amplifier output). Fast tuning lets users evaluate amplifier gain, matching and efficiency in a short test time. Combining the R&S®ZNA with systems from partner companies enables even more comprehensive characterization based on hybrid load pull tuning, e.g. for noise parameter tests.

Application: differential I/Q test

With up tofour phasecoherent sources, devices with I/Q input/output can flexibly be characterized. The sources can be set to arbitrary phase and magnitude values, to apply 90°/180° I/Q signals, or to perform imbalanced sweeps.

R&S®ZNA based source/load pull system

Themultiplesourceconceptofthe R&S®ZNAsupportsthe RF signal plus DUT reverse stimulation and active impedance tuning, offering active source/load pull testing in a compact single-box solution.



APPLICATIONS

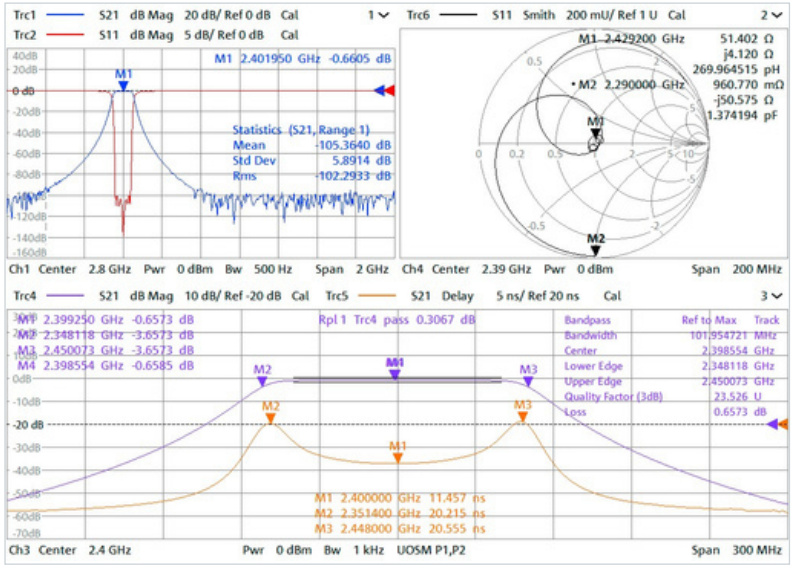
PASSIVE DEVICE CHARACTERIZATION

Withan exceptionaldynamicrange andversatile measurement andanalysisfeaturestheR&S®ZNAis prepared forthecharacterizationof challenging passivedevices.

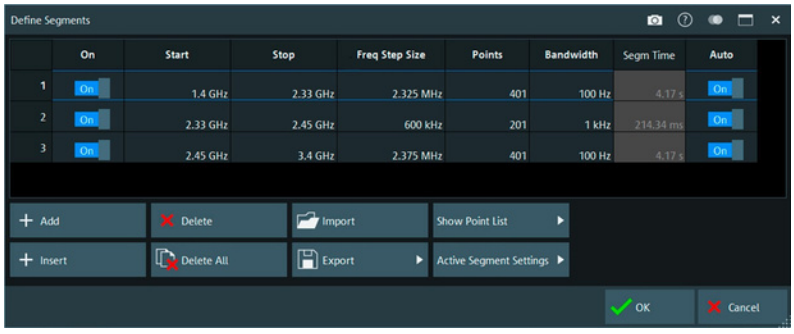
The task

Evenpassive device characterization may require a wide feature set and challenging instrument specifications:

- ▶ Get maximum throughput in production
- ▶ Minimize sweep time by finding the golden optimum between accuracy and sweep speed
- ▶ Short measurement times despite high dynamic range
- ▶ Comprehensive online analysis, pass/fail
- ▶ Measurement system and handler synchronization



The online analysis functions of the R&S®ZNA enable comprehensive DUT certification without external data analysis. Preloaded setups are represented by tabs and setup swap is done at the click of a mouse. Distributed over several screens (setups), a multitude of results is clearly displayed, and the R&S®ZNA is quickly ready for a new DUT.



The segmented sweep allows definition of different test parameters for subsegments of a sweep, e.g. high power and narrow IFBW in the stop band of a filter for high dynamic, and a wider IFBW and narrow frequency grid for short test time and high resolution in the pass band.

R&S®ZNA benefits for passive device characterization with challenging DUTs

Function/feature	Benefits
Up to 170 dB dynamic range [1]	Provides high accuracy even with high-blocking filters
Segmented sweep (number of points, power, IFBW, other, for subsegments of a sweep)	Ensures the optimum balance of accuracy, test time, and RF performance depending on the DUT properties
Filter/marker online analysis, limit lines/ripple test	Offers a comprehensive evaluation and certification of the DUT
Multiple parallel preloaded setups	▶ Reconfigure the measurement task at a mouse click, no time-consuming setup reload required ▶ Smart control and clear display of numerous measurement parameters, even for multiple DUTs
Speed improvement (R&S®ZNA-K66 option)	Significanly faster group delay measurements for multiband passive component testing with large point counts

[1] Applies in the lower frequency range, options required, data confidence level: "measured".

HIGH-POWER AMPLIFIER AND LNA TESTING

The R&S®ZNA enables high-power amplifier and LNA testing under real operating conditions.

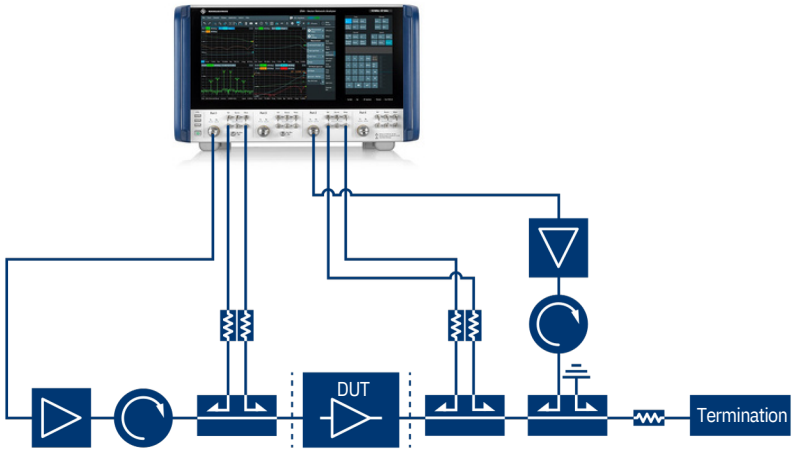
The task

The variety of test parameters and test setups for amplifier characterization calls for a wide range of personalities and configuration f lexibility of the test equipment:

- ▶ Handling of very high power levels, external high-power test setups
- ▶ Ensuring stable and drift-independent power levels
- ▶ Multiple tones for intermodulation tests, even on mixers
- ▶ Measurements under pulsed conditions
- ▶ Active device with differential structures
- ▶ Evaluation of noise figure and noise parameters of unmatched DUTs under variable matching conditions

Direct channel access option

Withthe directchannelaccessoption, as well as source and receiver step attenuators, the R&S®ZNA supports external high-power test setups (with external preamplifier in forward and reverse directions, high-power couplers, attenuators and circulators)



R&S®ZNAbenefitsforhigh-poweramplifierandLNA testing

Function/feature	Benefits
Up to 4 internal, independently configurable sources, internal combiner	Intermodulation testing (without external sources) at full speed and configuration flexibility, even in combination with mixers
Unique power sweep range of 100 dB, attenuators, compression point personality	Compression evaluation over wide power ranges, including real-time compression point (CP) evaluation
Combination of sweep modes	Magnitude and frequency offset swept measurements, AM/AM and AM/PM tests
Digital automatic level control (ALC), with arbitrary reference signal access	Accurate and stable stimulation power even with external preamplifiers
Control of external power supply units	Power added efficiency (PAE) test
Four integrated pulse modulators, pulse profile test option	High-power point-in-pulse test, pulse profile analysis
True differential mode	Reliable characterization of differential amplifiers without external baluns, mode-conversion parameters and phase/magnitude imbalance sweeps
Noise figure personality and preamplifier	Noise figure tests without reconnection and noise source
Source phase control, partner system integration (Focus Microwaves and Maury Microwave): active harmonic load pull	▶On-wafer chip characterization ▶Impedance tuning for unmatched amplifiers ▶Active harmonic load pull testing (with electronic and hybrid impedance tuning)

RECEIVER AND LNB C HARACTERIZATION

TheR&S®ZNAenablesreliable(high-gain)receiverandLNBcharacterizationwith a simple setup.

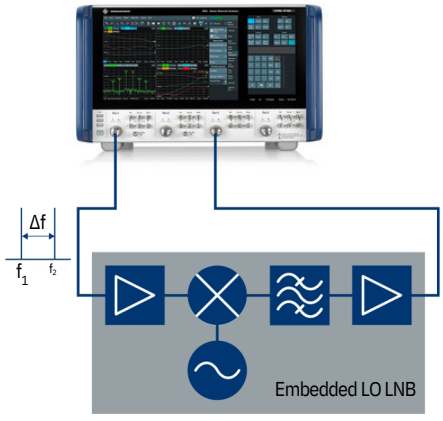
The task

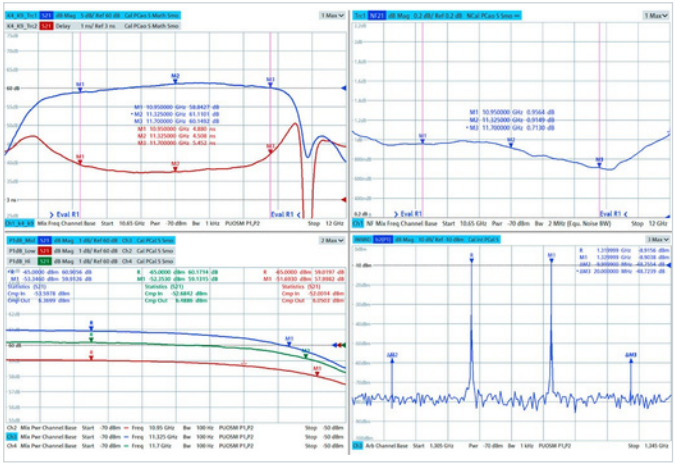
Thereare several special aspects which make high-gain converter testing challenging:

- ▶ Requirement of several sources for intermodulation test with dual LO devices (with LO access)
- ▶ IF frequency offset from an internal oscillating LO
- ▶ Mixer group delay test without LO access
- ▶ Noise figure test on mixers
- ▶ High accuracy, low traces noise, and short test time despite of very low stimulation power

EmbeddedLOconverter test setup

With dedicatedfunctions,suchas LOtracking and two-tone based group delay measurement, R&S®ZNA enables a reliable and comprehensive characterization of frequency converters without access to the internal local oscillator





Example result screen of embedded LO converter testing: conversion gain, group delay, noise figure, compression, intermodulation

R&S®ZNA benefits for receiver and LNB characterization

Function/feature	Benefits
Up to 4 internal, independently configurable sources, internal combiner	Intermodulation testing of converters with (accessible) dual LO conversion
Unique solution for embedded LO converter group delay test (R&S®ZNA-K9) and LO tracking function	Measure converter group delay (GD) reliable despite of s ignificant DUT LO drift, and w ithout access to the internal LO
Flexible frequency conversion capability and mixer phase measurement option	Phase measurements on converters, LO crosstalk, etc.
Selectable reference signal access for the stimulation source signal	Get a sufficient strong reference signal despite of extremely low stimulation power for low trace noise
Port 1 isolation amplifier	Get extremely low spur free stimulation signal
Noise figure test options, combined with mixer test setup	Comprising characterization without reconnection, including noise figure test without a noise source
2-port R&S®ZNA with 2 sources and internal combiner	Get intermodulation, group delay and noise figure (NF) from embedded LO converters with a 2-port R&S®ZNA

T/R MODULE AND RADAR AESA TESTING

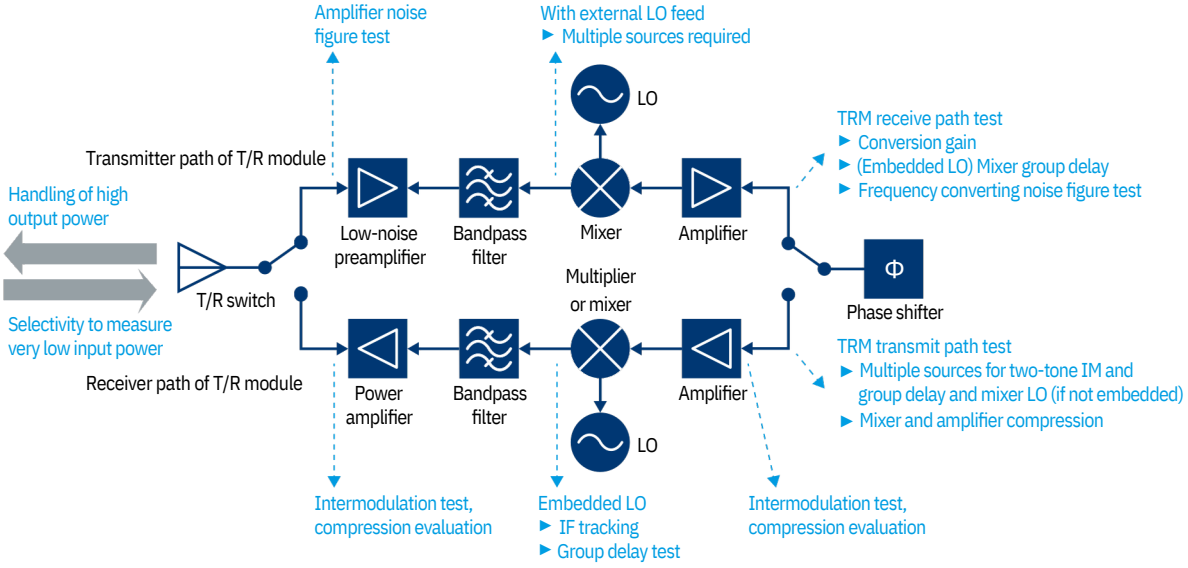
The R&S®ZNA enablescomprehensivetransmit/receive(T/R)moduleandradaractiveelectronically scanned array (AESA) testingwitha singleconnection.

The task

T/Rmodules combine both transmitting and r eceiving s ubmodules, which requires the following of measurement capabilities:

- ▶ Features for amplifier testing: compression point (CP), intermodulation (IM), noise figure (NF)
- ▶ Handling of very high and very low power
- ▶ Multiple frequency conversion with embedded mixer LO
- ▶ Multiple phase-controlled sources
- ▶ Enhanced DUT control and system support

Typical elements of a radar T/R module, highlighting the challenges for the VNA to characterize single components and the entire module



R&S®ZNA benefits for T/R module and radar AESA testing

Function/feature	Benefits
Up to 4 internal sources with flexible sweep mode configuration and internal combiner	▶ Receiver intermodulation and compression testing ▶ Frequency-converting modules with LO access: support of dual LO design ▶ Group delay testing of embedded LO devices
Phase-coherent source control	▶ Phase measurements on converters ▶ Radiation pattern testing with beamforming submodules
Multichannel spectrum analysis option	Spur search with all R&S®ZNA receivers, effective with up to 4 receivers in parallel
Enhanced trigger and pulsed I/O	DUT synchronization and control for DUT phase and power settings with synchronized measurement
2-port R&S®ZNA with two sources and options for high/low power and noise figure tests	Comprising characterization of a 2-port T/R module with an R&S®ZNA with two test ports (IM, CP, embedded LO converter group delay)

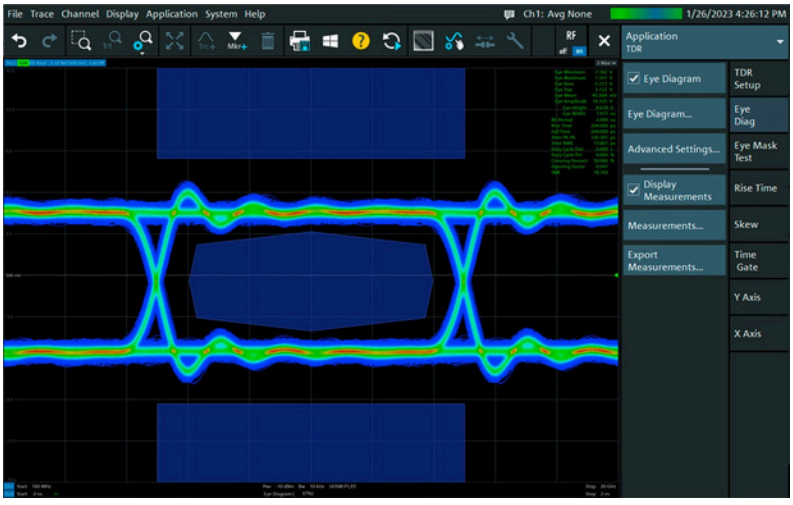
SIGNAL INTEGRITY TESTING

With the enhancedTDR option anddeembedding personalities,the R&S®ZNA enables evaluation of the signal transmission quality oflines,cablesand PCBstructures, including correction techniques for in-fixture, and on-PCB testing.

The task

Increasing data volumes and bit rates demand precise characterization of cables, transm ission lines and PCB structures at ever increasing frequency ranges. Simply testing in time and frequency provides reliable characterization, but in-fixture and on-board mounted DUTs call for additional deembedding functionalities:

- ▶ Combination of enhanced time domain analysis results (TDR) and S-parameters
- ▶ In-fixture calibration techniques
- ▶ Techniques for fixture and PCB structure characterization and deembedding
- ▶ Flexible single and multiport configuration



Eye diagram mask test with synthetic signal predistortion

R&S®ZNA benefits for signal integrity testing

Function/feature	Benefits
TDR with various filter and frequency grid configurations, including distance-to-fault test and synthetic frequency extension (R&S®ZNA-K2 option)	▶ Optimization of TDR measurement for optimal resolution and band-limited DUTs ▶ Easy cable distortion analysis ▶ TDR results at a higher resolution than given by DUT band-limitation and the R&S®ZNA frequency range
Enhanced TDR/eye diagram, including bit stream and modulation s imulation (R&S®ZNA-K20 option)	Simulated eye diagram analysis for transmission characterization without real pulsed signals
Enhanced in-fixture calibration techniques: TRL/LRL, TNA, TRM, TSM, TOM (R&S®ZNA-K210, -K220, -K230, -K231 options)	Direct in-fixture calibration with custom calibration standards (partially unknown and reduced number of standards)
Enhanced deembedding personalities based on custom tools from partner company	Test coupon based in-fixture and PCB structure characterization including deembedding
SNP assistant (R&S®ZNA-K100 option)	Guided connection steps to derive multi-port S-parameter (.snp) files with a 2-port or 4-port VNA
Speed improvement (R&S®ZNA-K66 option)	Fast sweep mode shortens measurement time, increasing production throughput and enabling full characterization of high-port-count DUTs without compromising accuracy

ANTENNAMEASUREMENTS– THE PERFECTFIT

With its widerangeofhardwareand software functions, theR&S®ZNA canbeusedas thehigh-performing core in near-field,far-field,compact rangeand radarcross section(RCS) antennatest systems.

Fast antenna characterization

Theoutstanding receiversensitivity of the R&S®ZNA, in combination with fast synthesizers, speeds up antenna characterization even when measuring very low signal levels. The analyzer's high sensitivity, low trace noise, wide range of selectable IF bandwidths and various averaging functions help to find the optimum balance of short test times and high accuracy.

For test systems employing external mixers, the R&S®ZNA allows flexible, independent configuration of the frequencies and powers for all sources and receivers, as well as direct IF signal path access with selectable IF frequencies.

Measurements on antenna arrays

The R&S®ZNA canprovidestimulus signals from up to four sources, making it possible to measure the directional pattern of electronically controlled antenna arrays. In addition, the internal LO signal (standard LO or second internal LO source up to 26.5 GHz) is a ccessible on the rear panel. This means that up to five sources are available for feeding antenna arrays or for external up/down conversion.

Featuring a true p arallel receiver a rchitecture with up to eight receivers, the analyzer reliably measures the amplitude and phase of up to eight input signals. The R&S®ZNA can therefore be used as a compact multi channel receiver to design antenna arrays and sub arrays for MIMO mobile communications systems, or it can be used as part of antenna test systems employing horizontally and/or vertically polarized antennas as well as reference receiving antennas.

R&S®ZNA benefits for antenna measurements

Function/feature	Benefits
High receiver sensitivity up to –151 dBm (1 Hz) (typ., with direct receiver access)	Short measurement times
Inputs for direct access to IF signal paths, selectable IF frequencies with 1 GHz bandwidth	Use in high-frequency test systems with external mixers Adaptation to optimal IF of test system
Identical RF design of all receivers	Identical characteristics of measurement and reference channels
Up to 5 internal sources [1)]	▶ Multi-antenna stimulation ▶ LO signals for external mixers
Configuration of arbitrary frequency-converting measurements	Universal support for external mixers and mmWave systems
Reverse frequency sweep	▶ Alternating movement of positioner (CW, CCW in azimuth, as well as movement in elevation) ▶ Spherical near-field measurements
Extended trigger functionality	▶ Optimal synchronization of positioner, clock generators, etc. ▶ Simple and flexible system integration
Truly parallel receiver architecture	▶ Measurements with up to eight receivers (no multiplexing) ▶ Simultaneous measurements of multiple antenna polarizations (horizontal/vertical) and antenna arrays (MIMO)
mmWave converters	Measurements in mmWave range

[1)] Up to four RF sources plus LO source (on rear panel output, 2nd internal LO source up to 26.5 GHz).

RCS measurements and measurements on complete RX modules

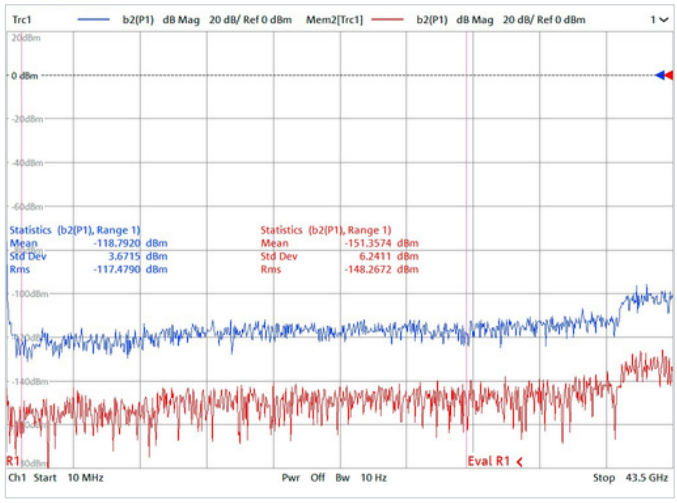
The R&S®ZNAcan perform RCS measurements and measurements on complete RX modules without any external test equipment. With up to four signal sources, up to four internal pulse modulators and generators, up to eight true receivers, and the ability to sample up to 16 wave quantities in parallel, the R&S®ZNA provides signal generation and multichannel measurements in a single, compact platform (see also "Pulsed measurements – fast and s imple", page 38).

Data streaming mode

The R&S®ZNA-K28 data streaming mode option allows continuous sweep recording and writing to a circular buffer. The controlled timing feature ensures constant measurement times for every sweep point and gapless recording. Thus, the user-defined number of sweeps and traces is merged to one common data set.

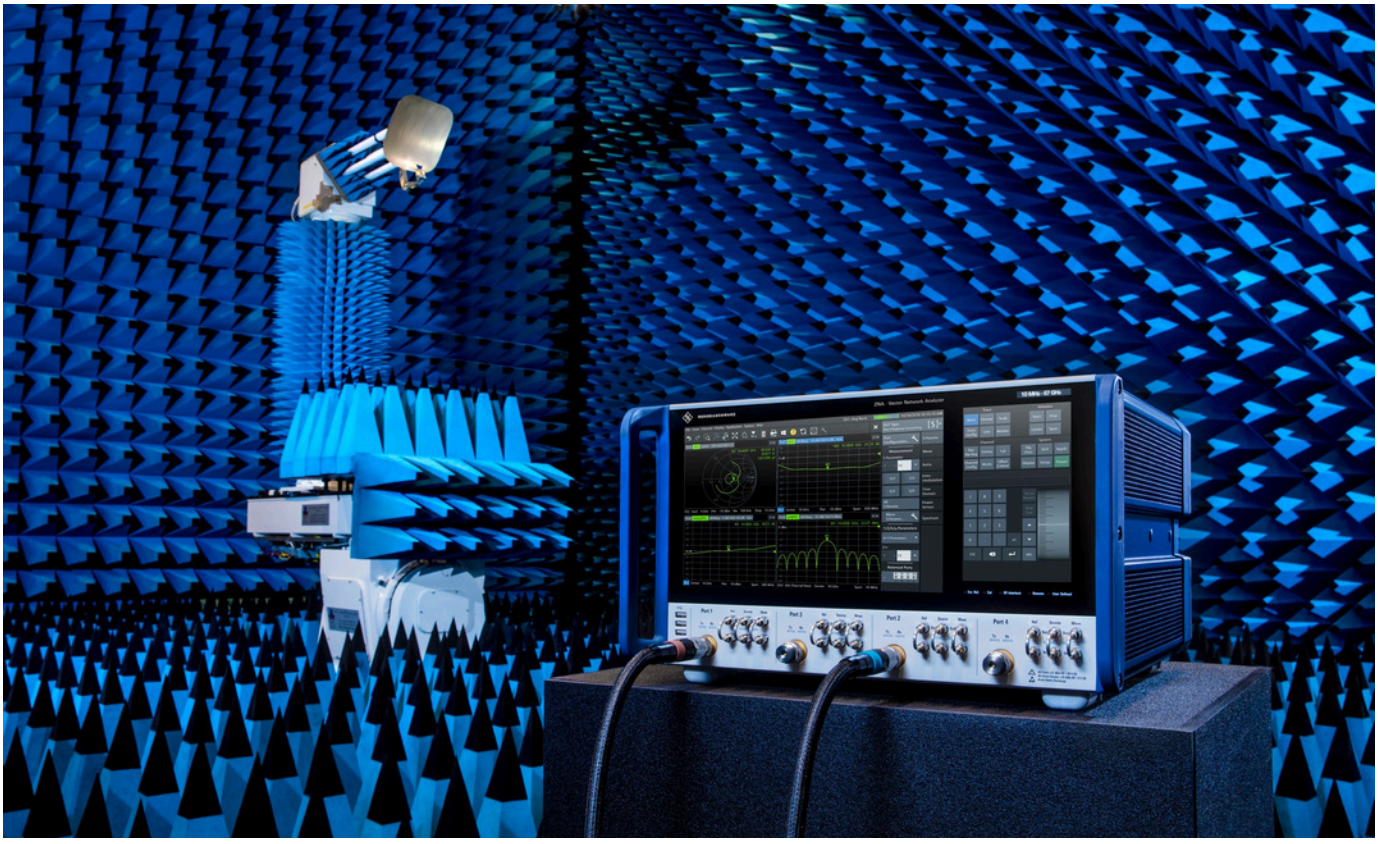
Partner system integration

Withsystemsfrom Rohde & Schwarz and its partner companies, Rohde & Schwarz provides complete free-field, far-field and RCS test systems.



The sensitivity of the R&S®ZNA26/R&S®ZNA43 receivers can reach –150 dBm (lower frequency end, typical, at 1 Hz IFBW, direct channel access/reversed coupler, receiver step attenuator in 0 dB position). The sensitivity of the b1 and b2 receivers is increased further by using the R&S®ZNAxx-B302 and R&S®ZNAxx-B501 preamplifiers.

The R&S®ZNA forms the powerful core in antenna test systems



mmWave MEASUREMENTS

Frequencybands in the mmWaveand terahertzranges are used inmany applications in the mobile communications, automotive, security, semiconductor and fundamental research sectors. Automotive radar at 77 GHz/79 GHz, mobile communications in the 5G frequency bands, and radars and sensors up to and beyond 100 GHz all require the characterization of active and passive components such as filters, amplifiers, mixers and antennas.

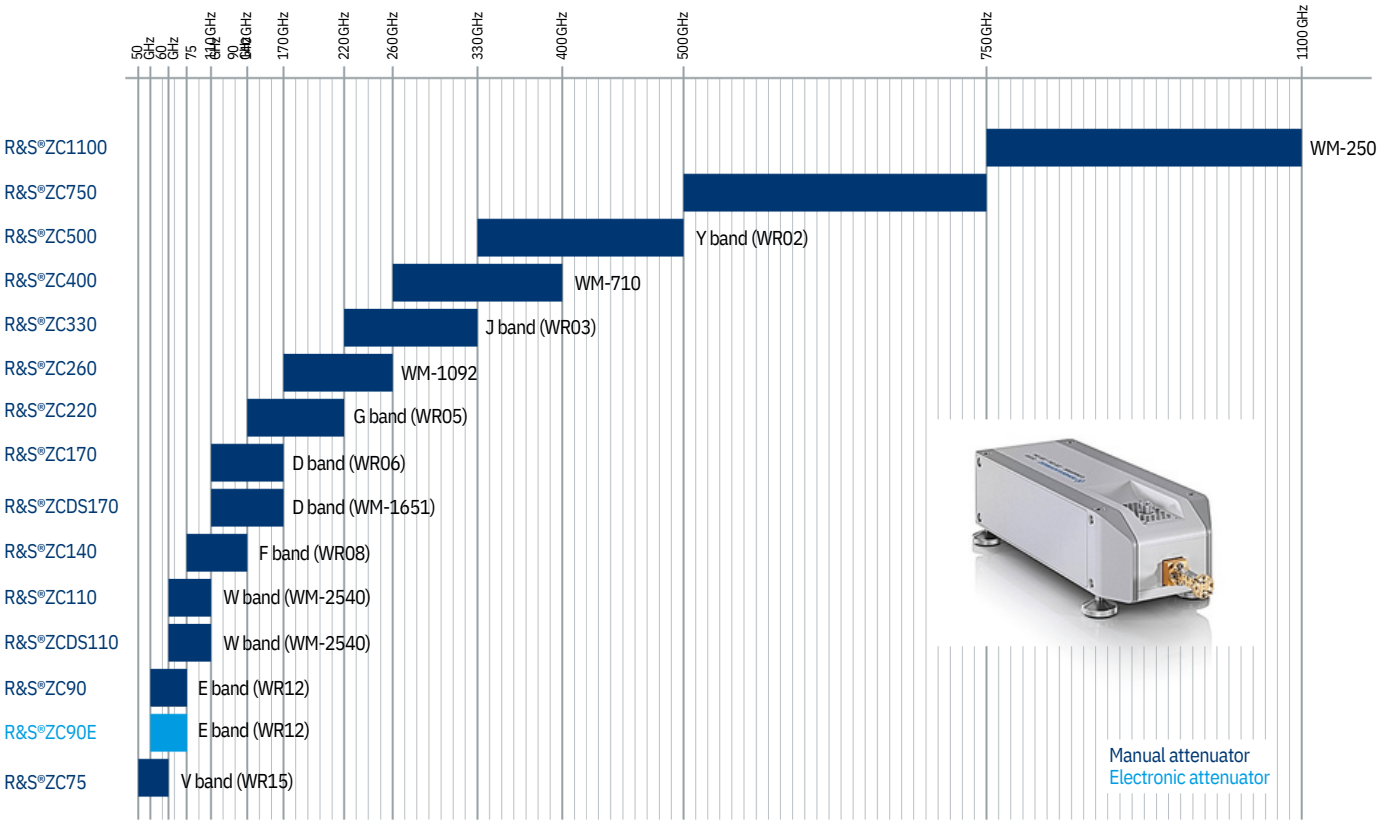
Frequencyextensionintotheterahertzrange

The R&S®ZVA-Zxxx and R&S®ZCxxx mmWave c onverters extend the R&S®ZNA frequency range up to 1.1 THz. Many applications, in particular on-wafer component characterization and antenna measurements, call for frequency converters with high output powers. The high operating frequencies of the components under test lead to significant losses in waveguides, probe tips and along the transmission path. The Rohde & Schwarz frequency converters feature high output powers and excellent dynamic range. They can be used to characterize active and passive DUTs.

Compact systems with dedicated options

The optional R&S®ZNA-B8 mmWave converter LO output makes the analyzer's internal LO signal available at the rear panel. The signal comes from the standard LO or, when a second internal LO is installed, from the 2nd LO. It provides up to +25 dBm output power, which is sufficient to feed up to four frequency converters connected to the R&S®ZNA. Configuration of the R&S®ZNA-B8 output for use with mmWave converters requires the R&S®ZNA-K8 option (mmWave converter support). The output power can be automatically calibrated to compensate for any losses introduced by cables and splitters. With the R&S®ZNA-B26 direct IF access option installed, the converters' measurement and reference signals are directly fed to the analyzer's IF path. The R&S®ZNAxx-B16 direct source and receiver access option can be used alternatively.

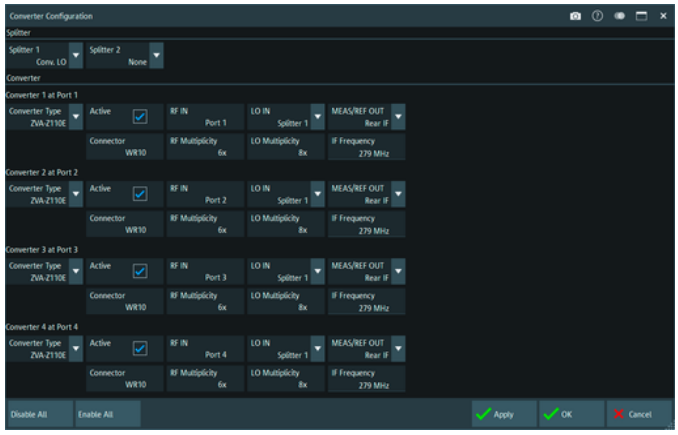
OverviewofR&S®ZCxxx mmWaveconverters



SpecialfeaturesofR&S®ZVA-ZxxxandR&S®ZCxxx mmWave converters

- ▶ Highoutput powersand wide dynamic range
- ▶ Easy configuration via straightforward dialog
- ▶ Multiport measurements with up to four converters without an external source
- ▶ Variable output power (manual adjustment with screw and/or control of output power by varying the input power)
- ▶ Amplifier characterization, power sweeps, compression point measurements
- ▶ R&S®ZNA-K1 spectrum analysis support in the mmWave range
- ▶ Phase coherence stimulation
- ▶ Absolute level calibration using power test heads from Rohde & Schwarz and Eriksson PM5/PM5B
- ▶ Automatic level control (ALC) usable in the mmWave range
- ▶ Pulsed measurements
- ▶ On-wafer component characterization, integration into MPI Corporation and FormFactor wafer prober systems
- ▶ Waveguide calibration kits (with or without sliding match) for all frequency bands of the converters
- ▶ High time and temperature stability
- ▶ Frequency-converting measurements [1)]
- ▶ Integration in (active) load pull test systems from Focus Microwaves and Maury Microwave
- ▶ Supported by mmWave material test systems from company SwissTo12
- ▶ Intermodulation measurements with R&S®ZCDS110 and R&S®ZCDS170 dual source mmWave converters

[1)] Converters with different frequency ranges can be used; external source(s) may be required, depending on setup/configuration.

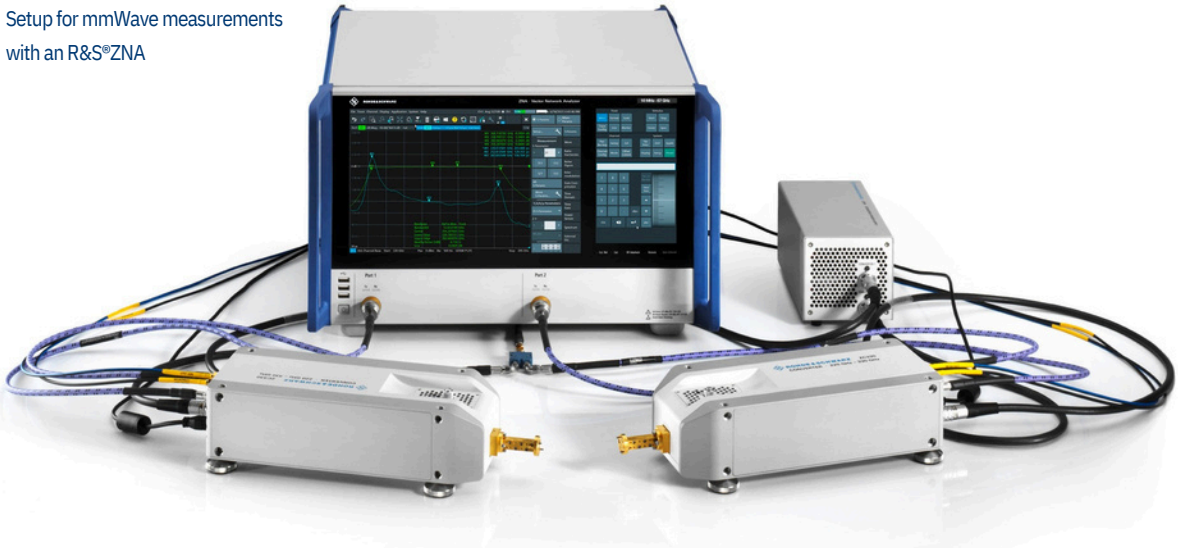


Software configuration

Software configuration

- ▶ Straightforward dialog for configuring 1-port to 4-port mmWave converter setups
- ▶ Menu-based selection of R&S®ZVA-Zxxx converter(s); automatic detection of R&S®ZCxxx converter(s)
- ▶ Configuration of customer's mmWave converters
- ▶ Support of Rohde & Schwarz and Erickson power sensors for absolute power level calibration up to 1.1 THz
- ▶ Configuration of frequency-converting measurements [1)]

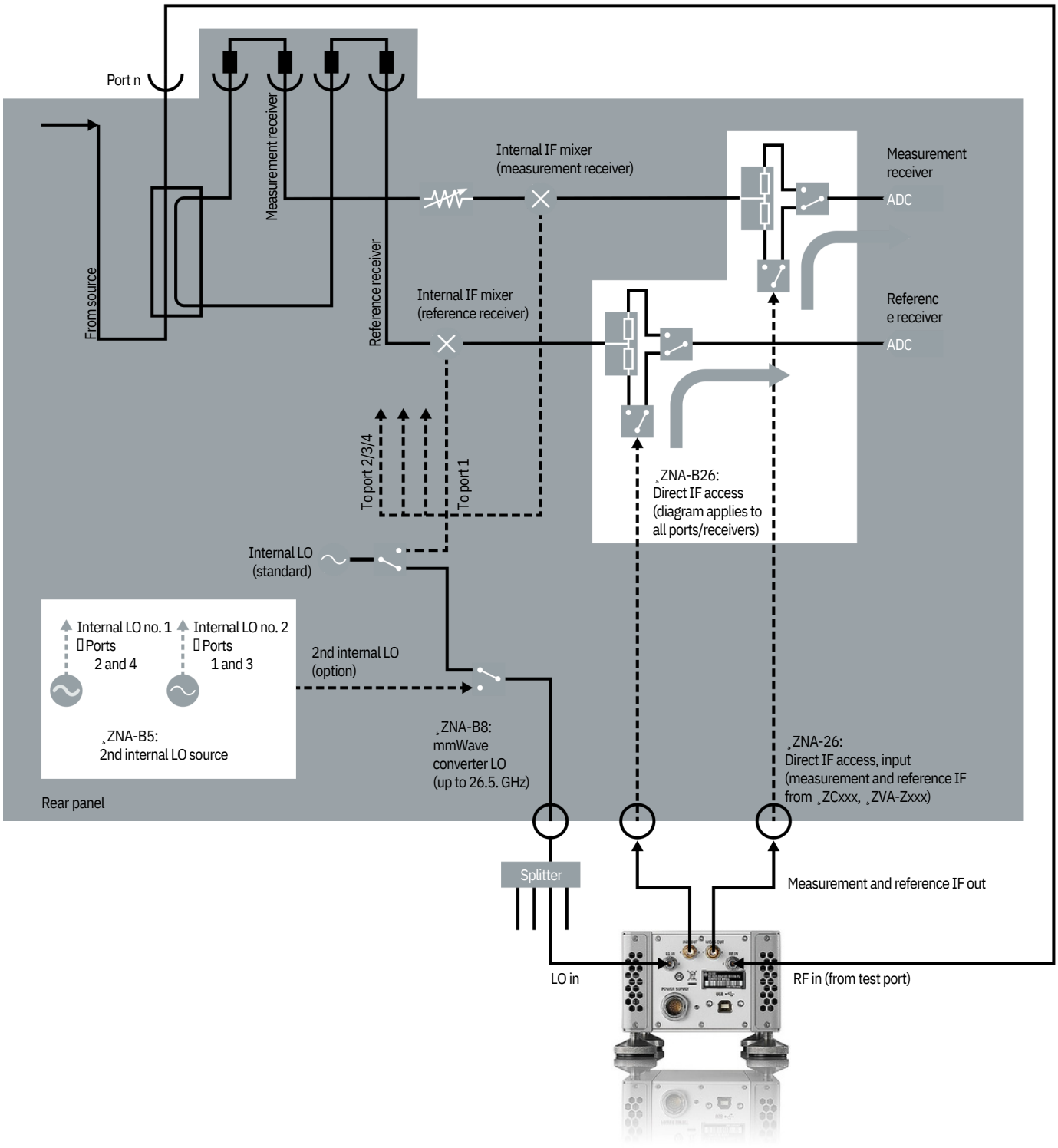
Setup for mmWave measurements with an R&S®ZNA



Hardware configuration

- Rear panel LO output up to +25 dBm (R&S®ZNA-B8 mmWave converter LO option) reliably provides converters with desired power even with long cables and LO splitters
- Use of direct IF inputs on R&S®ZNA rear panel
- Direct IF inputs with 1 GHz bandwidth for flexible integration of customer's mmWave converters
- Compact test setups: 2/4-port mmWave converter setups with 2/4-port R&S®ZNA, no external source or adapter box required

Hardwareconfigurationfor mmWavemeasurements



4-port R&S®ZNA67EXT single sweep system up to 110 GHz

R&S®ZNA67EXT vector network analyzer system: singlesweepsystemupto110 GHz

Someapplications,suchason-wafer transistorcharacterization, require a single sweep from 10 MHz to 110 GHz with only one probe contact. The R&S®ZNA67EXT s ystem is an extension of the R&S®ZNA67 with converters and diplexers to allow a s ingle sweep from 10 MHz to 110 GHz with a c oaxial 1 mm connector.

The system is available with two or four 1 mm test ports. The 2-port system can be configured with a 2-port R&S®ZNA67 or a 4-port R&S®ZNA67 base unit, whereas the 4-port system always requires a 4-port R&S®ZNA67 base unit.

All systems are available in standard power configuration not subject to export control and high-power systems subject to export control.

TVAC TESTING AND SATELLITE TVAC TESTING

TheR&S®ZNAprovidesreliableresultswiththermalvacuumchamber(TVAC)testingandsatellite TVAC testing.

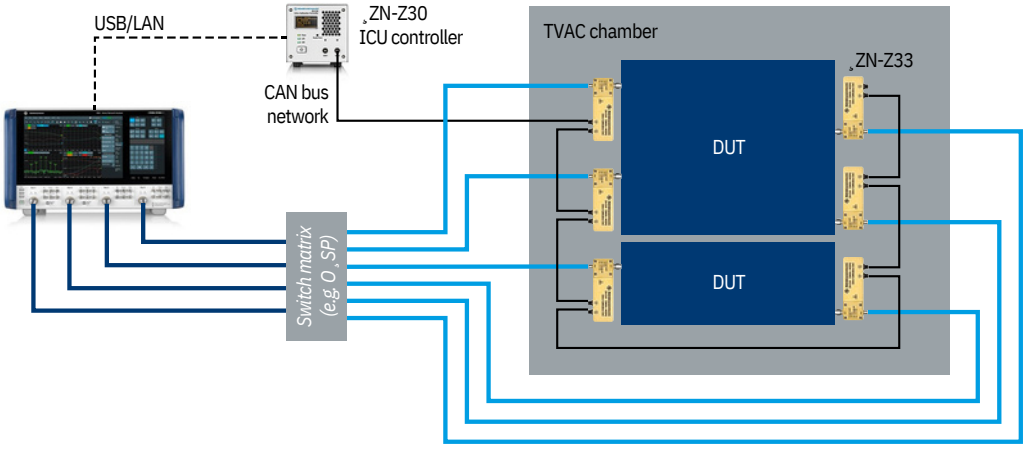
A VNA system error correction (SEC) requires the connection of single calibration standards or an automatic calibration unit, but for subsequent measurement, the calibration equipment is disconnected and the DUT is connected instead. However, there are mainly two application cases where this procedure is not applicable: TVAC testing/satellite TVAC testing and multiport testing/production testing.

TVAC testing/satellite TVAC testing: After evacuation and at every change of temperature, the RF response of test set components inside the chamber is potentially changed. However, there is no access to the reference planes in the TVAC chamber to connect calibration equipment for a recalibration.

Multiport testing/production testing: Especially in cases where there is a combination of both multiport DUT in production and numerous cables that are continuously moved, frequent recalibration is required. The R&S®ZN-Z3xx inline calibration units are designed to stay permanently in the reference plane, thus enabling frequent remote-controlled recalibration at a keystroke, without the need to access the test setup.

Schematic TVAC setup with Rohde & Schwarz inline calibration units

The inlinecalibrationunits (ICU) are connectedto the DUTinside thechamber.Recalibrationateach change of temperature and path switching is controlled by the R&S®ZNA and the R&S®ZN-Z30 ICU controller.



R&S®ZNA benefits for TVAC testing/satellite TVAC testing

Function/feature	Benefits
Firmware integration	▶ Base calibration and recalibration included in the R&S®SMARTerCal environment ▶ Calibration update in TVAC chambers and with multiport setups in a few keystrokes
CAN bus network structure	▶ A single controller supports up to 48 modules (corresponds to 4 8 c onne c tions) ▶ Distances up to 20 m possible ▶ Plug & play configuration
Extended feature range: power calibration (base calibration only), deembedding, mixer measurements	▶ Get accurate stimulation power even in TVAC chamber testing ▶ Correct for auxiliary components (adapters, splitter) ▶ Converter testing in TVAC

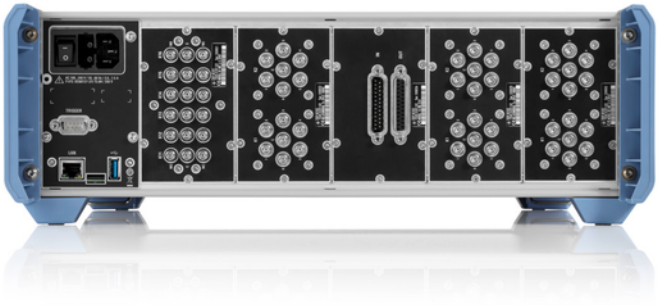
MULTIPORT EXTENSIONS

With predefined portgroups and USB autodetection, multiport systems basedon R&S®ZN-Z8x switch matrices are configuredin a few key strokes. RF switch andcontrol tasks arequick and easy to perform with the modular R&S®OSP open switch and control platform. The latest R&S®OSP generation comes with an extended range of modules, allowing an even wider variety of RF wiring configurations.

R&S®ZN-Z84 switch matrix, plug & play controlled (with 24 ports optional)

R&S®OSP220 and R&S®OSP230 open switch and control platforms

Rear view of the R&S®OSP320



A wide range of applications – from passive distributions to antenna beamforming arrays – requires multiport extension modules. The R&S®ZNA supports plug & play solutions as well as individually configurable switch matrices:

- The R&S®ZN-Z8x switch matrices are configurable with 6 to 24 ports and full crossbar, ranging up to 8 GHz/20 GHz
- The R&S®OSP open switch and control platform offers a freely configurable framework. Switch modules ranging from basic single pole, double throw (SPDT) to multiple I/O design can be combined in one rack frame and configured by channel as required.

R&S®ZNAbenefitsusingmultiportextensions

Function/feature	Benefits
R&S®ZN-Z8x switch matrices with up to 8 GHz (6 to 24 ports) or 20 GHz (6 and 12 ports)	Easy plug & play configuration of predefined sets of port groups
R&S®OSP open switch and control platform with up to 6 switch m odules, combination of single pole, double throw (SPDT) and t hroughout multiple I/O design	▶Application-specific combination of switch modules ▶Active multiport device testing up to 67 GHz

ORDERING INFORMATION

Designation	Type	Frequency range Order No.		Remarks
Base units				
Vector network analyzer, 2 ports, 26.5 GHz, 3.5 mm connectors	R&S®ZNA26	10 MHz to 26.5 GHz	1332.4500.22	
Vector network analyzer, 4 ports, 26.5 GHz, 3.5 mm connectors	R&S®ZNA26	10 MHz to 26.5 GHz	1332.4500.24	
Vector network analyzer, 2 ports, 43.5 GHz, 2.92 mm connectors	R&S®ZNA43	10 MHz to 43.5 GHz	1332.4500.42	
Vector network analyzer, 2 ports, 43.5 GHz, 2.4 mm connectors	R&S®ZNA43	10 MHz to 43.5 GHz	1332.4500.43	
Vector network analyzer, 4 ports, 43.5 GHz, 2.92 mm connectors	R&S®ZNA43	10 MHz to 43.5 GHz	1332.4500.44	
Vector network analyzer, 4 ports, 43.5 GHz, 2.4 mm connectors	R&S®ZNA43	10 MHz to 43.5 GHz	1332.4500.45	
Vector network analyzer, 2 ports, 50 GHz, 2.4 mm connectors	R&S®ZNA50	10 MHz to 50 GHz	1332.4500.52	
Vector network analyzer, 4 ports, 50 GHz, 2.4 mm connectors	R&S®ZNA50	10 MHz to 50 GHz	1332.4500.54	
Vector network analyzer, 2 ports, 67 GHz, 1.85 mm connectors	R&S®ZNA67	10 MHz to 67 GHz	1332.4500.62	
Vector network analyzer, 4 ports, 67 GHz, 1.85 mm connectors	R&S®ZNA67	10 MHz to 67 GHz	1332.4500.64	
Options				
Direct source and receiver access, for R&S®ZNA26 (2 ports)	R&S®ZNA26-B16	100 kHz to 26.5 GHz	1332.4581.22	
Direct source and receiver access, for R&S®ZNA26 (4 ports)	R&S®ZNA26-B16	100 kHz to 26.5 GHz	1332.4581.24	
Direct source and receiver access, for R&S®ZNA43 (2 ports)	R&S®ZNA43-B16	100 kHz to 43.5 GHz	1332.4581.42	
Direct source and receiver access, for R&S®ZNA43 (4 ports)	R&S®ZNA43-B16	100 kHz to 43.5 GHz	1332.4581.44	
Direct source and receiver access, for R&S®ZNA50 (2 ports)	R&S®ZNA50-B16	10 MHz to 50 GHz	1332.4581.52	
Direct source and receiver access, for R&S®ZNA50 (4 ports)	R&S®ZNA50-B16	10 MHz to 50 GHz	1332.4581.54	
Direct source and receiver access, for R&S®ZNA67 (2 ports)	R&S®ZNA67-B16	10 MHz to 67 GHz	1332.4581.62	
Direct source and receiver access, for R&S®ZNA67 (4 ports)	R&S®ZNA67-B16	10 MHz to 67 GHz	1332.4581.64	
Source step attenuator, port n, for R&S®ZNA26	R&S®ZNA26-B2n	10 MHz to 26.5 GHz	1332.4630.2n	n designates the port number (1/2/3/4) n designates the port number (1/2/3/4) n designates the port number (1/2/3/4) n designates the port number (1/2/3/4) n designates the port number (1/2/3/4) n designates the port number (1/2/3/4) n designates the port number (1/2/3/4) n designates the port number (1/2/3/4) n designates the port number (1/2/3/4) n designates the port number (1/2/3/4) n designates the port number (1/2/3/4) n designates the port number (1/2/3/4) n designates the port number (1/2/3/4)
Source step attenuator, port n, for R&S®ZNA43	R&S®ZNA43-B2n	10 MHz to 43.5 GHz	1332.4646.2n	
Source step attenuator, port n, for R&S®ZNA50	R&S®ZNA50-B2n	10 MHz to 50 GHz	1332.5007.2n	
Source step attenuator, port n, for R&S®ZNA67	R&S®ZNA67-B2n	10 MHz to 67 GHz	1332.5013.2n	
Receiver step attenuator, port n, for R&S®ZNA26	R&S®ZNA26-B3n	10 MHz to 26.5 GHz	1332.4700.3n	
Receiver step attenuator, port n, for R&S®ZNA43	R&S®ZNA43-B3n	10 MHz to 43.5 GHz	1332.4717.3n	
Receiver step attenuator, port n, for R&S®ZNA50	R&S®ZNA50-B3n	10 MHz to 50 GHz	1332.5020.3n	
Receiver step attenuator, port n, for R&S®ZNA67	R&S®ZNA67-B3n	10 MHz to 67 GHz	1332.5036.3n	
Internal pulse modulator, port n, for R&S®ZNA26	R&S®ZNA26-B4n	10 MHz to 26.5 GHz	1332.4775.4n	
Internal pulse modulator, port n, for R&S®ZNA43	R&S®ZNA43-B4n	10 MHz to 43.5 GHz	1332.4781.4n	
Internal pulse modulator, port n, for R&S®ZNA50	R&S®ZNA50-B4n	10 MHz to 50 GHz	1332.5088.4n	
Internal pulse modulator, port n, for R&S®ZNA67	R&S®ZNA67-B4n	10 MHz to 67 GHz	1332.5094.4n	
Internal pulse modulator, port n, for R&S®ZNA50	R&S®ZNA26-B3	10 MHz to 26.5 GHz	1332.4523.02	
Internal pulse modulator, port n, for R&S®ZNA67	R&S®ZNA43-B3	10 MHz to 43.5 GHz	1332.4617.02	
3rd and 4th internal source, for R&S®ZNA26 (4 ports)	R&S®ZNA50-B3	10 MHz to 50 GHz	1332.4981.02	
3rd and 4th internal source, for R&S®ZNA43 (4 ports)	R&S®ZNA67-B3	10 MHz to 67 GHz	1332.4998.02	
3rd and 4th internal source, for R&S®ZNA50 (4 ports)				
3rd and 4th internal source, for R&S®ZNA67 (4 ports)				

Designation	Type	Frequency range	Order No.	Remarks
2nd LO and RF source, for R&S®ZNA26 (2 ports)	R&S®ZNA26-B52	10 MHz to 26.5 GHz	1332.6503.0	
2nd LO and RF source, for R&S®ZNA40 (2 ports)	R&S®ZNA40-B52	10 MHz to 43.5 GHz	2	
2nd LO and RF source, for R&S®ZNA50 (2 ports)	R&S®ZNA50-B52	10 MHz to 50 GHz	1332.6510.0	
2nd LO and RF source, for R&S®ZNA67 (2 ports)	R&S®ZNA67-B52	10 MHz to 67 GHz	2	
Direct source monitor access, port 1, for R&S®ZNA26	R&S®ZNA26-B161	10 MHz to 26.5 GHz	1332.6526.0	2-port and 4-port R&S®ZNA, requires R&S ®ZN A 26 - B16, R&S ®ZN A 26 - B21
Direct source monitor access, port 1 and port 3, for R&S®ZNA26	R&S®ZNA26-B163	10 MHz to 26.5 GHz	2 1332.6823.03	4 -por t R&S®ZNA , requires R&S®ZNA 26 - B16, R&S®ZNA 26 - B21, R&S®ZNA 26 - B23
Direct source monitor access, port 1, for R&S®ZNA43	R&S®ZNA43-B161	10 MHz to 43.5 GHz	2 1332.4303.51	2-port and 4-port R&S®ZNA, requires R&S®ZNA43-B16, R&S®ZNA43-B21
Direct source monitor access, port 1 and port 3, for R&S®ZNA43 [2)]	R&S®ZNA43-B163	10 MHz to 43.5 GHz	1332.4823.5 1332.4830.53 1	4 -por t R&S®ZNA , requires R&S®ZNA43-B16, R&S®ZNA43-B21, R&S®ZNA43-B23
Direct source monitor access, port 1, for R&S®ZNA50	R&S®ZNA50-B161	10 MHz to 50 GHz	1332.5107.51	2-port and 4-port R&S®ZNA, requires R&S®ZNA50 -B16, R&S®ZNA50 -B21
Direct source monitor access, port 1 and port 3, for R&S®ZNA50	R&S®ZNA50-B163	10 MHz to 50 GHz	1332.5107.53	4 -por t R&S®ZNA , requires R&S®ZNA50-B16, R&S®ZNA50-B21, R&S®ZNA50 -B23
Direct source monitor access, port 1, for R&S®ZNA67	R&S®ZNA67-B161	10 MHz to 67 GHz	1332.5113.51	2-por t and 4 -por t R&S®ZNA , requires R&S®ZNA67-B16, R&S®ZNA67-B21
Direct source monitor access, port 1 and port 3, for R&S®ZNA67	R&S®ZNA67-B163	10 MHz to 67 GHz	1332.5113.53	4 -por t R&S®ZNA , requires R&S®ZNA67-B16, R&S®ZNA67-B21, R&S®ZNA67-B23
Low-noise preamplifier at receiver, port 2, for R&S®ZNA26	R&S®ZNA26-B302	10 MHz to 26.5 GHz	1332.4752.12	re quires R&S®ZNA 26 - B 32 and R&S®ZNA 26 - B16
Low-noise preamplifier at receiver, port 2, for R&S®ZNA43	R&S®ZNA43-B302	10 MHz to 43 GHz	1332.4769.12	re quire s R&S ® Z N A 4 3 - B 32 an d R&S®ZNA43-B16
Low noise preamplifier at receiver, port 2, for R&S®ZNA50	R&S®ZNA50-B302	10 MHz to 50 GHz	1332.4798.12	requires R&S®ZNA50 -B32 and R&S®ZNA50-B16; export restricted, combinable with R&S®ZNA-K1
Low noise preamplifier at receiver, port 2, for R&S®ZNA50	R&S®ZNA50-B312	10 MHz to 50 GHz	1332.5659.02	requires R&S®ZNA50 -B32 and R&S®ZNA50-B16; not export restricted, not combinable with R&S®ZNA-K1
Low noise preamplifier at receiver, port 2, for R&S®ZNA67	R&S®ZNA67-B302	10 MHz to 67 GHz	1332.4817.12	requires R&S®ZNA67-B32 and R&S®ZNA67-B16; export restricted, combinable with R&S®ZNA-K1
Low noise preamplifier at receiver, port 2, for R&S®ZNA67	R&S®ZNA67-B312	10 MHz to 67 GHz	1332.5665.02	requires R&S®ZNA67-B32 and R&S®ZNA67-B16; not export restricted, not combinable with R&S®ZNA-K1
Low-power spurious reduction, port 1, for R&S®ZNA26	R&S®ZNA26-B501	10 MHz to 26.5 GHz	1332.5220.11	re quire s R&S ®ZN A 26 - B 31
Low-power spurious reduction, port 1, for R&S®ZNA43	R&S®ZNA43-B501	10 MHz to 43.5 GHz	1332.5236.11	requires R&S®ZNA43-B31
Low power spurious reduction, port 1, for R&S®ZNA50	R&S®ZNA50-B501	10 MHz to 50 GHz	1332.5242.11	re quire s R&S ®ZN A5 0 - B 31
Low power spurious reduction, port 1, for R&S®ZNA50	R&S®ZNA50-B511	10 MHz to 50 GHz	1332.5671.02	re quire s R&S ®ZN A5 0 - B 31
Low power spurious reduction, port 1, for R&S®ZNA67	R&S®ZNA67-B501	10 MHz to 67 GHz	1332.5259.11	requires R&S®ZNA67-B31
Low power spurious reduction, port 1, for R&S®ZNA67	R&S®ZNA67-B511	10 MHz to 67 GHz	1332.5688.02	requires R&S®ZNA67-B31
Internal combiner, port 1 and port 2, for R&S®ZNA26 (2 ports)	R&S®ZNA26-B212	10 MHz to 26.5 GHz	1332.5265.02	2-port R&S®ZNA only; requires R&S®ZNA 26 - B52 and R&S®ZNA 26 - B21
Internal combiner, port 1 and port 2, for R&S®ZNA43 (2 ports)	R&S®ZNA43-B212	10 MHz to 43.5 GHz	1332.5271.02	2-port R&S®ZNA only; requires R&S®ZNA 4 3 - B52 and R&S®ZNA 4 3 - B21
Internal combiner, port 1 and port 2, for R&S®ZNA50 (2 ports)	R&S®ZNA50-B212	10 MHz to 50 GHz	1332.5288.02	2-port R&S®ZNA only; requires R&S®ZNA50 -B52 and R&S®ZNA50 -B21
Internal combiner, port 1 and port 2, for R&S®ZNA67 (2 ports)	R&S®ZNA67-B212	10 MHz to 67 GHz	1332.5294.02	2-port R&S®ZNA only; requires R&S®ZNA67-B52 and R&S®ZNA67-B21
Internal combiner, port 1 and port 3, for R&S®ZNA26 (4 ports)	R&S®ZNA26-B213	10 MHz to 26.5 GHz	1332.4846.13	4 - por t R&S®ZNA only; re quires R&S®ZNA 26 - B21 and R&S®ZNA 26 - B23
Internal combiner, port 1 and port 3, for R&S®ZNA43 (4 ports)	R&S®ZNA43-B213	10 MHz to 43.5 GHz	1332.4869.13	4 - por t R&S®ZNA only; re quires R&S®ZNA 4 3 - B21 and R&S®ZNA 4 3 - B23
Internal combiner, port 1 and port 3, for R&S®ZNA50 (4 ports)	R&S®ZNA50-B213	10 MHz to 50 GHz	1332.5042.13	4 - por t R&S®ZNA only; re quires R&S®ZNA50 -B21 and R&S®ZNA50 -B23
Internal combiner, port 1 and port 3, for R&S®ZNA67 (4 ports)	R&S®ZNA67-B213	10 MHz to 67 GHz	1332.5065.13	4 - por t R&S®ZNA only; re quires R&S®ZNA67-B21 and R&S®ZNA67-B23
Precision frequency reference (OCXO)	R&S®ZNA-B4		1332.4530.02	
Data streaming memory	R&S®ZNA-B5		1332.4675.02	
2nd internal LO source for R&S®ZNA (4 ports)	R&S®ZNA-B7		1332.4546.02	increases the number of receivers that can be used in parallel for pulse profile measure ments (depending on IF bandwidth)

Designation	Type	Frequency range	Order No.	Remarks
mmWave converter LO	R&S®ZNA-B8	10 MHz to 26.5 GHz	1332.4652.02	flexibleconfiguration for all mmWave converters, mixers, etc.
mmWave extender LO output	R&S®ZNA67-B80	10 MHz to 26.5 GHz	1332.5836.02	supports mmWave converters only from 110 GHz to 117 GHz to meet export restrictions to dedicated regions
Metrology configuration, for R&S®ZNA26 (2 ports)	R&S®ZNA26-B10		1332.4698.22	
Metrology configuration, for R&S®ZNA26 (4 ports)	R&S®ZNA26-B10		1332.4698.24	
Metrology configuration, for R&S®ZNA43 (2 ports)	R&S®ZNA43-B10		1332.4698.42	2.92 mm connectors
Metrology configuration, for R&S®ZNA43 (2 ports)	R&S®ZNA43-B10		1332.4698.43	2.4 mm c o nn e c to r s
Metrology configuration, for R&S®ZNA43 (4 ports)	R&S®ZNA43-B10		1332.4698.44	2.92 mm connectors
Metrology configuration, for R&S®ZNA43 (4 ports)	R&S®ZNA43-B10		1332.4698.45	2.4 mm c o nn e c to r s
Metrology configuration, for R&S®ZNA50 (2 ports)	R&S®ZNA50-B10		1332.4698.52	
Metrology configuration, for R&S®ZNA50 (4 ports)	R&S®ZNA67-B10		1332.4698.54	
Metrology configuration, for R&S®ZNA67 (2 ports)	R&S®ZNA67-B10		1332.4698.62	
Metrology configuration, for R&S®ZNA67 (4 ports)	R&S®ZNA67-B10		1332.4698.64	
Device control	R&S®ZNA-B12		1332.4552.02	
RFFE GPIO interface	R&S®ZNA-B15		1332.4575.02	
RFFE GPIO interface, including voltage/current measurement	R&S®ZNA-B15		1332.4575.03	
Direct IF access	R&S®ZNA-B26		1332.4598.02	
Trigger and control I/O board	R&S®ZNA-B91		1332.4800.02	
Spectrum analyzer mode	R&S®ZNA-K1		1332.5320.02	
Time domain analysis (TDR)	R&S®ZNA-K2		1332.5336.02	
Extended time domain analysis (including eye diagram)	R&S®ZNA-K20		1332.4746.02	requires R&S®ZNA-K2
Continuous data recording	R&S®ZNA-K28		1332.5613.02	
Scalar mixer and arbitrary frequency-converting measurements	R&S®ZNA-K4		1332.5342.02	
Vector corrected converter measurements (without reference mixer and phase reference)	R&S®ZNA-K5		1332.5359.02	requires R&S®ZNA-K4
Phase coherent source control	R&S®ZNA-K6		1332.5413.02	
True differential mode Speed improvement	R&S®ZNA-K61		1332.5442.02	requires R&S®ZNA-K6
Measurements on pulsed signals Increased	R&S®ZNA-K66		1332.5820.02	
IF bandwidth 30 MHz mmWave converter support	R&S®ZNA-K7		1332.5371.02	requires R&S®ZNA-K17
	R&S®ZNA-K17		1332.5459.02	
	R&S®ZNA-K8		1332.5388.02	
Group delay measurements on frequency c onverters without LO access	R&S®ZNA-K9		1332.5394.02	requires R&S®ZNA-K4 and options to generate a two-tone signal; ▶ 2-port R&S®ZNA: R&S®ZNAxx-B52, R&S®ZNA x x- B21, R&S®ZNA x x- B212 ▶ 4-port R&S®ZNA: R&S®ZNAxx-B16 and R&S®ZNAxx-Z9 cable set or R&S®ZNA x x- B213 internal combiner, R&S®ZNAxx-B21/-B23
1 mHz frequency resolution Noise figure	R&S®ZNA-K19		1332.5513.0	
measurements Uncertainty analysis Uncertainty	R&S®ZNA-K30		2	
analysis, preinstalled Security write protection	R&S®ZNA-K50		1332.5465.0	METAS tool user provided
SNP assistant EaZy deembedding (EZD) In-situ	R&S®ZNA-		2	METAS tool preinstalled
deembedding (ISD)	K50P		1332.5542.0	
Smart fixture deembedding (SFD) Delta-	R&S®ZNA-K51		2	
L PCB characterization Health and utilization	R&S®ZNA-		1332.5594.0	
monitoring service (HUMS)	K100		2	
Windows 11 24H2 upgrade kit	R&S®ZNA-		1332.5559.0	
mmWave converters	K210		2	
Converter WR15, one module	R&S®ZNA-		1338.9327.0	
Converter WR12, one module	K220		2	upgrade to IPS15, including SSD
Converter WR12, one module Converter WM-	R&S®ZNA-		1339.3897.0	converters require R&S®ZNA-K8
2540, one module Converter WM-	R&S®ZC75	50 GHz to 75 GHz	2323.8259.0	
2540	R&S®ZC90	60 GHz to 90 GHz	2339.3900.0	
Converter WM-2032, one module	R&S®ZC90E	60 GHz to 90 GHz	2323.7600.0	
	R&S®ZC110	75 GHz to 110 GHz	2339.3916.0	
	R&S®ZCDS110	75 GHz to 110 GHz	2323.7600.0	combiner for 2-tone signal included
	R&S®ZC140	90 GHz to 140 GHz	2339.3922.0	
			2323.7617.0	
			2332.5607.0	
			2354.5322.0	
			2357.4204.0	

Designation	Type	Frequency range	Order No.	Remarks
Converter WM-1651, one module	R&S®ZC170	110 GHz to 170 GHz	1323.7630.0	
Converter WM-1651, one module	R&S®ZC170	110 GHz to 170 GHz	2	only for R&S®ZNA43, R&S®ZNA50, R&S®ZNA67
Converter WM-1651	R&S®ZCDS170	110 GHz to 170 GHz	1323.7630.0	combiner for 2-tone signal included
Converter WM-1295, one module	R&S®ZC220	140 GHz to 220 GHz	3	
Converter WM-1092, one module	R&S®ZC260	170 GHz to 260 GHz	1354.5522.0	
Converter WM-864, one module	R&S®ZC330	220 GHz to 330 GHz	2	
Converter WM-710, one module	R&S®ZC400	260 GHz to 400 GHz	1323.7646.0	
Converter WM-570, one module	R&S®ZC500	330 GHz to 500 GHz	2	
Converter WM-570, one module	R&S®ZC500	330 GHz to 500 GHz	3628.5682.0	only for R&S®ZNA43, R&S®ZNA50, R&S®ZNA67
Converter WM-750, one module	R&S®ZC750	500 GHz to 750 GHz	2	
Converter WM-250, one module	R&S®ZC1100	750 GHz to 1100 GHz	1323.7669.0	
mmWave receivers			2	receivers require R&S®ZNA-K8
Receiver WR12, one module	R&S®ZRX90	60 GHz to 90 GHz	3656.9220.0	
Receiver WM-2540 (WR10), one module	R&S®ZRX110	75 GHz to 110 GHz	3658.5368.0	
Receiver WM-2032 (WR08), one module	R&S®ZRX140	90 GHz to 140 GHz	2	
Receiver WM-1651 (WR6.5), one module	R&S®ZRX170	110 GHz to 170 GHz	1323.7681.0	
Receiver WM-1295 (WR5.1), one module	R&S®ZRX220	140 GHz to 220 GHz	3637.1511.0	
Receiver WM-1092 (WR4.3), one module	R&S®ZRX260	170 GHz to 260 GHz	2	
Receiver WM-864 (WR3.4), one module	R&S®ZRX330	220 GHz to 330 GHz	2	
Receiver WM-710 (WR2.8), one module	R&S®ZRX400	260 GHz to 400 GHz	1323.7681.0	
Receiver WM-570, one module	R&S®ZRX500	330 GHz to 500 GHz	3637.1528.0	
Receiver WM-380 (WR1.5), one module	R&S®ZRX750	500 GHz to 750 GHz	2	
Receiver WM-250 (WR1.0), one module	R&S®ZRX110	750 GHz to 1100 GHz	3	
mmWave mini receivers	0		2	
Mini receiver WM-2540 (WR10), one module	R&S®ZRX110	75 GHz to 110 GHz	3622.0717.0	receivers require R&S®ZNA-K8
Mini receiver WM-1651 (WR6.5), one module	L	110 GHz to 170 GHz	2	
Mini receiver WM-1295 (WR5.1), one module	R&S®ZRX170	140 GHz to 220 GHz	3622.0730.0	
Mini receiver WM-864 (WR3.4), one module	L	220 GHz to 330 GHz	2	
Mini receiver WM-570, one module	R&S®ZRX220	330 GHz to 500 GHz	3622.0743.0	
Mini receiver WM-380 (WR1.5), one module	L	500 GHz to 750 GHz	2	
Calibration and verification	R&S®ZRX330		3622.0750.0	
Calibration kits (manual calibration)	L		2	
Calibration kit, 3.5 mm, 50 Ω	R&S®ZRX500	0 Hz to 26.5 GHz	3622.0766.0	
Calibration kit, 2.92 mm, 50 Ω	Z235	0 Hz to 43.5 GHz	2	
Calibration kit, 2.4 mm, 50 Ω	R&S®ZRX750	0 Hz to 50 GHz	3622.0772.0	
Calibration kit, 1.85 mm, 50 Ω	Z229	0 Hz to 67 GHz	2	
Calibration kit, 1.0 mm, 50 Ω	R&S®ZN-	0 Hz to 110 GHz	1339.5002.0	
Waveguide calibration kits	Z224		2	
Waveguide calibration kit WR15 (without sliding match)	R&S®ZV-WR15	50 GHz to 75 GHz	1337.3502.0 1307.7500.30	
Waveguide calibration kit WR15 (w ith sliding match)	R&S®ZN-Z218 R&S®ZV-WR15	50 GHz to 75 GHz	2 1307.7500.31	
Waveguide calibration kit WR12 (without sliding match)	Z210 R&S®ZV-WR12	60 GHz to 90 GHz	2 1307.7700.10	
Waveguide calibration kit WR12 (w ith sliding match)	R&S®ZV-WR12	60 GHz to 90 GHz	1307.7700.11	
Waveguide calibration kit WR10 (without sliding match)	R&S®ZV-WR10	75 GHz to 110 GHz	1307.7100.10	
Waveguide calibration kit WR10 (w ith sliding match)	R&S®ZV-WR10	75 GHz to 110 GHz	1307.7100.11	
Waveguide calibration kit WR08 (without sliding match)	R&S®ZV-WR08	90 GHz to 140 GHz	1307.7900.10	
Waveguide calibration kit WR08 (w ith sliding match)	R&S®ZV-WR08	90 GHz to 140 GHz	1307.7900.11	
Waveguide calibration kit WR06 (without sliding match)	R&S®ZV-WR06	110 GHz to 170 GHz	1311.8807.10	
Waveguide calibration kit WR06 (w ith sliding match)	R&S®ZV-WR06	110 GHz to 170 GHz	1311.8807.11	

Designation	Type	Frequency range	Order No.	Remarks
Waveguide calibration kit WR05 (without sliding match)	R&S®ZV-WR05	140 GHz to 220 GHz	1307.8106.10	
Waveguide calibration kit WR05 (w ith sliding match)	R&S®ZV-WR05	140 GHz to 220 GHz	1307.8106.11	
Waveguide calibration kit WR03 (without sliding match)	R&S®ZV-WR03	220 GHz to 325 GHz	1307.7300.30	
Waveguide calibration kit WR03 (w ith sliding match)	R&S®ZV-WR03	220 GHz to 325 GHz	1307.7300.31	
Waveguide calibration kit WR02 (without sliding match)	R&S®ZV-WR02	325 GHz to 500 GHz	1314.5550.10	
Waveguide calibration kit WM-1092	R&S®ZCWM-1092	170 GHz to 260 GHz	3628.5699.02	
Waveguide calibration kit WM-710	R&S®ZCWM-710	260 GHz to 400 GHz	1339.4070.02	
Waveguide calibration kit WM-570	R&S®ZCWM-570	330 GHz to 500 GHz	1322.3099.10	
Waveguide calibration kit WM-380	R&S®ZCWM-380	500 GHz to 750 GHz	1322.3101.02	
Waveguide calibration kit WM-250	R&S®ZCWM-250	750 GHz to 1100 GHz	1322.3118.02	
Calibration units (automatic calibration)				
Calibration unit, 2 ports, 3.5 mm (f)	R&S®ZN-Z50	9 kHz to 26.5 GHz	1335.6904.3	
Calibration unit, 4 ports, 3.5 mm (f)	R&S®ZN-Z52	100 kHz to 26.5 GHz	2	
Calibration unit, 2 ports, 3.5 mm (f)	R&S®ZN-Z53	100 kHz to 26.5 GHz	1335.6991.3	
Calibration unit, 2 ports, 2.92 mm (f)	R&S®ZN-Z54	9 kHz to 40 GHz	0	c h ar ac te r ize d to 4 3.5 GHz
Calibration unit, 2 ports, 2.4 mm (f)	R&S®ZN-Z55	9 kHz to 50 GHz	1335.7046.3	
Calibration unit, 2 ports, 1.85 mm (f)	R&S®ZN-	10 MHz to 67 GHz	2	
Inline calibration units (automatic calibration)	Z156		1335.7117.9	
Inline calibration unit controller	R&S®ZN-		2328.7609.0	
Inline calibration unit, 40 GHz	Z30		2335.7181.4	
Inline calibration unit, 40 GHz, TVAC	R&S®ZN-		2328.7644.0	
Comb generators (phase calibration reference)	Z33		2332.7239.0	
Comb generator, 2.92 mm (f) Comb generator, 1.85 mm (f)	R&S®ZN-	10 MHz to 44 GHz	1352.3000.4	requires R&S®ZNA-B12 option
Verification kits	Z344	10 MHz to 67 GHz	3	requires R&S®ZNA-B12 option
T-check verification device, 3.5 mm (f to m) T-check verification device, 2.92 mm (f to m) T-check verification device, 2.4 mm (f to m) Verification kit, 3.5 mm	R&S®ZN-		1352.3000.6	
Verification kit, 2.92 mm Verification kit, 2.4 mm	Z667	45 MHz to 26.5 GHz	1319.1018.0	
Test cables	Z335	45 MHz to 40 GHz	2	
3.5 mm (f) to 3.5 mm (m), length: 0.6 m	R&S®ZV-	45 MHz to 50 GHz	1319.1024.0	
2.92 mm (f) to 2.92 mm (m), length: 0.6 m/1 m	Z329	45 MHz to 26.5 GHz	2	
2.4 mm (f) to 2.4 mm (m), length: 0.6 m	R&S®ZV-	45 MHz to 40 GHz	1319.1030.0	
3.5 mm (f) to 3.5 mm (m), length: 0.6 m/0.9 m/1.5 m R&S®ZV-Z193	Z324	45 MHz to 50 GHz	2	
	R&S®ZV-		1319.1060.0	
	Z335	0 Hz to 26.5 GHz	2301.7595.25	
	R&S®ZV-	0 Hz to 40 GHz	1319.1076.25/38	
	Z329	0 Hz to 50 GHz	2301.7637.25	
	R&S®ZV-	0 Hz to 26.5 GHz	1319.1082.24/36/	
2.92 mm (f) to 2.92 mm (m), length: 0.6 m/0.9 m	Z324 R&S®ZV-Z195	0 Hz to 40 GHz	40	
2.92 mm (m) to 2.92 mm (m), length: 0.9 m	R&S®ZV-Z195	0 Hz to 40 GHz	1306.4536.24/36	recommended when using R&S®ZNA-B8 option
1.85 mm (f) to 1.85 mm (m), length: 0.6 m/0.9 m	R&S®ZV-Z196	0 Hz to 67 GHz	1306.4536.37	
1.85 mm (m) to 1.85 mm (m), length: 0.6 m/0.9 m	R&S®ZV-Z196	0 Hz to 67 GHz	1306.4559.24/36	
Hardware add-ons			1306.4559.25/37	
Calibration mixer, 2.92 mm (f)	R&S®ZN-	10 MHz to 40 GHz	1339.3800.0	
Calibration mixer, 2.92 mm (f), delivery without wooden storage box	ZM292	10 MHz to 40 GHz	2	
mmWave adaption kit, for R&S®ZNA26/43, two converters	R&S®ZN- R&S®ZCAKN		1339.3800.0 1332.6178.43	
mmWave adaption kit, for R&S®ZNA26/43, four converters	ZM292 R&S®ZCAKN		3 1332.6178.44	
mmWave adaption kit, for R&S®ZNA50/67, two converters	R&S®ZCAKN		1332.6178.67	
mmWave adaption kit, for R&S®ZNA50/67, four converters	R&S®ZCAKN		1332.6178.68	
Torque wrench for 3.5/2.92/2.4/1.85 mm connector, 8 mm width, 0.9 Nm torque	R&S®ZN-ZTW		1328.8534.35	

Designation	Type	Frequency range	Order No.	Remarks
Torque wrench for R&S®ZNA test port connector, 19 mm width, 0.9 Nm torque	R&S®ZN-ZTW		1328.8534.19	
Additional removable hard disk	R&S®ZNA-B19		1332.4600.04	with Windows 11operatingsystem
19" rack adapter, pigeon blue	R&S®ZZA-KN6		1175.3056.00	
19" rack adapter, violet blue	R&S®ZZA-KN6B		1703.1369.00	colorforinstrumentsinthenew housing design
Cable sets (to combine the signals from port 1 and port 3 of an R&S®ZNA (4 ports) to produce a two-tone signal, required for intermodulation m easurements and embedded LO group delay measurements with R&S®ZNA-K9 option; required, if no internal combiner is installed)				
Cable set for R&S®ZNA-K9 (3.5 mm for R&S®ZNA26)	R&S®ZNA26-Z9		1332.4730.26	
Cable set for R&S®ZNA-K9 (2.92 mm for R&S®ZNA43)	R&S®ZNA43-Z9		1332.4730.43	
Cable set for R&S®ZNA-K9 (2.4 mm for R&S®ZNA43)	R&S®ZNA43-Z9		1332.4730.44	
Cable set for R&S®ZNA-K9 (1.85 mm for R&S®ZNA50)	R&S®ZNA50-Z9		1332.4730.50	
Cable set for R&S®ZNA-K9 (1.85 mm for R&S®ZNA67)	R&S®ZNA67-Z9		1332.4730.67	
Tools				
License dongle, PC software	R&S®ZNPC		1325.6601.0	
R&S®ZNA simulation	R&S®ZNXSIM-K2		2	
Time domain analysis (TDR) for simulation	R&S®ZNXSIM-K22		1338.1626.0	
Vector network analyzer systems			2	
Vector network analyzer system, 110 GHz, 2 test ports, complete system based on R&S®ZNA67, 2-port model, standard power	R&S®ZNA67EXT	10 MHz to 110 GHz	1338.1632.0 1352.1888.12 2	
Vector network analyzer system, 110 GHz, 2 test ports, complete system based on R&S®ZNA67, 4-port model, standard power	R&S®ZNA67EXT	10 MHz to 110 GHz	1352.1888.13	
Vector network analyzer system, 110 GHz, 4 test ports, complete system based on R&S®ZNA67, 4-port model, standard power	R&S®ZNA67EXT	10 MHz to 110 GHz	1352.1888.14	
Vector network analyzer system, 110 GHz, 2 test ports, complete system based on R&S®ZNA67, 2-port model, high power	R&S®ZNA67EXT	10 MHz to 110 GHz	1352.1888.0 5	
Vector network analyzer system, 110 GHz, 2 test ports, complete system based on R&S®ZNA67, 4-port model, high power	R&S®ZNA67EXT	10 MHz to 110 GHz	1352.1888.16	
Vector network analyzer system, 110 GHz, 4 test ports, complete system based on R&S®ZNA67, 4-port model, high power	R&S®ZNA67EXT	10 MHz to 110 GHz	1352.1888.17	
Option				
Continuous sweep up to 110 GHz	R&S®ZNA67-K110	10 MHz to 110 GHz	1332.5642.02	
Hardware add-ons				
RF cable set, Gore, for R&S®ZNA67EXT, 2-port system	R&S®ZN-ZCASGO		1352.1659.02	
RF cable set, Gore, for R&S®ZNA67EXT, 4-port system	R&S®ZN-ZCASGO		1352.1659.04	

Hardware upgrade options

Hardware options can be retrofitted either with a B option (R&S®ZNA-Bx/-Bxx, R&S®ZNAxx-Bx/-Bxx/-Bxxx) or with a U (upgrade) option. U options are required for the following upgrades:

- ▶ Direct source monitor access: R&S®ZNAxx-U161/R&S®ZNAxx-B163.
  These options additionally require R&S®ZNAxx-U16 and R&S®ZNAxx-U21/R&S®ZNAxx-U23 unless the corresponding B options (R&S®ZNAxx-B16, R&S®ZNAxx-B21/R&S®ZNAxx-B23) are already installed.
- ▶ All source and receiver step attenuators: R&S®ZNAxx-U2n, R&S®ZNAxx-U3n

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